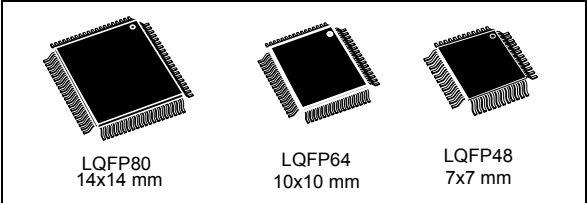


Automotive 8-bit ultra-low-power MCU, 64 KB Flash, EEPROM, RTC, AES, LCD, timers, USARTs, I2C, SPIs, ADC, DAC, COMPs

Datasheet - production data

## Features

- AEC-Q100 grade 1 qualified
  - Operating conditions
    - Operating power supply range 1.8 V to 3.6 V (down to 1.65 V at power down)
    - Temp. range: -40 to 85 or 125 °C
  - Low-power features
    - 5 low-power modes: Wait, Low-power run (5.9 µA), Low-power wait (3 µA), Active-halt with full RTC (1.4 µA), Halt (400 nA)
    - Consumption: 200 µA/MHz+330 µA
    - Fast wake up from Halt mode (4.7 µs)
    - Ultra-low leakage per I/O: 50 nA
  - Advanced STM8 core
    - Harvard architecture and 3-stage pipeline
    - Max freq: 16 MHz, 16 CISC MIPS peak
    - Up to 40 external interrupt sources
  - Reset and supply management
    - Low power, ultra safe BOR reset with 5 programmable thresholds
    - Ultra-low-power POR/PDR
    - Programmable voltage detector (PVD)
  - Clock management
    - 32 kHz and 1-16 MHz crystal oscillators
    - Internal 16 MHz factory-trimmed RC and 38 kHz low consumption RC
    - Clock security system
  - Low-power RTC
    - BCD calendar with alarm interrupt,
    - Digital calibration with +/- 0.5ppm accuracy
    - Advanced anti-tamper detection
  - DMA
    - 4 ch. for ADC, encryption hardware accelerator (AES), DACs, SPIs, I<sup>2</sup>C, USARTs, Timers, 1 ch. for memory-to-memory
  - LCD: 8x40 or 4x44 w/ step-up converter
- 

LQFP80  
14x14 mm

LQFP64  
10x10 mm

LQFP48  
7x7 mm

- 12-bit ADC up to 1 Msps / 28 channels,
    - Temp. sensor and internal ref. voltage
  - Memories
    - Up to 64 Kbytes of Flash with up to 2 Kbytes of data EEPROM with ECC and RWW
    - Flexible write/read protection modes
    - Up to 4 Kbytes of RAM
  - 2x12-bit DAC (dual mode) with output buffer
  - 2 ultra-low-power comparators
    - 1 with fixed threshold and 1 rail to rail
    - Wakeup capability
  - Timers
    - Three 16-bit timers with 2 channels (IC, OC, PWM), quadrature encoder
    - One 16-bit advanced control timer with 3 channels, supporting motor control
    - One 8-bit timer with 7-bit prescaler
    - One window and one independent watchdog
    - Beeper timer with 1, 2 or 4 kHz frequencies
  - Communication interfaces
    - Two synchronous serial interface (SPI)
    - Fast I<sup>2</sup>C 400 kHz SMBus and PMBus
    - Three USARTs (IrDA, LIN 1.3, LIN2.0)
  - Up to 67 I/Os, all mappable on interrupt vectors
  - Fast on-chip programming and non-intrusive debugging with SWIM, Bootloader using USART
  - 96-bit unique ID



Table 1. Device summary

| Reference   | Part number                           |
|-------------|---------------------------------------|
| STM8AL31E8x | STM8AL31E88, STM8AL31E89, STM8AL31E8A |
| STM8AL3LE8x | STM8AL3LE88, STM8AL3LE89, STM8AL3LE8A |

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# 1 Introduction

This document describes the features, pinout, mechanical data and ordering information of the high-density STM8AL31E8x and STM8AL3LE8x devices (microcontrollers with 64 Kbyte Flash memory density). These devices are referred to as high-density devices in STM8L051/L052 Value Line, STM8L151/L152, STM8L162, STM8AL31, STM8AL3L MCU lines reference manual (RM0031) and in the STM8L and STM8AL Flash programming manual (PM0054).

For more details on the whole STMicroelectronics ultra-low-power family please refer to [Section 3: Functional overview on page 14](#).

For information on the debug module and SWIM (single wire interface module), refer to the *STM8 SWIM communication protocol and debug module user manual* (UM0470).

For information on the STM8 core, please refer to the *STM8 CPU programming manual* (PM0044).

## 2 Description

The high-density STM8AL3xE8x ultra-low-power devices feature an enhanced STM8 CPU core providing increased processing power (up to 16 MIPS at 16 MHz) while maintaining the advantages of a CISC architecture with improved code density, a 24-bit linear addressing space and an optimized architecture for low-power operations.

The family includes an integrated debug module with a hardware interface (SWIM) which allows non-intrusive in-application debugging and ultrafast Flash programming.

All high-density STM8AL3xE8x microcontrollers feature embedded data EEPROM and low-power low-voltage single-supply program Flash memory.

The devices incorporate an extensive range of enhanced I/Os and peripherals, a 12-bit ADC, two DACs, two comparators, a real-time clock, AES, 8x40 or 4x44-segment LCD, four 16-bit timers, one 8-bit timer, as well as standard communication interfaces such as two SPIs, an I<sup>2</sup>C interface, and three USARTs. One 8x40 or 4x44-segment LCD is available on the STM8AL3LE8x devices. The modular design of the peripheral set allows the same peripherals to be found in different ST microcontroller families including 32-bit families. This makes any transition to a different family very easy, and simplified even more by the use of a common set of development tools.

### 2.1 STM8AL ultra-low-power 8-bit family benefits

High-density STM8AL3xE8x devices are part of the STM8AL automotive ultra-low-power 8-bit family providing the following benefits:

- Integrated system
  - 64 Kbytes of high-density embedded Flash program memory
  - 2 Kbytes of data EEPROM
  - 4 Kbytes of RAM
  - Internal high-speed and low-power low speed RC.
  - Embedded reset
- Ultra-low-power consumption
  - 1  $\mu$ A in Active-halt mode
  - Clock gated system and optimized power management
  - Capability to execute from RAM for Low-power wait mode and Low-power run mode
- Advanced features
  - Up to 16 MIPS at 16 MHz CPU clock frequency
  - Direct memory access (DMA) for memory-to-memory or peripheral-to-memory access.
- Short development cycles
  - Application scalability across a common family product architecture with compatible pinout, memory map and modular peripherals.
  - Wide choice of development tools

STM8AL ultra-low-power microcontrollers operates either from 1.8 to 3.6 V (down to 1.65 V at power-down) or from 1.65 to 3.6 V. They are available in the -40 to +85 °C and -40 to +125 °C temperature ranges.

These features make the STM8AL ultra-low-power microcontroller families suitable for a wide range of applications.

The devices are offered in one 48-pin package. Different sets of peripherals are included depending on the device. Refer to [Section 3](#) for an overview of the complete range of peripherals proposed in this family.

All STM8AL ultra-low-power products are based on the same architecture with the same memory mapping and a coherent pinout.

[Figure 1](#) shows the block diagram of the high-density STM8AL3xE8x families.

## 2.2 Device overview

**Table 2. High-density STM8AL3xE8x low-power device features and peripheral counts**

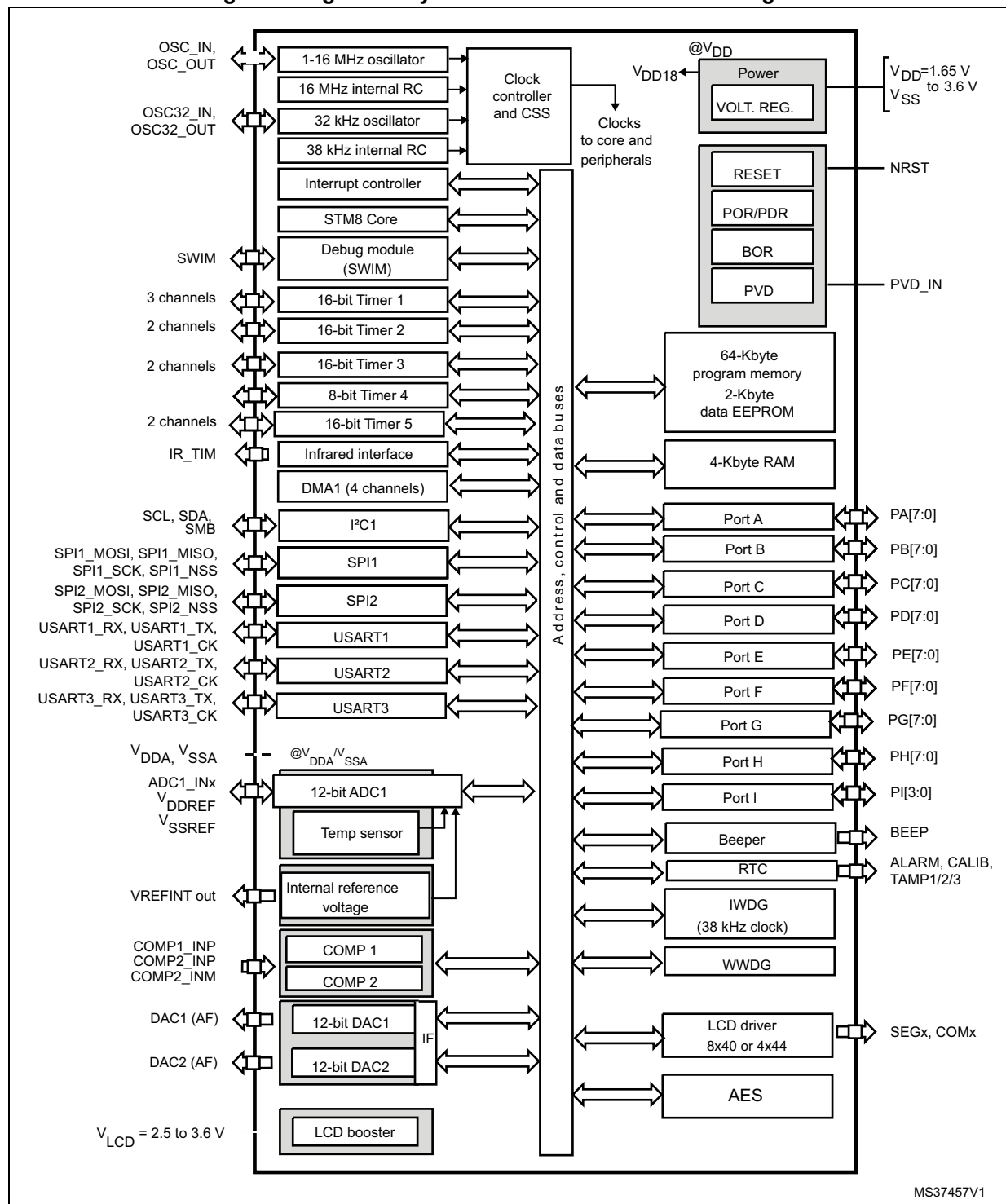
| Features                                        |                  | STM8AL3xx8                                                                                                                | STM8AL3xx9                  | STM8AL3xxA                  |
|-------------------------------------------------|------------------|---------------------------------------------------------------------------------------------------------------------------|-----------------------------|-----------------------------|
| Flash (Kbyte)                                   |                  | 64                                                                                                                        |                             |                             |
| Data EEPROM (Kbyte)                             |                  | 2                                                                                                                         |                             |                             |
| AES                                             |                  | 1                                                                                                                         |                             |                             |
| LCD                                             |                  | 8x28 or 4x32 <sup>(1)</sup>                                                                                               | 8x36 or 4x40 <sup>(1)</sup> | 8x40 or 4x44 <sup>(1)</sup> |
| Timers                                          | Basic            | 1<br>(8-bit)                                                                                                              | 1<br>(8-bit)                | 1<br>(8-bit)                |
|                                                 | General purpose  | 3<br>(16-bit)                                                                                                             | 3<br>(16-bit)               | 3<br>(16-bit)               |
|                                                 | Advanced control | 1<br>(16-bit)                                                                                                             | 1<br>(16-bit)               | 1<br>(16-bit)               |
| Communication interfaces                        | SPI              | 2                                                                                                                         | 2                           | 2                           |
|                                                 | I2C              | 1                                                                                                                         | 1                           | 1                           |
|                                                 | USART            | 3                                                                                                                         | 3                           | 3                           |
| GPIOs                                           |                  | 41 <sup>(2)</sup>                                                                                                         | 54 <sup>(2)</sup>           | 68 <sup>(2)</sup>           |
| 12-bit synchronized ADC<br>(number of channels) |                  | 1<br>(25)                                                                                                                 | 1<br>(28)                   | 1<br>(28)                   |
| 12-Bit DAC                                      |                  | 2                                                                                                                         | 2                           | 2                           |
| Number of channels                              |                  | 2                                                                                                                         | 2                           | 2                           |
| Comparators (COMP1/COMP2)                       |                  | 2                                                                                                                         | 2                           | 2                           |
| Others                                          |                  | RTC, window watchdog, independent watchdog,<br>16-MHz and 38-kHz internal RC, 1- to 16-MHz and 32-kHz external oscillator |                             |                             |
| CPU frequency                                   |                  | 16 MHz                                                                                                                    |                             |                             |
| Operating voltage                               |                  | 1.8 to 3.6 V (down to 1.65 V at power-down) with BOR                                                                      |                             |                             |
| Operating temperature                           |                  | -40 to +85 °C / -40 to +125 °C                                                                                            |                             |                             |
| Packages                                        |                  | LQFP48                                                                                                                    | LQFP64                      | LQFP80                      |

1. STM8AL3LE8x versions only.

2. The number of GPIOs given in this table includes the NRST/PA1 pin but the application can use the NRST/PA1 pin as general purpose output only (PA1).

### 3 Functional overview

Figure 1. High-density STM8AL3xE8x device block diagram



- Legend:** AF: alternate function  
ADC: Analog-to-digital converter  
AES: Advanced encryption standard hardware accelerator

BOR: Brownout reset  
DMA: Direct memory access  
DAC: Digital-to-analog converter  
I<sup>2</sup>C: Inter-integrated circuit multimaster interface  
IWDG: Independent watchdog  
LCD: Liquid crystal display  
POR/PDR: Power on reset / power-down reset  
RTC: Real-time clock  
SPI: Serial peripheral interface  
SWIM: Single wire interface module  
USART: Universal synchronous asynchronous receiver transmitter  
WWDG: Window watchdog

## 3.1 Low-power modes

The high-density STM8AL3xE8x devices support five low-power modes to achieve the best compromise between low-power consumption, short startup time and available wakeup sources:

- **Wait mode:** CPU clock is stopped, but selected peripherals keep running. An internal or external interrupt or a Reset is used to exit the microcontroller from Wait mode (WFE or WFI mode).
- **Low-power run mode:** The CPU and the selected peripherals are running. Execution is done from RAM with a low speed oscillator (LSI or LSE). Flash memory and data EEPROM are stopped and the voltage regulator is configured in ultra-low-power mode. The microcontroller enters Low-power run mode by software and exits from this mode by software or by a reset.  
All interrupts must be masked and are not used to exit the microcontroller from this mode.
- **Low-power wait mode:** This mode is entered when executing a Wait for event in Low-power run mode. It is similar to Low-power run mode except that the CPU clock is stopped. The wakeup from this mode is triggered by a Reset or by an internal or external event (peripheral event generated by the timers, serial interfaces, DMA controller (DMA1), comparators and I/O ports). When the wakeup is triggered by an event, the system goes back to Low-power run mode.  
All interrupts must be masked and are not used to exit the microcontroller from this mode.
- **Active-halt mode:** CPU and peripheral clocks are stopped, except RTC. The wakeup is triggered by RTC interrupts, external interrupts or reset.
- **Halt mode:** CPU and peripheral clocks are stopped, the device remains powered on. The RAM content is preserved. The wakeup is triggered by an external interrupt or reset. A few peripherals have also a wakeup from Halt capability. Switching off the internal reference voltage reduces power consumption. Through software configuration it is also possible to wake up the device without waiting for the internal reference voltage wakeup time to have a fast wakeup time of 5  $\mu$ s.

## 3.2 Central processing unit STM8

### 3.2.1 Advanced STM8 Core

The 8-bit STM8 core is designed for code efficiency and performance with an Harvard architecture and a 3-stage pipeline.

It contains 6 internal registers which are directly addressable in each execution context, 20 addressing modes including indexed indirect and relative addressing, and 80 instructions.

#### Architecture and registers

- Harvard architecture
- 3-stage pipeline
- 32-bit wide program memory bus - single cycle fetching most instructions
- X and Y 16-bit index registers - enabling indexed addressing modes with or without offset and read-modify-write type data manipulations
- 8-bit accumulator
- 24-bit program counter - 16 Mbyte linear memory space
- 16-bit stack pointer - access to a 64 Kbyte level stack
- 8-bit condition code register - 7 condition flags for the result of the last instruction

#### Addressing

- 20 addressing modes
- Indexed indirect addressing mode for lookup tables located anywhere in the address space
- Stack pointer relative addressing mode for local variables and parameter passing

#### Instruction set

- 80 instructions with 2-byte average instruction size
- Standard data movement and logic/arithmetic functions
- 8-bit by 8-bit multiplication
- 16-bit by 8-bit and 16-bit by 16-bit division
- Bit manipulation
- Data transfer between stack and accumulator (push/pop) with direct stack access
- Data transfer using the X and Y registers or direct memory-to-memory transfers

### 3.2.2 Interrupt controller

The high-density STM8AL3xE8x devices feature a nested vectored interrupt controller:

- Nested interrupts with 3 software priority levels
- 32 interrupt vectors with hardware priority
- Up to 40 external interrupt sources on 11 vectors
- Trap and reset interrupts



### 3.3 Reset and supply management

#### 3.3.1 Power supply scheme

The device requires a 1.65 V to 3.6 V operating supply voltage ( $V_{DD}$ ). The external power supply pins must be connected as follows:

- $V_{SS1}$ ,  $V_{DD1}$ ,  $V_{SS2}$ ,  $V_{DD2}$ ,  $V_{SS3}$ ,  $V_{DD3}$ ,  $V_{SS4}$ ,  $V_{DD4}$  = 1.65 to 3.6 V: external power supply for I/Os and for the internal regulator. Provided externally through  $V_{DD}$  pins, the corresponding ground pin is  $V_{SS}$ .  $V_{SS1}/V_{SS2}/V_{SS3}/V_{SS4}$  and  $V_{DD1}/V_{DD2}/V_{DD3}/V_{DD4}$  must not be left unconnected.
- $V_{SSA}$ ,  $V_{DDA}$  = 1.65 to 3.6 V: external power supplies for analog peripherals (minimum voltage to be applied to  $V_{DDA}$  is 1.8 V when the ADC1 is used).  $V_{DDA}$  and  $V_{SSA}$  must be connected to  $V_{DD}$  and  $V_{SS}$ , respectively.
- $V_{REF+}$ ,  $V_{REF-}$  (for ADC1): external reference voltage for ADC1. Must be provided externally through  $V_{REF+}$  and  $V_{REF-}$  pin.
- $V_{REF+}$  (for DAC1/2): external voltage reference for DAC1 and DAC2 must be provided externally through  $V_{REF+}$ .

#### 3.3.2 Power supply supervisor

The device has an integrated ZEROPOWER power-on reset (POR)/power-down reset (PDR), coupled with a brownout reset (BOR) circuitry. At power-on, BOR is always active, and ensures proper operation starting from 1.8 V. As soon as the 1.8 V BOR threshold is reached, the option byte loading process starts, either to confirm or modify the default thresholds, or to disable BOR permanently. In this latter case, the  $V_{DD}$  min value at power down is 1.65 V.

Five BOR thresholds are available through option byte, starting from 1.8 V to 3 V. To reduce the power consumption in Halt mode, it is possible to automatically switch off the internal reference voltage (and consequently the BOR) in Halt mode. The device remains in reset state when  $V_{DD}$  is below a specified threshold,  $V_{POR/PDR}$  or  $V_{BOR}$ , without the need for any external reset circuit.

The device features an embedded programmable voltage detector (PVD) that monitors the  $V_{DD}/V_{DDA}$  power supply and compares it to the  $V_{PVD}$  threshold. This PVD offers 7 different levels between 1.85 V and 3.05 V, chosen by software, with a step around 200 mV. An interrupt is generated when  $V_{DD}/V_{DDA}$  drops below the  $V_{PVD}$  threshold and/or when  $V_{DD}/V_{DDA}$  is higher than the  $V_{PVD}$  threshold. The interrupt service routine generates then a warning message and/or put the MCU into a safe state. The PVD is enabled by software.

### 3.3.3 Voltage regulator

The high-density STM8AL3xE8x devices embed an internal voltage regulator for generating the 1.8 V power supply for the core and peripherals.

This regulator has two different modes:

- **Main voltage regulator mode (MVR)** for Run, Wait for interrupt (WFI) and Wait for event (WFE) modes.
- **Low-power voltage regulator mode (LPVR)** for Halt, Active-halt, Low-power run and Low-power wait modes.

When entering Halt or Active-halt modes, the system automatically switches from the MVR to the LPVR in order to reduce current consumption.

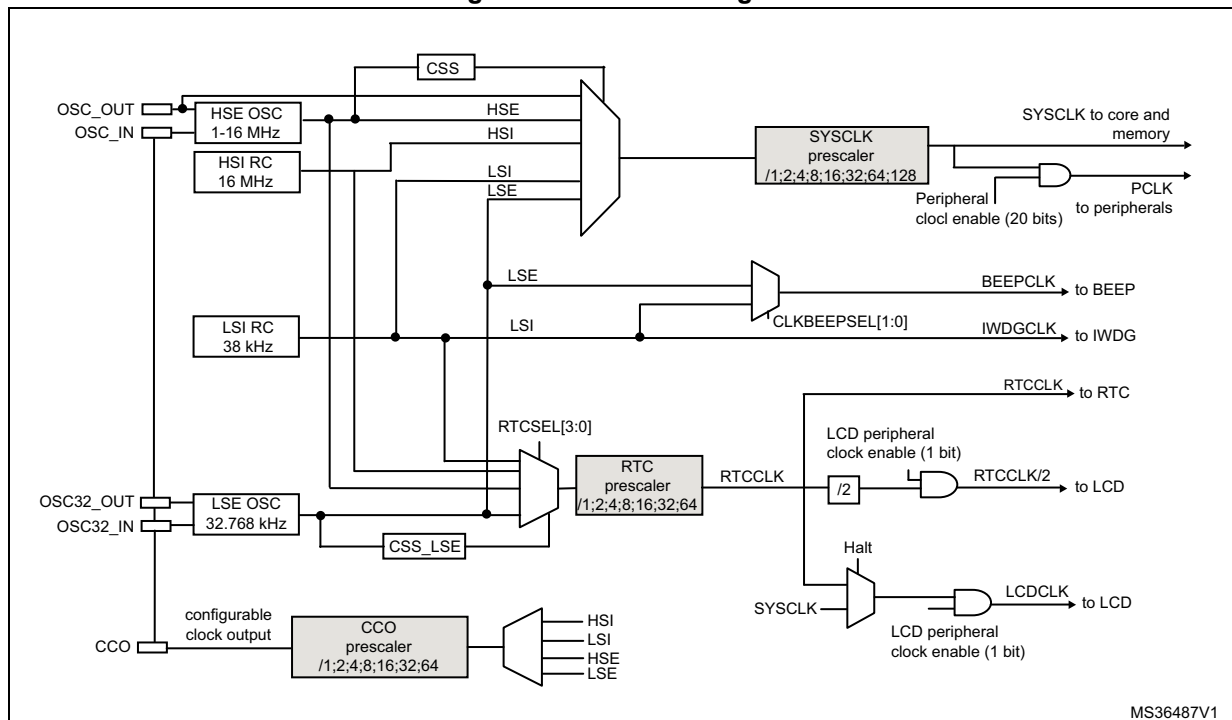
## 3.4 Clock management

The clock controller distributes the system clock (SYSCLK) coming from different oscillators to the core and the peripherals. It also manages clock gating for low-power modes and ensures clock robustness.

### Features

- **Clock prescaler:** to get the best compromise between speed and current consumption, the clock frequency to the CPU and peripherals has to be adjusted by a programmable prescaler
- **Safe clock switching:** Clock sources are adaptable safely on the fly in run mode through a configuration register.
- **Clock management:** To reduce power consumption, the clock controller stops the clock to the core, individual peripherals or memory.
- **System clock sources:** 4 different clock sources are available to drive the system clock:
  - 1-16 MHz High speed external crystal (HSE)
  - 16 MHz High speed internal RC oscillator (HSI)
  - 32.768 Low speed external crystal (LSE)
  - 38 kHz Low speed internal RC (LSI)
- **RTC and LCD clock sources:** the above four sources are available to clock the RTC and the LCD, whatever the system clock.
- **Startup clock:** After reset, the microcontroller restarts by default with an internal 2 MHz clock (HSI/8). The prescaler ratio and clock source is adjustable by the application program as soon as the code execution starts.
- **Clock security system (CSS):** This feature is enabled by software. If a HSE clock failure occurs, the system clock is automatically switched to HSI.
- **Configurable main clock output (CCO):** This outputs an external clock for use by the application.

**Figure 2. Clock tree diagram**



1. The HSE clock source is either an external crystal/ceramic resonator or an external source (HSE bypass). Refer to Section HSE clock in STM8L051/L052 Value Line, STM8L151/L152, STM8L162, STM8AL31, STM8AL3L MCU lines reference manual (RM0031).
2. The LSE clock source is either an external crystal/ceramic resonator or a external source (LSE bypass). Refer to Section LSE clock in STM8L051/L052 Value Line, STM8L151/L152, STM8L162, STM8AL31, STM8AL3L MCU lines reference manual (RM0031).

### 3.5 Low-power real-time clock

The real-time clock (RTC) is an independent binary coded decimal (BCD) timer/counter.

Six byte locations contain the second, minute, hour (12/24 hour), week day, date, month, year, in BCD (binary coded decimal) format. Correction for 28, 29 (leap year), 30, and 31 day months are made automatically. The subsecond field is also readable in binary format.

The calendar is adjustable from 1 to 32767 RTC clock pulses. This allows to make a synchronization to a master clock.

The RTC offers a digital calibration which allows an accuracy of +/-0.5ppm.

It provides a programmable alarm and programmable periodic interrupts with wakeup from Halt capability.

- Periodic wakeup time using the 32.768 kHz LSE with the lowest resolution (of 61  $\mu$ s) is from min. 122  $\mu$ s to max. 3.9 s. With a different resolution, the wakeup time reaches 36 hours
- Periodic alarms based on the calendar are generated from LSE period to every year

A clock security system detects a failure on LSE, and provides an interrupt with wakeup capability. The RTC clock automatically switches to LSI in case of LSE failure.

The RTC also provides 3 anti-tamper detection pins. This detection embeds a programmable filter and wakes-up the MCU.

### 3.6 LCD (Liquid crystal display)

The LCD is only available on STM8AL3LE8x devices.

The liquid crystal display drives up to 8 common terminals and up to 40 segment terminals to drive up to 320 pixels. This LCD is configurable to drive up to 4 common and 44 segments (up to 176 pixels).

- Internal step-up converter to guarantee contrast control whatever  $V_{DD}$ .
- Static 1/2, 1/3, 1/4, 1/8 duty supported.
- Static 1/2, 1/3, 1/4 bias supported.
- Phase inversion to reduce power consumption and EMI.
- Up to 8 pixels programmable to blink.
- The LCD controller operating in Halt mode.

*Note: Unnecessary segments and common pins can be used as general I/O pins.*

### 3.7 Memories

The high-density STM8AL3xE8x devices have the following main features:

- 4 Kbytes of RAM
- The non-volatile memory is divided into three arrays:
  - 64 Kbytes of medium-density embedded Flash program memory
  - 2 Kbytes of Data EEPROM
  - Option byte.

The memory supports the read-while-write (RWW): it is possible to execute the code from the program matrix while programming/erasing the data matrix.

The option byte protects part of the Flash program memory from write and readout piracy.

### 3.8 DMA

A 4-channel direct memory access controller (DMA1) offers a memory-to-memory and peripherals-from/to-memory transfer capability. The 4 channels are shared between the following IPs with DMA capability: ADC1, DAC1, DAC2, AES, I2C1, SPI1, SPI2, USART1, USART2, USART3, and the 5 Timers.

### 3.9 Analog-to-digital converter

- 12-bit analog-to-digital converter (ADC1) with 28 channels (including 4 fast channel), temperature sensor and internal reference voltage
- Conversion time down to 1  $\mu$ s with  $f_{\text{SYSCLK}} = 16$  MHz
- Programmable resolution
- Programmable sampling time
- Single and continuous mode of conversion
- Scan capability: automatic conversion performed on a selected group of analog inputs
- Analog watchdog: interrupt generation when the converted voltage is outside the programmed threshold
- Triggered by timer

*Note:* ADC1 can be served by DMA1.

### 3.10 Digital-to-analog converter

- 12-bit DAC with 2 buffered outputs (two digital signals are converted into two analog voltage signal outputs)
- Synchronized update capability using timers
- DMA capability for each channel
- External triggers for conversion
- Noise-wave generation
- Triangular-wave generation
- Dual DAC channels with independent or simultaneous conversions
- Input reference voltage  $V_{\text{REF+}}$  for better resolution

*Note:* DAC can be served by DMA1.

### 3.11 Ultra-low-power comparators

The high-density STM8AL3xE8x devices embed two comparators (COMP1 and COMP2) sharing the same current bias and voltage reference. The voltage reference is an internal or external (coming from an I/O).

- One comparator with fixed threshold (COMP1).
- One comparator rail to rail with fast or slow mode (COMP2). The threshold is one of the following:
  - DAC output
  - External I/O
  - Internal reference voltage or internal reference voltage submultiple (1/4, 1/2, 3/4)

The two comparators are usable together to offer a window function. They wake up from Halt mode.

### 3.12 System configuration controller and routing interface

The system configuration controller provides the capability to remap some alternate functions on different I/O ports. TIM4 and ADC1 DMA channels can also be remapped.

The highly flexible routing interface allows application software to control the routing of different I/Os to the TIM1 timer input captures. It also controls the routing of internal analog signals to ADC1, COMP1, COMP2, DAC1 and the internal reference voltage  $V_{REFINT}$ . It also provides a set of registers for efficiently managing the charge transfer acquisition sequence.

### 3.13 AES

The AES Hardware Accelerator can be used to encipher and decipher data using the AES algorithm (compatible with FIPS PUB 197, 2001 Nov 26).

- Key scheduler
- Key derivation for decryption
- 128-bit data block processed
- 128-bit key length
- 892 clock cycles to encrypt/decrypt one 128-bit block

AES data flow can be served by the DMA1 controller

### 3.14 Timers

The high-density STM8AL3xE8x devices contain one advanced control timer (TIM1), three 16-bit general purpose timers (TIM2, TIM3 and TIM5) and one 8-bit basic timer (TIM4).

All the timers are served by DMA1.

[Table 3](#) compares the features of the advanced control, general-purpose and basic timers.

**Table 3. Timer feature comparison**

| Timer | Counter resolution | Counter type | Prescaler factor               | DMA1 request generation | Capture/compare channels | Complementary outputs |
|-------|--------------------|--------------|--------------------------------|-------------------------|--------------------------|-----------------------|
| TIM1  | 16-bit             | up/down      | Any integer from 1 to 65536    | Yes                     | 3 + 1                    | 3                     |
| TIM2  |                    |              | Any power of 2 from 1 to 128   |                         | 2                        | None                  |
| TIM3  |                    |              |                                |                         |                          |                       |
| TIM5  |                    |              |                                |                         |                          |                       |
| TIM4  | 8-bit              | up           | Any power of 2 from 1 to 32768 |                         | 0                        |                       |

### 3.14.1 16-bit advanced control timer (TIM1)

This is a high-end timer designed for a wide range of control applications. With its complementary outputs, dead-time control and center-aligned PWM capability, the field of applications is extended to motor control, lighting and half-bridge driver.

- 16-bit up, down and up/down autoreload counter with 16-bit prescaler
- 3 independent capture/compare channels (CAPCOM) configurable as input capture, output compare, PWM generation (edge and center aligned mode) and single pulse mode output
- 1 additional capture/compare channel which is not connected to an external I/O
- Synchronization module to control the timer with external signals
- Break input to force timer outputs into a defined state
- 3 complementary outputs with adjustable dead time
- Encoder mode
- Interrupt capability on various events (capture, compare, overflow, break, trigger)

### 3.14.2 16-bit general purpose timers (TIM2, TIM3, TIM5)

- 16-bit autoreload (AR) up/down-counter
- 7-bit prescaler adjustable to fixed power of 2 ratios (1...128)
- 2 individually configurable capture/compare channels
- PWM mode
- Interrupt capability on various events (capture, compare, overflow, break, trigger)
- Synchronization with other timers or external signals (external clock, reset, trigger and enable)

### 3.14.3 8-bit basic timer (TIM4)

The 8-bit timer consists of an 8-bit up auto-reload counter driven by a programmable prescaler. This timer is used for timebase generation with interrupt generation on timer overflow or for DAC trigger generation.

## 3.15 Watchdog timers

The watchdog system is based on two independent timers providing maximum security to the applications.

### 3.15.1 Window watchdog timer

The window watchdog (WWDG) is used to detect the occurrence of a software fault, usually generated by external interferences or by unexpected logical conditions, which cause the application program to abandon its normal sequence.

### 3.15.2 Independent watchdog timer

The independent watchdog peripheral (IWDG) is used to resolve processor malfunctions due to hardware or software failures.

It is clocked by the internal LSI RC clock source, and thus stays active even in case of a CPU clock failure.

## 3.16 Beeper

The beeper function outputs a signal on the BEEP pin for sound generation. The signal is in the range of 1, 2 or 4 kHz.

## 3.17 Communication interfaces

### 3.17.1 SPI

The serial peripheral interfaces (SPI1 and SPI2) provide half/ full duplex synchronous serial communication with external devices.

- Maximum speed: 8 Mbit/s ( $f_{\text{SYSCLK}}/2$ ) both for master and slave
- Full duplex synchronous transfers
- Simplex synchronous transfers on 2 lines with a possible bidirectional data line
- Master or slave operation - selectable by hardware or software
- Hardware CRC calculation
- Slave/master selection input pin

*Note:* SPI1 and SPI2 can be served by the DMA1 Controller.

### 3.17.2 I<sup>2</sup>C

The I<sup>2</sup>C bus interface (I2C1) provides multi-master capability, and controls all I<sup>2</sup>C bus-specific sequencing, protocol, arbitration and timing.

- Master, slave and multi-master capability
- Standard mode up to 100 kHz and fast speed modes up to 400 kHz.
- 7-bit and 10-bit addressing modes.
- SMBus 2.0 and PMBus support
- Hardware CRC calculation

*Note:* I<sup>2</sup>C1 can be served by the DMA1 Controller.



### 3.17.3 USART

The USART interfaces (USART1, USART2 and USART3) allow full duplex, asynchronous communications with external devices requiring an industry standard NRZ asynchronous serial data format. It offers a very wide range of baud rates.

- 1 Mbit/s full duplex SCI
- SPI1 emulation
- High precision baud rate generator
- Smartcard emulation
- IrDA SIR encoder decoder
- Single wire half duplex mode

*Note: USART1, USART2 and USART3 can be served by the DMA1 Controller.*

*USART interfaces are used to implement LIN slave communication, with LIN Break detection on the framing error flag (FE in USART\_SR register) with a value of 0 in the USART data register (USART\_DR).*

### 3.18 Infrared (IR) interface

The high-density STM8AL3xE8x devices contain an infrared interface which is used with an IR LED for remote control functions. Two timer output compare channels are used to generate the infrared remote control signals.

### 3.19 Development support

#### Development tools

Development tools for the STM8 microcontrollers include:

- The STice emulation system offering tracing and code profiling
- The STVD high-level language debugger including C compiler, assembler and integrated development environment
- The STVP Flash programming software

The STM8 also comes with starter kits, evaluation boards and low-cost in-circuit debugging/programming tools.

#### Single wire data interface (SWIM) and debug module

The debug module with its single wire data interface (SWIM) permits non-intrusive real-time in-circuit debugging and fast memory programming.

The Single wire interface is used for direct access to the debugging module and memory programming. The interface is activated in all device operation modes.

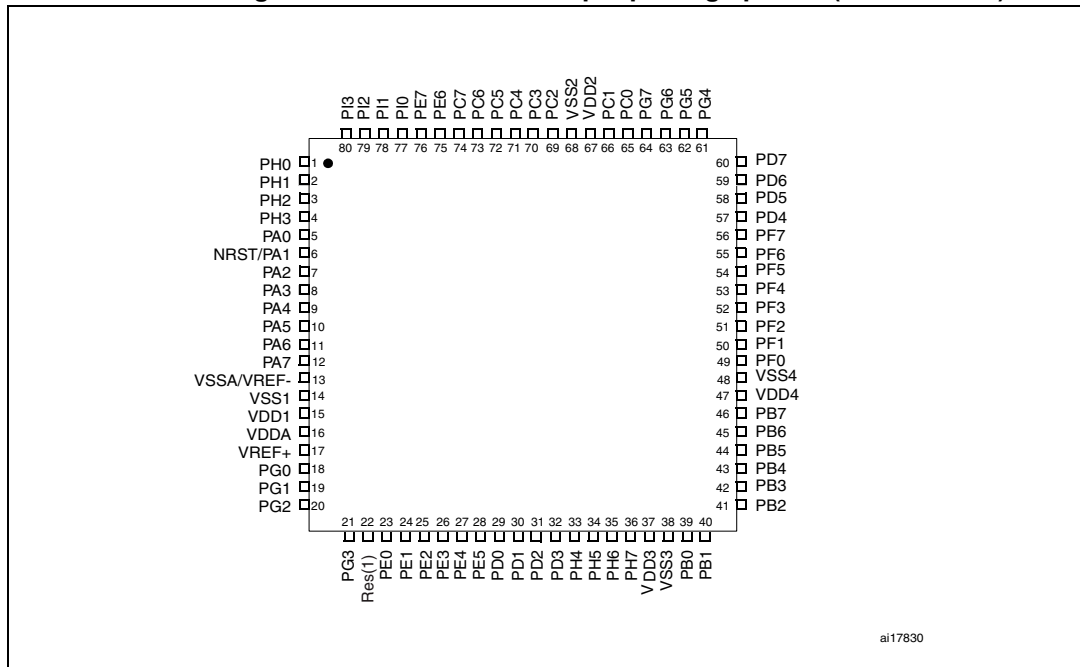
The non-intrusive debugging module features a performance close to a full-featured emulator. Beside memory and peripherals, CPU operation is also monitored in real-time by means of shadow registers.

**Bootloader**

A bootloader is available to reprogram the Flash memory using the USART1, USART2, USART3 (USARTs in asynchronous mode), SPI1 or SPI2 interfaces.

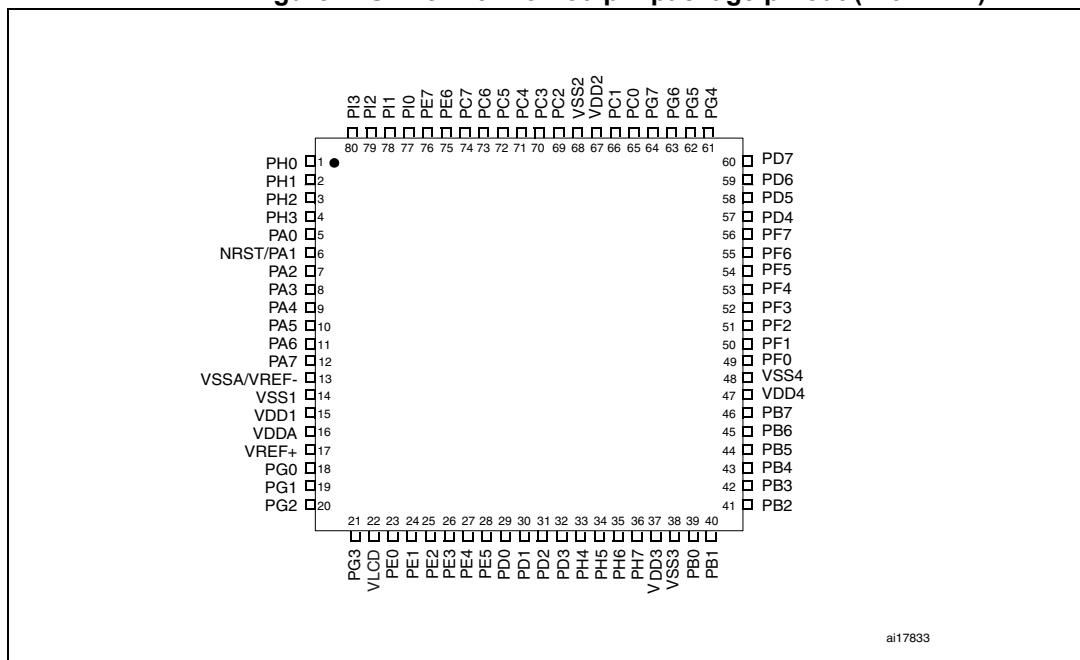
## 4 Pin description

Figure 3. STM8AL31E8A 80-pin package pinout (without LCD)



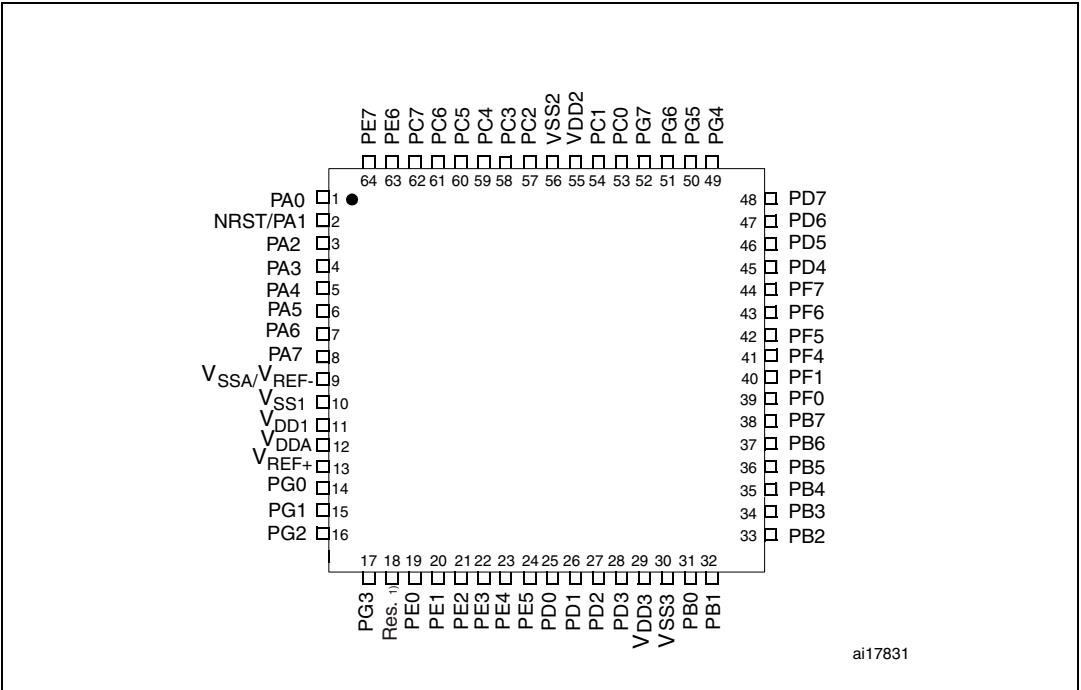
1. Pin 22 is reserved and must be tied to  $V_{DD}$ .
2. The above figure shows the package top view.

Figure 4. STM8AL3LE8A 80-pin package pinout (with LCD)



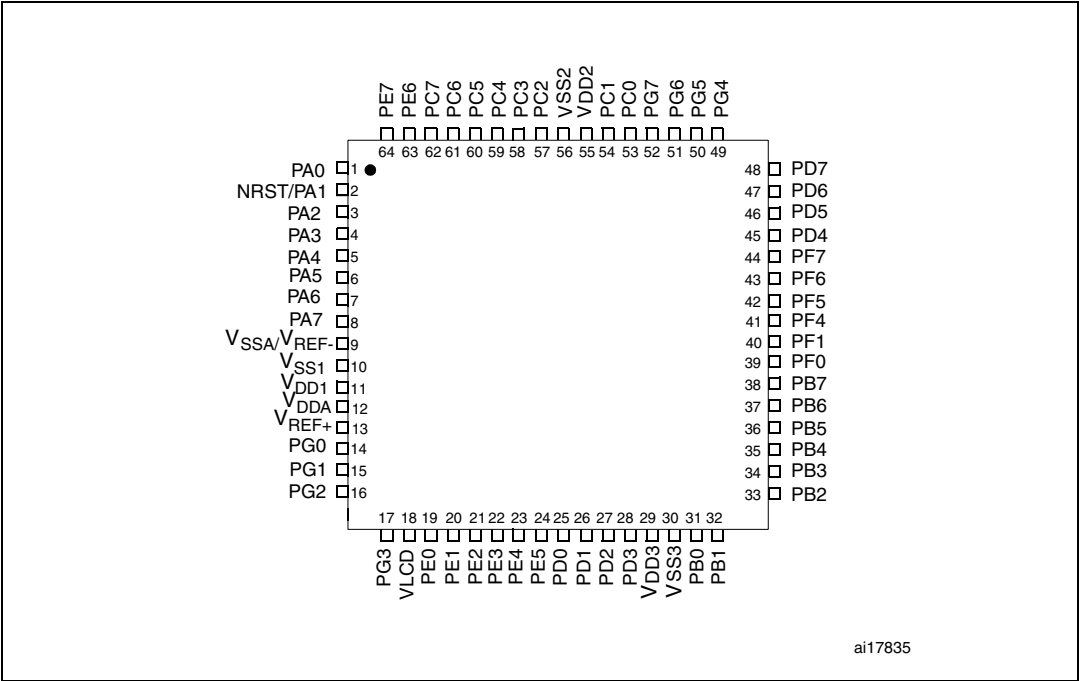
1. The above figure shows the package top view.

Figure 5. STM8AL31E89 64-pin pinout (without LCD)



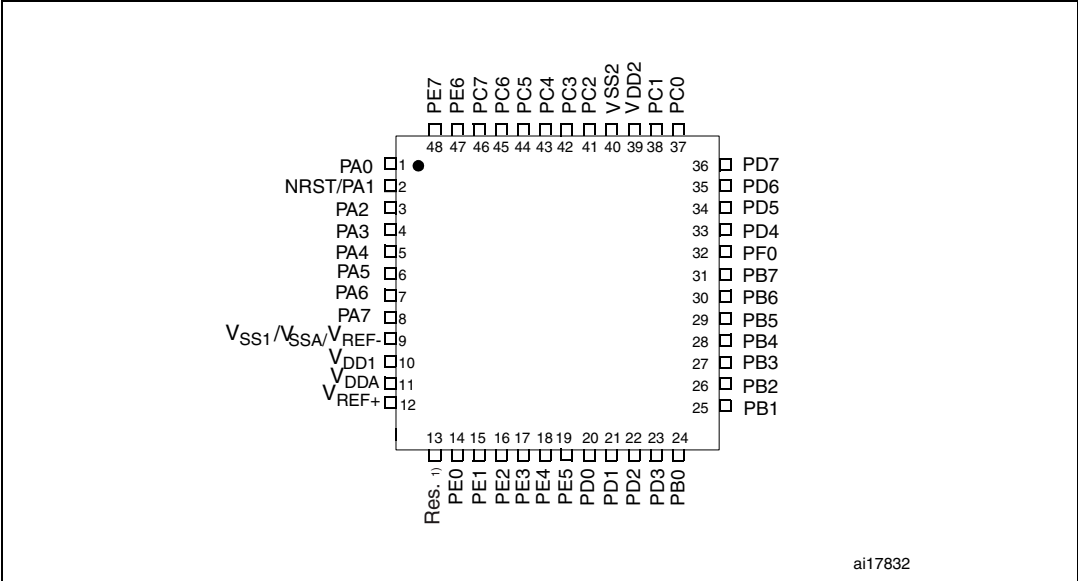
1. Pin 18 is reserved and must be tied to  $V_{DD-}$ .
2. The above figure shows the package top view.

Figure 6. STM8AL3LE89 64-pin pinout (with LCD)



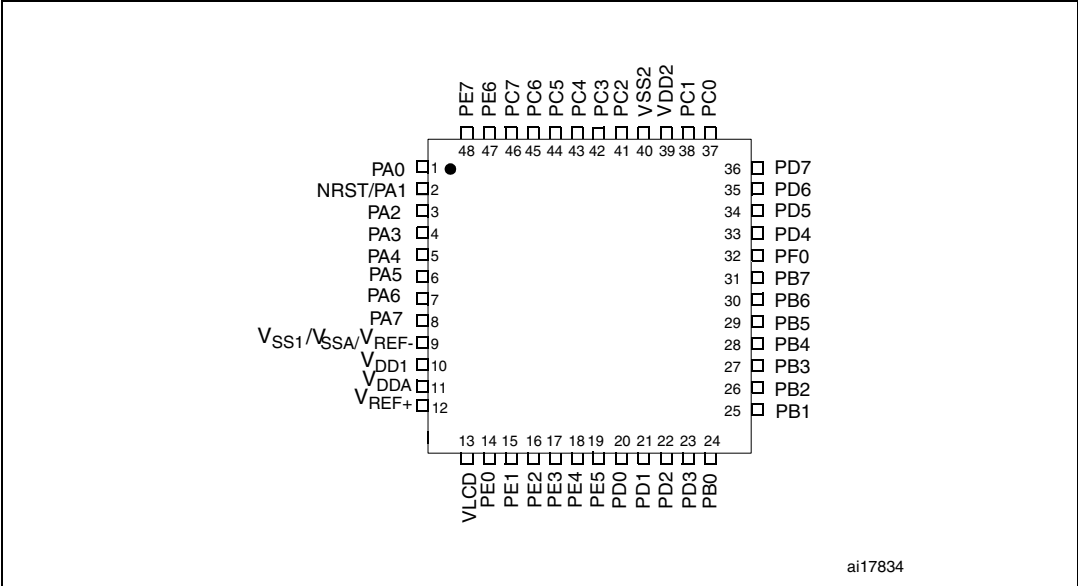
1. The above figure shows the package top view.

Figure 7. STM8AL31E88 48-pin pinout (without LCD)



1. Pin 13 is reserved and must be tied to  $V_{DD}$ .
2. The above figure shows the package top view.

Figure 8. STM8AL3LE88 48-pin pinout (with LCD)



1. The above figure shows the package top view.

Table 4. Legend/abbreviation

|                                       |                                                                                                                                                                                                      |                                                      |
|---------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------------|
| <b>Type</b>                           | I= input, O = output, S = power supply                                                                                                                                                               |                                                      |
| <b>Level</b>                          | FT: Five-volt tolerant                                                                                                                                                                               |                                                      |
|                                       | Output                                                                                                                                                                                               | HS = high sink/source (20 mA)                        |
| <b>Port and control configuration</b> | Input                                                                                                                                                                                                | float = floating, wpu = weak pull-up                 |
|                                       | Output                                                                                                                                                                                               | T = true open drain, OD = open drain, PP = push pull |
| <b>Reset state</b>                    | Bold X (pin state after reset release).<br>Unless otherwise specified, the pin state is the same during the reset phase (i.e. "under reset") and after internal reset release (i.e. at reset state). |                                                      |

Table 5. High-density STM8AL3xE8x pin description

| Pin number |        |        | Pin name                                                                                         | Type | I/O level         | Input    |          |                | Output           |    |    | Main function (after reset) | Default alternate function                                                                                  |
|------------|--------|--------|--------------------------------------------------------------------------------------------------|------|-------------------|----------|----------|----------------|------------------|----|----|-----------------------------|-------------------------------------------------------------------------------------------------------------|
| LQFP80     | LQFP64 | LQFP48 |                                                                                                  |      |                   | floating | wpu      | Ext. interrupt | High sink/source | OD | PP |                             |                                                                                                             |
| 1          | -      | -      | PH0/LCD SEG 36 <sup>(3)</sup>                                                                    | I/O  | FT <sup>(5)</sup> | <b>X</b> | X        | X              | HS               | X  | X  | <b>Port H0</b>              | LCD segment 36                                                                                              |
| 2          | -      | -      | PH1/LCD SEG 37 <sup>(3)</sup>                                                                    | I/O  | FT <sup>(5)</sup> | <b>X</b> | X        | X              | HS               | X  | X  | <b>Port H1</b>              | LCD segment 37                                                                                              |
| 3          | -      | -      | PH2/LCD SEG 38 <sup>(3)</sup>                                                                    | I/O  | FT <sup>(5)</sup> | <b>X</b> | X        | X              | HS               | X  | X  | <b>Port H2</b>              | LCD segment 38                                                                                              |
| 4          | -      | -      | PH3/LCD SEG 39 <sup>(3)</sup>                                                                    | I/O  | FT <sup>(5)</sup> | <b>X</b> | X        | X              | HS               | X  | X  | <b>Port H3</b>              | LCD segment 39                                                                                              |
| 6          | 2      | 2      | NRST/PA1 <sup>(1)</sup>                                                                          | I/O  | -                 | -        | <b>X</b> | -              | HS               | X  | X  | <b>Reset</b>                | PA1                                                                                                         |
| 7          | 3      | 3      | PA2/OSC_IN/<br>[USART1_TX] <sup>(2)</sup> /<br>[SPI1_MISO] <sup>(2)</sup>                        | I/O  | -                 | <b>X</b> | X        | X              | HS               | X  | X  | <b>Port A2</b>              | HSE oscillator input /<br>[USART1 transmit] / [SPI1 master in- slave out] /                                 |
| 8          | 4      | 4      | PA3/OSC_OUT/[USART1_RX] <sup>(2)</sup> /<br>[SPI1_MOSI] <sup>(2)</sup>                           | I/O  | -                 | <b>X</b> | X        | X              | HS               | X  | X  | <b>Port A3</b>              | HSE oscillator output /<br>[USART1 receive] / [SPI1 master out/slave in] /                                  |
| 9          | 5      | 5      | PA4/TIM2_BKIN/<br>[TIM2_ETR] <sup>(2)</sup> /<br>LCD_COM0 <sup>(3)</sup> /ADC1_IN2<br>COMP1_INP  | I/O  | FT <sup>(5)</sup> | <b>X</b> | X        | X              | HS               | X  | X  | <b>Port A4</b>              | Timer 2 - break input /<br>[Timer 2 - trigger] /<br>LCD_COM 0 / ADC1 input 2/Comparator 1 positive input    |
| 10         | 6      | 6      | PA5/TIM3_BKIN/<br>[TIM3_ETR] <sup>(2)</sup> /<br>LCD_COM1 <sup>(3)</sup> /ADC1_IN1/<br>COMP1_INP | I/O  | FT <sup>(5)</sup> | <b>X</b> | X        | X              | HS               | X  | X  | <b>Port A5</b>              | Timer 3 - break input /<br>[Timer 3 - trigger] /<br>LCD_COM 1 /<br>ADC1 input 1/Comparator 1 positive input |
| 11         | 7      | 7      | PA6/ADC1_TRIG/<br>LCD_COM2 <sup>(3)</sup> /ADC1_IN0/<br>COMP1_INP                                | I/O  | FT <sup>(5)</sup> | <b>X</b> | X        | X              | HS               | X  | X  | <b>Port A6</b>              | ADC1 - trigger / LCD_COM2 /<br>ADC1 input 0/Comparator 1 positive input                                     |

Table 5. High-density STM8AL3xE8x pin description (continued)

| Pin number |        |        | Pin name                                                                                        | Type | I/O level         | Input    |     |                | Output           |    |    | Main function<br>(after reset) | Default alternate function                                                                                              |
|------------|--------|--------|-------------------------------------------------------------------------------------------------|------|-------------------|----------|-----|----------------|------------------|----|----|--------------------------------|-------------------------------------------------------------------------------------------------------------------------|
| LQFP80     | LQFP64 | LQFP48 |                                                                                                 |      |                   | floating | wpu | Ext. interrupt | High sink/source | OD | PP |                                |                                                                                                                         |
| 12         | 8      | 8      | PA7/LCD_SEG0 <sup>(3)</sup> /<br>TIM5_CH1                                                       | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port A7</b>                 | LCD segment 0 / TIM5<br>channel 1                                                                                       |
| 39         | 31     | 24     | PB0 <sup>(4)</sup> /TIM2_CH1/<br>LCD_SEG10 <sup>(3)</sup> /<br>ADC1_IN18/<br>COMP1_INP          | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port B0</b>                 | Timer 2 - channel 1 / LCD<br>segment 10 /<br>ADC1_IN18/Comparator 1<br>positive input                                   |
| 40         | 32     | 25     | PB1/TIM3_CH1/<br>LCD_SEG11 <sup>(3)</sup> /<br>ADC1_IN17/<br>COMP1_INP                          | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port B1</b>                 | Timer 3 - channel 1 / LCD<br>segment 11 /<br>ADC1_IN17/Comparator 1<br>positive input                                   |
| 41         | 33     | 26     | PB2/ TIM2_CH2/<br>LCD_SEG12 <sup>(3)</sup> /<br>ADC1_IN16/<br>COMP1_INP                         | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port B2</b>                 | Timer 2 - channel 2 / LCD<br>segment 12 /<br>ADC1_IN16/Comparator 1<br>positive input                                   |
| 42         | 34     | 27     | PB3/TIM2_ETR/<br>LCD_SEG13 <sup>(3)</sup> /<br>ADC1_IN15/COMP1_INP                              | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port B3</b>                 | Timer 2 - trigger / LCD<br>segment 13<br>/ADC1_IN15/Comparator 1<br>positive input                                      |
| 43         | 35     | -      | PB4 <sup>(4)</sup> /SPI1_NSS/<br>LCD_SEG14 <sup>(3)</sup> /<br>ADC1_IN14/COMP1_INP              | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port B4</b>                 | SPI1 master/slave select /<br>LCD segment 14 /<br>ADC1_IN14/Comparator 1<br>positive input                              |
| -          | -      | 28     | PB4 <sup>(4)</sup> /SPI1_NSS/<br>LCD_SEG14 <sup>(3)</sup> /<br>ADC1_IN14/DAC_OUT2/<br>COMP1_INP | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port B4</b>                 | SPI1 master/slave select /<br>LCD segment 14 /<br>ADC1_IN14 /<br>DAC channel 2<br>output/Comparator 1<br>positive input |
| 44         | 36     | -      | PB5/SPI1_SCK/<br>LCD_SEG15 <sup>(3)</sup> /<br>ADC1_IN13/<br>COMP1_INP                          | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port B5</b>                 | SPI1 clock / LCD segment<br>15 /<br>ADC1_IN13/Comparator 1<br>positive input                                            |
| -          | -      | 29     | PB5/SPI1_SCK/<br>LCD_SEG15 <sup>(3)</sup> /<br>ADC1_IN13/DAC_OUT2/<br>COMP1_INP                 | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port B5</b>                 | [SPI1 clock] / LCD segment<br>15 / ADC1_IN13 / DAC<br>channel 2<br>output/Comparator 1<br>positive input                |

Table 5. High-density STM8AL3xE8x pin description (continued)

| Pin number |        |        | Pin name                                                                                          | Type | I/O level         | Input    |     |                | Output           |    |    | Main function<br>(after reset) | Default alternate function                                                                                                                                                |
|------------|--------|--------|---------------------------------------------------------------------------------------------------|------|-------------------|----------|-----|----------------|------------------|----|----|--------------------------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| LQFP80     | LQFP64 | LQFP48 |                                                                                                   |      |                   | floating | wpu | Ext. interrupt | High sink/source | OD | PP |                                |                                                                                                                                                                           |
| 45         | 37     | -      | PB6/SPI1_MOSI/<br>LCD_SEG16 <sup>(3)</sup> /<br>ADC1_IN12/COMP1_INP                               | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port B6</b>                 | SPI1 master out/slave in/<br>LCD segment 16 /<br>ADC1_IN12/Comparator 1<br>positive input                                                                                 |
| -          | -      | 30     | PB6/SPI1_MOSI/<br>LCD_SEG16 <sup>(3)</sup> /<br>ADC1_IN12/DAC_OUT2/<br>COMP1_INP                  | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port B6</b>                 | SPI1 master out/<br>slave in / LCD segment 16 /<br>ADC1_IN12 / DAC channel<br>2 output/Comparator 1<br>positive input                                                     |
| 46         | 38     | 31     | PB7/SPI1_MISO/<br>LCD_SEG17 <sup>(3)</sup> /<br>ADC1_IN11/COMP1_INP                               | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port B7</b>                 | SPI1 master in- slave out/<br>LCD segment 17 /<br>ADC1_IN11/Comparator 1<br>positive input                                                                                |
| 65         | 53     | 37     | PC0/I2C1_SDA                                                                                      | I/O  | FT <sup>(5)</sup> | X        |     | X              | T <sup>(6)</sup> | -  | -  | <b>Port C0</b>                 | I2C1 data                                                                                                                                                                 |
| 66         | 54     | 38     | PC1/I2C1_SCL                                                                                      | I/O  | FT <sup>(5)</sup> | X        |     | X              | T <sup>(6)</sup> | -  | -  | <b>Port C1</b>                 | I2C1 clock                                                                                                                                                                |
| 69         | 57     | 41     | PC2/USART1_RX/<br>LCD_SEG22/ADC1_IN6/<br>COMP1_INP/VREFINT                                        | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port C2</b>                 | USART1 receive /<br>LCD segment 22 /<br>ADC1_IN6/Comparator 1<br>positive input/Internal<br>reference voltage output                                                      |
| -          | -      | 42     | PC3/USART1_TX/<br>LCD_SEG23 <sup>(3)</sup> /<br>ADC1_IN5                                          | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port C3</b>                 | USART1 transmit /<br>LCD segment 23 /<br>ADC1_IN5                                                                                                                         |
| 70         | 58     | -      | PC3/USART1_TX/<br>LCD_SEG23 <sup>(3)</sup> /<br>ADC1_IN5/COMP2_INM/<br>COMP1_INP                  | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port C3</b>                 | USART1 transmit /<br>LCD segment 23 /<br>ADC1_IN5 /<br>Comparator 2 negative input<br>/Comparator 1 input positive                                                        |
| 71         | 59     | 43     | PC4/USART1_CK/<br>I2C1_SMB/CCO/<br>LCD_SEG24 <sup>(3)</sup> /<br>ADC1_IN4/COMP2_INM/<br>COMP1_INP | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port C4</b>                 | USART1 synchronous clock<br>/ I2C1_SMB / Configurable<br>clock output / LCD segment<br>24 / ADC1_IN4 /<br>Comparator 2 negative input<br>/ Comparator 1 positive<br>input |
| 72         | 60     | 44     | PC5/OSC32_IN<br>/[SPI1_NSS] <sup>(2)</sup> /<br>[USART1_TX] <sup>(2)</sup>                        | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port C5</b>                 | LSE oscillator input / [SPI1<br>master/slave select] /<br>[USART1 transmit]                                                                                               |



Table 5. High-density STM8AL3xE8x pin description (continued)

| Pin number |        |        | Pin name                                                                                          | Type | I/O level         | Input    |     |                | Output           |    |    | Main function (after reset) | Default alternate function                                                                                                   |
|------------|--------|--------|---------------------------------------------------------------------------------------------------|------|-------------------|----------|-----|----------------|------------------|----|----|-----------------------------|------------------------------------------------------------------------------------------------------------------------------|
| LQFP80     | LQFP64 | LQFP48 |                                                                                                   |      |                   | floating | wpu | Ext. interrupt | High sink/source | OD | PP |                             |                                                                                                                              |
| 73         | 61     | 45     | PC6/OSC32_OUT/<br>[SPI1_SCK] <sup>(2)</sup> /<br>[USART1_RX] <sup>(2)</sup>                       | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port C6                     | LSE oscillator output / [SPI1 clock] / [USART1 receive]                                                                      |
| 74         | 62     | -      | PC7/LCD_SEG25 <sup>(3)</sup> /<br>ADC1_IN3/COMP2_INM/<br>COMP1_INP                                | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port C7                     | LCD segment 25<br>/ADC1_IN3/ Comparator<br>negative input / Comparator<br>1 positive input                                   |
| -          | -      | 46     | PC7/LCD_SEG25 <sup>(3)</sup> /<br>ADC1_IN3/USART3_CK/<br>COMP2_INM/<br>COMP1_INP                  | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port C7                     | LCD segment 25<br>/ADC1_IN3/ USART3<br>synchronous clock/<br>Comparator 2 negative input<br>/ Comparator 1 positive<br>input |
| 29         | 25     | 20     | PD0/TIM3_CH2/<br>[ADC1_TRIG] <sup>(2)</sup> /<br>LCD_SEG7 <sup>(3)</sup> /<br>ADC1_IN22/COMP2_INP | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port D0                     | Timer 3 - channel 2 /<br>[ADC1_Trigger] / LCD<br>segment 7 / ADC1_IN22 /<br>Comparator 2 positive input<br>2                 |
| 30         | 26     | 21     | PD1/TIM3_ETR/<br>LCD_COM3 <sup>(3)</sup> /<br>ADC1_IN21/COMP1_INP/<br>COMP2_INP                   | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port D1                     | Timer 3 - trigger /<br>LCD_COM3 / ADC1_IN21 /<br>comparator 1 positive input/<br>comparator 2 positive input                 |
| 31         | 27     | 22     | PD2/TIM1_CH1<br>/LCD_SEG8 <sup>(3)</sup> /<br>ADC1_IN20/COMP1_INP                                 | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port D2                     | Timer 1 - channel 1 / LCD<br>segment 8 /<br>ADC1_IN20/Comparator 1<br>positive input                                         |
| 32         | 28     | 23     | PD3/ TIM1_ETR/<br>LCD_SEG9 <sup>(3)</sup> /<br>ADC1_IN19/<br>COMP1_INP                            | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port D3                     | Timer 1 - trigger / LCD<br>segment 9 /<br>ADC1_IN19/Comparator 1<br>positive input                                           |
| 57         | 45     | -      | PD4/TIM1_CH2<br>/LCD_SEG18 <sup>(3)</sup> /<br>ADC1_IN10/<br>COMP1_INP                            | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port D4                     | Timer 1 - channel 2 / LCD<br>segment 18 /<br>ADC1_IN10/Comparator 1<br>positive input                                        |
| -          | -      | 33     | PD4/TIM1_CH2<br>/LCD_SEG18 <sup>(3)</sup> /<br>ADC1_IN10/SPI2_MISO/<br>COMP1_INP                  | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port D4                     | Timer 1 - channel 2 / LCD<br>segment 18 /<br>ADC1_IN10/SPI2 master<br>in/slave out/Comparator 1<br>positive input            |

Table 5. High-density STM8AL3xE8x pin description (continued)

| Pin number |        |        | Pin name                                                                                              | Type | I/O level         | Input    |     |                | Output           |    |    | Main function<br>(after reset) | Default alternate function                                                                                                                                                    |
|------------|--------|--------|-------------------------------------------------------------------------------------------------------|------|-------------------|----------|-----|----------------|------------------|----|----|--------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| LQFP80     | LQFP64 | LQFP48 |                                                                                                       |      |                   | floating | wpu | Ext. interrupt | High sink/source | OD | PP |                                |                                                                                                                                                                               |
| 58         | 46     | -      | PD5/TIM1_CH3<br>/LCD_SEG19 <sup>(3)</sup> /<br>ADC1_IN9/<br>COMP1_INP                                 | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port D5</b>                 | Timer 1 - channel 3 / LCD<br>segment 19 /<br>ADC1_IN9/Comparator 1<br>positive input                                                                                          |
| -          | -      | 34     | PD5/TIM1_CH3<br>/LCD_SEG19 <sup>(3)</sup> /<br>ADC1_IN9/SPI2_MOSI/<br>COMP1_INP                       | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port D5</b>                 | Timer 1 - channel 3 / LCD<br>segment 19 / ADC1_IN9/<br>SPI2 master out/slave<br>in/Comparator 1 positive<br>input                                                             |
| 59         | 47     | -      | PD6/TIM1_BKIN<br>/LCD_SEG20 <sup>(3)</sup> /<br>ADC1_IN8/RTC_CALIB/<br>COMP1_INP/VREFINT              | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port D6</b>                 | Timer 1 - break input / LCD<br>segment 20 / ADC1_IN8 /<br>RTC calibration/Comparator<br>1 positive input/Internal<br>reference voltage output                                 |
| -          | -      | 35     | PD6/TIM1_BKIN<br>/LCD_SEG20 <sup>(3)</sup> /<br>ADC1_IN8/RTC_CALIB/<br>SPI2_SCK/COMP1_INP/<br>VREFINT | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port D6</b>                 | Timer 1 - break input / LCD<br>segment 20 / ADC1_IN8 /<br>RTC calibration/SPI2<br>clock/Comparator 1 positive<br>input/Internal reference<br>voltage output                   |
| 60         | 48     | -      | PD7/TIM1_CH1N<br>/LCD_SEG21 <sup>(3)</sup> /<br>ADC1_IN7/RTC_ALARM/<br>COMP1_INP/VREFINT              | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port D7</b>                 | Timer 1 - inverted channel 1/<br>LCD segment 21 /<br>ADC1_IN7 / RTC<br>alarm/Comparator 1 positive<br>input/Internal reference<br>voltage output                              |
| -          | -      | 36     | PD7/TIM1_CH1N<br>/LCD_SEG21 <sup>(3)</sup> /<br>ADC1_IN7/RTC_ALARM/<br>SPI2_NSS/COMP1_INP/V<br>REFINT | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port D7</b>                 | Timer 1 - inverted channel 1/<br>LCD segment 21 /<br>ADC1_IN7 / RTC alarm<br>/SPI2 master/slave<br>select/Comparator 1 positive<br>input/Internal reference<br>voltage output |
| 61         | 49     | -      | PG4/LCD_SEG32/<br>SPI2_NSS                                                                            | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port G4</b>                 | LCD segment 32 / SPI2<br>master/slave select                                                                                                                                  |
| 62         | 50     | -      | PG5/LCD_SEG33/<br>SPI2_SCK                                                                            | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port G5</b>                 | LCD segment 33 / SPI2<br>clock                                                                                                                                                |
| 63         | 51     | -      | PG6/LCD_SEG34/<br>SPI2_MOSI                                                                           | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port G6</b>                 | LCD segment 34 / SPI2<br>master out- slave in                                                                                                                                 |

Table 5. High-density STM8AL3xE8x pin description (continued)

| Pin number |        |        | Pin name                                                                         | Type | I/O level         | Input    |     |                | Output           |    |    | Main function (after reset) | Default alternate function                                                                                   |
|------------|--------|--------|----------------------------------------------------------------------------------|------|-------------------|----------|-----|----------------|------------------|----|----|-----------------------------|--------------------------------------------------------------------------------------------------------------|
| LQFP80     | LQFP64 | LQFP48 |                                                                                  |      |                   | floating | wpu | Ext. interrupt | High sink/source | OD | PP |                             |                                                                                                              |
| 64         | 52     | -      | PG7/LCD_SEG35/<br>SPI2_MISO                                                      | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port G7</b>              | LCD segment 35 / SPI2 master in- slave out                                                                   |
| 23         | -      | -      | PE0/LCD_SEG1 <sup>(3)</sup> /<br>TIM5_CH2                                        | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port E0</b>              | LCD segment 1 /Timer 5 channel 2                                                                             |
| -          | 19     | 14     | PE0/LCD_SEG1 <sup>(3)</sup> /<br>TIM5_CH2/RTC_TAMP1                              | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port E0</b>              | LCD segment 1 /Timer 5 channel 2 / RTC tamper 1                                                              |
| 24         | -      | -      | PE1/TIM1_CH2N<br>/LCD_SEG2 <sup>(3)</sup>                                        | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port E1</b>              | Timer 1 - inverted channel 2 / LCD segment 2                                                                 |
| -          | 20     | 15     | PE1/TIM1_CH2N<br>/LCD_SEG2 <sup>(3)</sup> /<br>RTC_TAMP2                         | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port E1</b>              | Timer 1 - inverted channel 2 / LCD segment 2 / RTC tamper 2                                                  |
| 25         | -      | -      | PE2/TIM1_CH3N<br>/LCD_SEG3 <sup>(3)</sup>                                        | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port E2</b>              | Timer 1 - inverted channel 3 / LCD segment 3                                                                 |
| -          | 21     | 16     | PE2/TIM1_CH3N<br>/LCD_SEG3 <sup>(3)</sup> /<br>RTC_TAMP3                         | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port E2</b>              | Timer 1 - inverted channel 3 / LCD segment 3 / RTC tamper 3                                                  |
| 26         | -      | -      | PE3/LCD_SEG4 <sup>(3)</sup>                                                      | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port E3</b>              | LCD segment 4                                                                                                |
| -          | 22     | 17     | PE3/LCD_SEG4 <sup>(3)</sup> /<br>USART2_RX                                       | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port E3</b>              | LCD segment 4 / USART2 receive                                                                               |
| 27         | -      | -      | PE4/LCD_SEG5 <sup>(3)</sup> /<br>DAC_TRIG1                                       | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port E4</b>              | LCD segment 5 / DAC 1 trigger                                                                                |
| -          | 23     | 18     | PE4/LCD_SEG5 <sup>(3)</sup> /<br>DAC_TRIG2/USART2_TX                             | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port E4</b>              | LCD segment 5 / DAC 2 trigger / USART2 transmit                                                              |
| 28         | -      | -      | PE5/LCD_SEG6 <sup>(3)</sup> /<br>ADC1_IN23/COMP1_INP/<br>COMP2_INP               | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port E5</b>              | LCD segment 6 / ADC1_IN23/Comparator 1 positive input/Comparator 2 positive input                            |
| -          | 24     | 19     | PE5/LCD_SEG6 <sup>(3)</sup> /<br>ADC1_IN23/COMP1_INP/<br>COMP2_INP/<br>USART2_CK | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port E5</b>              | LCD segment 6 / ADC1_IN23/ Comparator 1 positive input/ Comparator 2 positive input/USART2 synchronous clock |
| -          | -      | 47     | PE6/LCD_SEG26 <sup>(3)</sup> /<br>PVD_IN/TIM5_BKIN/<br>USART3_TX                 | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port E6</b>              | LCD segment 26 /PVD_IN /TIM5 break input / USART3 transmit                                                   |

Table 5. High-density STM8AL3xE8x pin description (continued)

| Pin number |        |        | Pin name                                                   | Type | I/O level         | Input    |     |                | Output           |    |    | Main function<br>(after reset) | Default alternate function                                                             |
|------------|--------|--------|------------------------------------------------------------|------|-------------------|----------|-----|----------------|------------------|----|----|--------------------------------|----------------------------------------------------------------------------------------|
| LQFP80     | LQFP64 | LQFP48 |                                                            |      |                   | floating | wpu | Ext. interrupt | High sink/source | OD | PP |                                |                                                                                        |
| 75         | 63     | -      | PE6/LCD_SEG26 <sup>(3)</sup> /<br>PVD_IN/TIM5_BKIN         | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port E6                        | LCD segment 26 /PVD_IN<br>/TIM5 break input                                            |
| 76         | 64     | -      | PE7/LED_SEG27/<br>TIM5_ETR                                 | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port E7                        | LCD segment 27/<br>TIM5 trigger                                                        |
| -          | -      | 48     | PE7/LED_SEG27/<br>TIM5_ETR/<br>USART3_RX                   | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port E7                        | LCD segment 27/TIM5 trig-<br>ger/USART3 receive                                        |
| 77         | -      | -      | PI0/RTC_TAMP1/<br>[SPI2_NSS]/[TIM3_CH1]                    | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port I0                        | RTC tamper 1 output<br>[SPI2 master/slave select]<br>[TIM3 channel 1]                  |
| 78         | -      | -      | PI1/RTC_TAMP2/<br>[SPI2_SCK]                               | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port I1                        | RTC tamper 2 output<br>[SPI2 clock]                                                    |
| 79         | -      | -      | PI2/RTC_TAMP3/<br>[SPI2_MOSI]                              | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port I2                        | RTC tamper 3 output<br>[SPI2 master out- slave in]                                     |
| 80         | -      | -      | PI3/TIM5_CH1/<br>[SPI2_MISO]/[TIM3_CH2]                    | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | Port I3                        | TIM5 Channel 1<br>[SPI2 master in- slave out]<br>[TIM3 channel 2]                      |
| -          | -      | 32     | PF0/ADC1_IN24/<br>DAC_OUT1                                 | I/O  | -                 | X        | X   | X              | HS               | X  | X  | Port F0                        | ADC1_IN24 / DAC 1 output                                                               |
| -          | 39     | -      | PF0/ADC1_IN24/<br>DAC_OUT1<br>[USART3_TX]                  | I/O  | -                 | X        | X   | X              | HS               | X  | X  | Port F0                        | ADC1_IN24 /<br>DAC 1 output/<br>[USART3 transmit]                                      |
| 49         | -      | -      | PF0/ADC1_IN24/<br>DAC_OUT1/<br>[USART3_TX]/[SPI1_MIS<br>O] | I/O  | -                 | X        | X   | X              | HS               | X  | X  | Port F0                        | ADC1_IN24 / DAC 1 output/<br>[USART3 transmit]<br>[SPI1 master in- slave out]          |
| 50         | -      | -      | PF1/ADC1_IN25/<br>DAC_OUT2/<br>[USART3_RX]/<br>[SPI1_MOSI] | I/O  | -                 | X        | X   | X              | HS               | X  | X  | Port F1                        | ADC1_IN25/<br>DAC channel 2 output/<br>[USART3 receive]<br>[SPI1 master out- slave in] |
| -          | 40     | -      | PF1/ADC1_IN25/<br>DAC_OUT2/<br>[USART3_RX]                 | I/O  | -                 | X        | X   | X              | HS               | X  | X  | Port F1                        | ADC1_IN25/<br>DAC channel 2 output/<br>[USART3 receive]                                |
| 51         | -      | -      | PF2/ADC1_IN26/<br>[SPI1_SCK]/<br>[USART3_SCK]              | I/O  | -                 | X        | X   | X              | HS               | X  | X  | Port F2                        | ADC1_IN26<br>[SPI1 clock]<br>[USART3 clock]                                            |
| 52         | -      | -      | PF3/ADC1_IN27/<br>[SPI1_NSS]                               | I/O  | -                 | X        | X   | X              | HS               | X  | X  | Port F3                        | ADC1_IN26<br>[SPI1 master/slave select]                                                |

Table 5. High-density STM8AL3xE8x pin description (continued)

| Pin number |        |        | Pin name                                             | Type | I/O level         | Input    |     |                | Output           |    |    | Main function<br>(after reset) | Default alternate function                                              |
|------------|--------|--------|------------------------------------------------------|------|-------------------|----------|-----|----------------|------------------|----|----|--------------------------------|-------------------------------------------------------------------------|
| LQFP80     | LQFP64 | LQFP48 |                                                      |      |                   | floating | wpu | Ext. interrupt | High sink/source | OD | PP |                                |                                                                         |
| 53         | 41     | -      | PF4/LCD_COM4                                         | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port F4</b>                 | LCD COM4                                                                |
| 54         | 42     | -      | PF5/LCD_COM5                                         | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port F5</b>                 | LCD COM5                                                                |
| 55         | 43     | -      | PF6/LCD_COM6                                         | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port F6</b>                 | LCD COM6                                                                |
| 56         | 44     | -      | PF7/LCD_COM7                                         | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port F7</b>                 | LCD COM7                                                                |
| 22         | 18     | 13     | VLCD <sup>(7)</sup>                                  | S    | -                 | -        | -   | -              | -                | -  | -  |                                | LCD booster external capacitor                                          |
| 15         | 11     | 10     | V <sub>DD1</sub>                                     | S    | -                 | -        | -   | -              | -                | -  | -  |                                | Digital power supply                                                    |
| 14         | 10     | -      | V <sub>SS1</sub>                                     | -    | -                 | -        | -   | -              | -                | -  | -  |                                | I/O ground                                                              |
| 16         | 12     | 11     | V <sub>DDA</sub>                                     | S    | -                 | -        | -   | -              | -                | -  | -  |                                | Analog supply voltage                                                   |
| 17         | 13     | 12     | V <sub>REF+</sub> /V <sub>REF+</sub> _DAC            | S    | -                 | -        | -   | -              | -                | -  | -  |                                | ADC1 and DAC1/2 positive voltage reference                              |
| 18         | 14     | -      | PG0/LCD SEG 28 <sup>(3)</sup> /USART3_RX/[TIM2_BKIN] | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port G0</b>                 | LCD segment 28/<br>USART3 receive /<br>[Timer 2 - break input]          |
| 19         | 15     | -      | PG1/LCD SEG 29 <sup>(3)</sup> /USART3_TX/[TIM3_BKIN] | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port G1</b>                 | LCD segment 29/<br>USART3 transmit /<br>[Timer 3 - break input]         |
| 20         | 16     | -      | PG2/LCD_SEG 30 <sup>(3)</sup> /USART3_CK             | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port G2</b>                 | LCD segment 30/<br>USART 3 synchronous clock                            |
| 21         | 17     | -      | PG3/LCD SEG 31 <sup>(3)</sup> /[TIM3_ETR]            | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port G3</b>                 | LCD segment 31/<br>[Timer 3 - trigger]                                  |
| 33         | -      | -      | PH4/USART2_RX                                        | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port H4</b>                 | USART2 receive                                                          |
| 34         | -      | -      | PH5/USART2_TX                                        | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port H5</b>                 | USART2 transmit                                                         |
| 35         | -      | -      | PH6/USART2_CK/TIM5_CH1                               | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port H6</b>                 | USART2 synchronous clock/ Timer 5 - channel 1                           |
| 36         | -      | -      | PH7/TIM5_CH2                                         | I/O  | FT <sup>(5)</sup> | X        | X   | X              | HS               | X  | X  | <b>Port H7</b>                 | Timer 5 - channel 2                                                     |
| -          | -      | 9      | V <sub>SS</sub> /V <sub>SSA</sub> /V <sub>REF-</sub> | S    | -                 | -        | -   | -              | -                | -  | -  |                                | I/O ground / Analog ground voltage /<br>ADC1 negative voltage reference |
| 13         | 9      | -      | V <sub>SSA</sub> /V <sub>REF-</sub>                  | S    | -                 | -        | -   | -              | -                | -  | -  |                                | Analog ground voltage /<br>ADC1 negative voltage reference              |
| 37         | 29     | -      | V <sub>DD3</sub>                                     | S    | -                 | -        | -   | -              | -                | -  | -  |                                | IOs supply voltage                                                      |
| 38         | 30     | -      | V <sub>SS3</sub>                                     | S    | -                 | -        | -   | -              | -                | -  | -  |                                | IOs ground voltage                                                      |

Table 5. High-density STM8AL3xE8x pin description (continued)

| Pin number |        |        | Pin name                                                                        | Type | I/O level | Input    |     |                | Output           |    |    | Main function (after reset) | Default alternate function                                                                              |
|------------|--------|--------|---------------------------------------------------------------------------------|------|-----------|----------|-----|----------------|------------------|----|----|-----------------------------|---------------------------------------------------------------------------------------------------------|
| LQFP80     | LQFP64 | LQFP48 |                                                                                 |      |           | floating | wpu | Ext. interrupt | High sink/source | OD | PP |                             |                                                                                                         |
| 5          | 1      | 1      | PA0 <sup>(8)</sup> /[USART1_CK] <sup>(2)</sup> /SWIM/BEEP/IR_TIM <sup>(9)</sup> | I/O  | -         | X        | X   | X              | HS               | X  | X  | Port A0                     | [USART1 synchronous clock] <sup>(2)</sup> / SWIM input and output / Beep output / Infrared Timer output |
| 68         | 56     | 40     | V <sub>SS2</sub>                                                                | S    | -         | -        | -   | -              | -                | -  | -  |                             | I/Os ground voltage                                                                                     |
| 67         | 55     | 39     | V <sub>DD2</sub>                                                                | S    | -         | -        | -   | -              | -                | -  | -  |                             | I/Os supply voltage                                                                                     |
| 48         | -      | -      | V <sub>SS4</sub>                                                                | S    | -         | -        | -   | -              | -                | -  | -  |                             | I/Os ground voltage                                                                                     |
| 47         | -      | -      | V <sub>DD4</sub>                                                                | S    | -         | -        | -   | -              | -                | -  | -  |                             | I/Os supply voltage                                                                                     |

- At power-up, the PA1/NRST pin is a reset input pin with pull-up. To be used as a general purpose pin (PA1), it can be configured only as output open-drain or push-pull, not as a general purpose input. Refer to Section *Configuring NRST/PA1 pin as general purpose output* in STM8L051/L052 Value Line, STM8L151/L152, STM8L162, STM8AL31, STM8AL3L MCU lines reference manual (RM0031).
- [ ] Alternate function remapping option (if the same alternate function is shown twice, it indicates an exclusive choice not a duplication of the function).
- Available on STM8AL3LE8x devices only.
- A pull-up is applied to PB0 and PB4 during the reset phase. These two pins are input floating after reset release.
- In the 5 V tolerant I/Os, the protection diode to V<sub>DD</sub> is not implemented.
- In the open-drain output column, 'T' defines a true open-drain I/O (P-buffer, weak pull-up and protection diode to V<sub>DD</sub> are not implemented).
- Available on STM8AL3LE8x devices only. On STM8AL31E8x devices it is reserved and must be tied to V<sub>DD</sub>.
- The PA0 pin is in input pull-up during the reset phase and after reset release.
- High Sink LED driver capability available on PA0.

**Note:** The slope control of all GPIO pins, except true open drain pins, are programmable. By default the slope control is limited to 2 MHz.

### System configuration options

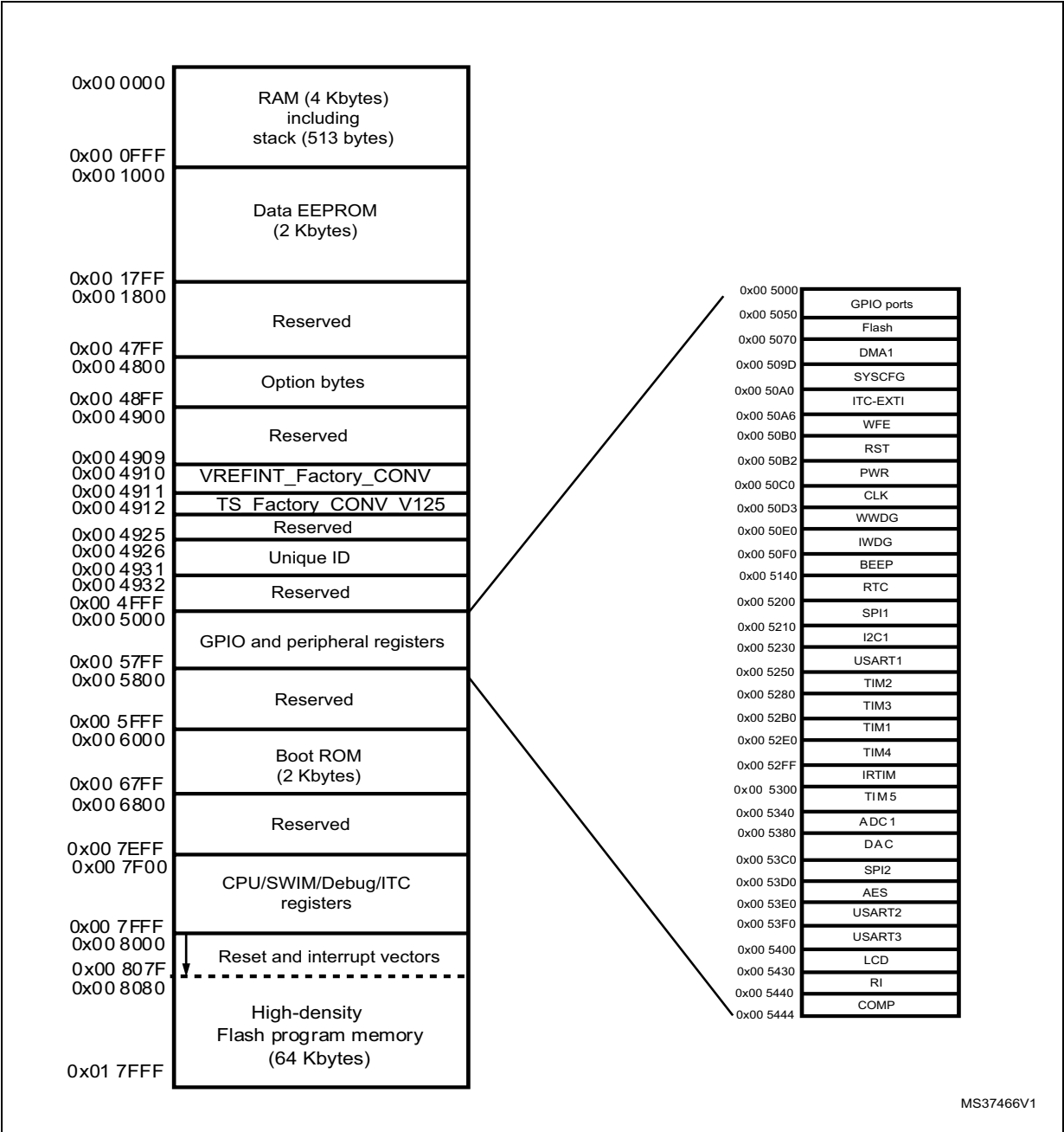
As shown in [Table 5: High-density STM8AL3xE8x pin description](#), some alternate functions can be remapped on different I/O ports by programming one of the two remapping registers described in the "Routing interface (RI) and system configuration controller" section in STM8L051/L052 Value Line, STM8L151/L152, STM8L162, STM8AL31, STM8AL3L MCU lines reference manual (RM0031).

# 5 Memory and register map

## 5.1 Memory mapping

The memory map is shown in [Figure 9](#).

Figure 9. Memory map



MS37466V1

1. Refer to [Table 9](#) for an overview of hardware register mapping, to [Table 8](#) for details on I/O port hardware registers, and to [Table 10](#) for information on CPU/SWIM/debug module controller registers.

Table 6. Flash and RAM boundary addresses

| Memory area          | Size     | Start address | End address |
|----------------------|----------|---------------|-------------|
| RAM                  | 4 Kbyte  | 0x00 0000     | 0x00 0FFF   |
| Flash program memory | 64 Kbyte | 0x00 8000     | 0x01 7FFF   |

## 5.2 Register map

Table 7. Factory conversion registers

| Address   | Block | Register label                      | Register name                                 | Reset status |
|-----------|-------|-------------------------------------|-----------------------------------------------|--------------|
| 0x00 4910 | -     | VREFINT_Factory_CONV <sup>(1)</sup> | Internal reference voltage factory conversion | 0xXX         |
| 0x00 4911 | -     | TS_Factory_CONV_V125 <sup>(2)</sup> | Temperature sensor output voltage             | 0xXX         |

1. The VREFINT\_Factory\_CONV byte represents the 8 LSB of the result of the VREFINT 12-bit ADC conversion performed in factory. The 2 MSB have a fixed value: 0x6.
2. The TS\_Factory\_CONV\_V125 byte represents the 8 LSB of the result of the V125 12-bit ADC conversion performed in factory. The 2 MSB have a fixed value: 0x3.

Table 8. I/O port hardware register map

| Address   | Block  | Register label | Register name                     | Reset status |
|-----------|--------|----------------|-----------------------------------|--------------|
| 0x00 5000 | Port A | PA_ODR         | Port A data output latch register | 0x00         |
| 0x00 5001 |        | PA_IDR         | Port A input pin value register   | 0xXX         |
| 0x00 5002 |        | PA_DDR         | Port A data direction register    | 0x00         |
| 0x00 5003 |        | PA_CR1         | Port A control register 1         | 0x01         |
| 0x00 5004 |        | PA_CR2         | Port A control register 2         | 0x00         |
| 0x00 5005 | Port B | PB_ODR         | Port B data output latch register | 0x00         |
| 0x00 5006 |        | PB_IDR         | Port B input pin value register   | 0xXX         |
| 0x00 5007 |        | PB_DDR         | Port B data direction register    | 0x00         |
| 0x00 5008 |        | PB_CR1         | Port B control register 1         | 0x00         |
| 0x00 5009 |        | PB_CR2         | Port B control register 2         | 0x00         |
| 0x00 500A | Port C | PC_ODR         | Port C data output latch register | 0x00         |
| 0x00 500B |        | PC_IDR         | Port C input pin value register   | 0xXX         |
| 0x00 500C |        | PC_DDR         | Port C data direction register    | 0x00         |
| 0x00 500D |        | PC_CR1         | Port C control register 1         | 0x00         |
| 0x00 500E |        | PC_CR2         | Port C control register 2         | 0x00         |



Table 8. I/O port hardware register map (continued)

| Address   | Block  | Register label | Register name                     | Reset status |
|-----------|--------|----------------|-----------------------------------|--------------|
| 0x00 500F | Port D | PD_ODR         | Port D data output latch register | 0x00         |
| 0x00 5010 |        | PD_IDR         | Port D input pin value register   | 0xXX         |
| 0x00 5011 |        | PD_DDR         | Port D data direction register    | 0x00         |
| 0x00 5012 |        | PD_CR1         | Port D control register 1         | 0x00         |
| 0x00 5013 |        | PD_CR2         | Port D control register 2         | 0x00         |
| 0x00 5014 | Port E | PE_ODR         | Port E data output latch register | 0x00         |
| 0x00 5015 |        | PE_IDR         | Port E input pin value register   | 0xXX         |
| 0x00 5016 |        | PE_DDR         | Port E data direction register    | 0x00         |
| 0x00 5017 |        | PE_CR1         | Port E control register 1         | 0x00         |
| 0x00 5018 |        | PE_CR2         | Port E control register 2         | 0x00         |
| 0x00 5019 | Port F | PF_ODR         | Port F data output latch register | 0x00         |
| 0x00 501A |        | PF_IDR         | Port F input pin value register   | 0xXX         |
| 0x00 501B |        | PF_DDR         | Port F data direction register    | 0x00         |
| 0x00 501C |        | PF_CR1         | Port F control register 1         | 0x00         |
| 0x00 501D |        | PF_CR2         | Port F control register 2         | 0x00         |
| 0x00 501E | Port G | PG_ODR         | Port G data output latch register | 0x00         |
| 0x00 501F |        | PG_IDR         | Port G input pin value register   | 0xXX         |
| 0x00 5020 |        | PG_DDR         | Port G data direction register    | 0x00         |
| 0x00 5021 |        | PG_CR1         | Port G control register 1         | 0x00         |
| 0x00 5022 |        | PG_CR2         | Port G control register 2         | 0x00         |
| 0x00 5023 | Port H | PH_ODR         | Port H data output latch register | 0x00         |
| 0x00 5024 |        | PH_IDR         | Port H input pin value register   | 0xXX         |
| 0x00 5025 |        | PH_DDR         | Port H data direction register    | 0x00         |
| 0x00 5026 |        | PH_CR1         | Port H control register 1         | 0x00         |
| 0x00 5027 |        | PH_CR2         | Port H control register 2         | 0x00         |
| 0x00 5028 | Port I | PI_ODR         | Port I data output latch register | 0x00         |
| 0x00 5029 |        | PI_IDR         | Port I input pin value register   | 0xXX         |
| 0x00 502A |        | PI_DDR         | Port I data direction register    | 0x00         |
| 0x00 502B |        | PI_CR1         | Port I control register 1         | 0x00         |
| 0x00 502C |        | PI_CR2         | Port I control register 2         | 0x00         |

Table 9. General hardware register map

| Address                      | Block                   | Register label         | Register name                                        | Reset status |
|------------------------------|-------------------------|------------------------|------------------------------------------------------|--------------|
| 0x00 502E<br>to<br>0x00 5049 | Reserved area (44 byte) |                        |                                                      |              |
| 0x00 5050                    | Flash                   | FLASH_CR1              | Flash control register 1                             | 0x00         |
| 0x00 5051                    |                         | FLASH_CR2              | Flash control register 2                             | 0x00         |
| 0x00 5052                    |                         | FLASH_PUKR             | Flash program memory unprotection key register       | 0x00         |
| 0x00 5053                    |                         | FLASH_DUKR             | Data EEPROM unprotection key register                | 0x00         |
| 0x00 5054                    |                         | FLASH_IAPSR            | Flash in-application programming status register     | 0x00         |
| 0x00 5055<br>to<br>0x00 506F | Reserved area (27 byte) |                        |                                                      |              |
| 0x00 5070                    | DMA1                    | DMA1_GCSR              | DMA1 global configuration & status register          | 0xFC         |
| 0x00 5071                    |                         | DMA1_GIR1              | DMA1 global interrupt register 1                     | 0x00         |
| 0x00 5072 to<br>0x00 5074    | Reserved area (3 byte)  |                        |                                                      |              |
| 0x00 5075                    | DMA1                    | DMA1_C0CR              | DMA1 channel 0 configuration register                | 0x00         |
| 0x00 5076                    |                         | DMA1_C0SPR             | DMA1 channel 0 status & priority register            | 0x00         |
| 0x00 5077                    |                         | DMA1_C0NDTR            | DMA1 number of data to transfer register (channel 0) | 0x00         |
| 0x00 5078                    |                         | DMA1_C0PARH            | DMA1 peripheral address high register (channel 0)    | 0x52         |
| 0x00 5079                    |                         | DMA1_C0PARL            | DMA1 peripheral address low register (channel 0)     | 0x00         |
| 0x00 507A                    |                         | Reserved area (1 byte) |                                                      |              |
| 0x00 507B                    |                         | DMA1_C0M0ARH           | DMA1 memory 0 address high register (channel 0)      | 0x00         |
| 0x00 507C                    |                         | DMA1_C0M0ARL           | DMA1 memory 0 address low register (channel 0)       | 0x00         |
| 0x00 507D to<br>0x00 507E    | Reserved area (2 byte)  |                        |                                                      |              |
| 0x00 507F                    | DMA1                    | DMA1_C1CR              | DMA1 channel 1 configuration register                | 0x00         |
| 0x00 5080                    |                         | DMA1_C1SPR             | DMA1 channel 1 status & priority register            | 0x00         |
| 0x00 5081                    |                         | DMA1_C1NDTR            | DMA1 number of data to transfer register (channel 1) | 0x00         |
| 0x00 5082                    |                         | DMA1_C1PARH            | DMA1 peripheral address high register (channel 1)    | 0x52         |
| 0x00 5083                    |                         | DMA1_C1PARL            | DMA1 peripheral address low register (channel 1)     | 0x00         |

Table 9. General hardware register map (continued)

| Address                   | Block                  | Register label          | Register name                                        | Reset status |
|---------------------------|------------------------|-------------------------|------------------------------------------------------|--------------|
| 0x00 5084                 | Reserved area (1 byte) |                         |                                                      |              |
| 0x00 5085                 | DMA1                   | DMA1_C1M0ARH            | DMA1 memory 0 address high register (channel 1)      | 0x00         |
| 0x00 5086                 |                        | DMA1_C1M0ARL            | DMA1 memory 0 address low register (channel 1)       | 0x00         |
| 0x00 5087<br>0x00 5088    | Reserved area (2 byte) |                         |                                                      |              |
| 0x00 5089                 | DMA1                   | DMA1_C2CR               | DMA1 channel 2 configuration register                | 0x00         |
| 0x00 508A                 |                        | DMA1_C2SPR              | DMA1 channel 2 status & priority register            | 0x00         |
| 0x00 508B                 |                        | DMA1_C2NDTR             | DMA1 number of data to transfer register (channel 2) | 0x00         |
| 0x00 508C                 |                        | DMA1_C2PARH             | DMA1 peripheral address high register (channel 2)    | 0x52         |
| 0x00 508D                 |                        | DMA1_C2PARL             | DMA1 peripheral address low register (channel 2)     | 0x00         |
| 0x00 508E                 |                        | Reserved area (1 byte)  |                                                      |              |
| 0x00 508F                 |                        | DMA1_C2M0ARH            | DMA1 memory 0 address high register (channel 2)      | 0x00         |
| 0x00 5090                 |                        | DMA1_C2M0ARL            | DMA1 memory 0 address low register (channel 2)       | 0x00         |
| 0x00 5091<br>0x00 5092    | Reserved area (2 byte) |                         |                                                      |              |
| 0x00 5093                 | DMA1                   | DMA1_C3CR               | DMA1 channel 3 configuration register                | 0x00         |
| 0x00 5094                 |                        | DMA1_C3SPR              | DMA1 channel 3 status & priority register            | 0x00         |
| 0x00 5095                 |                        | DMA1_C3NDTR             | DMA1 number of data to transfer register (channel 3) | 0x00         |
| 0x00 5096                 |                        | DMA1_C3PARH_<br>C3M1ARH | DMA1 peripheral address high register (channel 3)    | 0x40         |
| 0x00 5097                 |                        | DMA1_C3PARL_<br>C3M1ARL | DMA1 peripheral address low register (channel 3)     | 0x00         |
| 0x00 5098                 |                        | DMA_C3M0EAR             | DMA channel 3 memory 0 extended address register     | 0x00         |
| 0x00 5099                 |                        | DMA1_C3M0ARH            | DMA1 memory 0 address high register (channel 3)      | 0x00         |
| 0x00 509A                 |                        | DMA1_C3M0ARL            | DMA1 memory 0 address low register (channel 3)       | 0x00         |
| 0x00 509B to<br>0x00 509C | Reserved area (3 byte) |                         |                                                      |              |

Table 9. General hardware register map (continued)

| Address                      | Block                   | Register label | Register name                             | Reset status        |
|------------------------------|-------------------------|----------------|-------------------------------------------|---------------------|
| 0x00 509D                    | SYSCFG                  | SYSCFG_RMPCR3  | Remapping register 3                      | 0x00                |
| 0x00 509E                    |                         | SYSCFG_RMPCR1  | Remapping register 1                      | 0x00                |
| 0x00 509F                    |                         | SYSCFG_RMPCR2  | Remapping register 2                      | 0x00                |
| 0x00 50A0                    | ITC - EXTI              | EXTI_CR1       | External interrupt control register 1     | 0x00                |
| 0x00 50A1                    |                         | EXTI_CR2       | External interrupt control register 2     | 0x00                |
| 0x00 50A2                    |                         | EXTI_CR3       | External interrupt control register 3     | 0x00                |
| 0x00 50A3                    |                         | EXTI_SR1       | External interrupt status register 1      | 0x00                |
| 0x00 50A4                    |                         | EXTI_SR2       | External interrupt status register 2      | 0x00                |
| 0x00 50A5                    |                         | EXTI_CONF1     | External interrupt port select register 1 | 0x00                |
| 0x00 50A6                    | WFE                     | WFE_CR1        | WFE control register 1                    | 0x00                |
| 0x00 50A7                    |                         | WFE_CR2        | WFE control register 2                    | 0x00                |
| 0x00 50A8                    |                         | WFE_CR3        | WFE control register 3                    | 0x00                |
| 0x00 50A9                    |                         | WFE_CR4        | WFE control register 4                    | 0x00                |
| 0x00 50AA                    | ITC - EXTI              | EXTI_CR4       | External interrupt control register 4     | 0x00                |
| 0x00 50AB                    |                         | EXTI_CONF2     | External interrupt port select register 2 | 0x00                |
| 0x00 50A9<br>to<br>0x00 50AF | Reserved area (7 byte)  |                |                                           |                     |
| 0x00 50B0                    | RST                     | RST_CR         | Reset control register                    | 0x00                |
| 0x00 50B1                    |                         | RST_SR         | Reset status register                     | 0x01                |
| 0x00 50B2                    | PWR                     | PWR_CSR1       | Power control and status register 1       | 0x00                |
| 0x00 50B3                    |                         | PWR_CSR2       | Power control and status register 2       | 0x00                |
| 0x00 50B4<br>to<br>0x00 50BF | Reserved area (12 byte) |                |                                           |                     |
| 0x00 50C0                    | CLK                     | CLK_CKDIVR     | Clock master divider register             | 0x03                |
| 0x00 50C1                    |                         | CLK_CRTCR      | Clock RTC register                        | 0x00 <sup>(1)</sup> |
| 0x00 50C2                    |                         | CLK_ICKCR      | Internal clock control register           | 0x11                |
| 0x00 50C3                    |                         | CLK_PCKENR1    | Peripheral clock gating register 1        | 0x00                |
| 0x00 50C4                    |                         | CLK_PCKENR2    | Peripheral clock gating register 2        | 0x00                |
| 0x00 50C5                    |                         | CLK_CCOR       | Configurable clock control register       | 0x00                |
| 0x00 50C6                    |                         | CLK_ECKCR      | External clock control register           | 0x00                |
| 0x00 50C7                    |                         | CLK_SCSR       | System clock status register              | 0x01                |
| 0x00 50C8                    |                         | CLK_SWR        | System clock switch register              | 0x01                |
| 0x00 50C9                    |                         | CLK_SWCR       | Clock switch control register             | 0xX0                |

Table 9. General hardware register map (continued)

| Address                      | Block                   | Register label         | Register name                           | Reset status |
|------------------------------|-------------------------|------------------------|-----------------------------------------|--------------|
| 0x00 50CA                    | CLK                     | CLK_CSSR               | Clock security system register          | 0x00         |
| 0x00 50CB                    |                         | CLK_CBEEPR             | Clock BEEP register                     | 0x00         |
| 0x00 50CC                    |                         | CLK_HSICALR            | HSI calibration register                | 0xXX         |
| 0x00 50CD                    |                         | CLK_HSITRIMR           | HSI clock calibration trimming register | 0x00         |
| 0x00 50CE                    |                         | CLK_HSIUNLCKR          | HSI unlock register                     | 0x00         |
| 0x00 50CF                    |                         | CLK_REGCSR             | Main regulator control status register  | 0bxx11 100X  |
| 0x00 50D0                    |                         | CLK_PCKENR3            | Peripheral clock gating register 3      | 0x00         |
| 0x00 50D1<br>to<br>0x00 50D2 | Reserved area (2 byte)  |                        |                                         |              |
| 0x00 50D3                    | WWDG                    | WWDG_CR                | WWDG control register                   | 0x7F         |
| 0x00 50D4                    |                         | WWDG_WR                | WWDG window register                    | 0x7F         |
| 0x00 50D5<br>to<br>00 50DF   | Reserved area (11 byte) |                        |                                         |              |
| 0x00 50E0                    | IWDG                    | IWDG_KR                | IWDG key register                       | 0xXX         |
| 0x00 50E1                    |                         | IWDG_PR                | IWDG prescaler register                 | 0x00         |
| 0x00 50E2                    |                         | IWDG_RLR               | IWDG reload register                    | 0xFF         |
| 0x00 50E3<br>to<br>0x00 50EF | Reserved area (13 byte) |                        |                                         |              |
| 0x00 50F0                    | BEEP                    | BEEP_CSR1              | BEEP control/status register 1          | 0x00         |
| 0x00 50F1<br>0x00 50F2       |                         | Reserved area (2 byte) |                                         |              |
| 0x00 50F3                    |                         | BEEP_CSR2              | BEEP control/status register 2          | 0x1F         |
| 0x00 50F4<br>to 0x00 513F    | Reserved area (76 byte) |                        |                                         |              |
| 0x00 5140                    | RTC                     | RTC_TR1                | Time register 1                         | 0x00         |
| 0x00 5141                    |                         | RTC_TR2                | Time register 2                         | 0x00         |
| 0x00 5142                    |                         | RTC_TR3                | Time register 3                         | 0x00         |
| 0x00 5143                    | Reserved area (1 byte)  |                        |                                         |              |
| 0x00 5144                    | RTC                     | RTC_DR1                | Date register 1                         | 0x01         |
| 0x00 5145                    |                         | RTC_DR2                | Date register 2                         | 0x21         |
| 0x00 5146                    |                         | RTC_DR3                | Date register 3                         | 0x00         |
| 0x00 5147                    | Reserved area (1 byte)  |                        |                                         |              |

Table 9. General hardware register map (continued)

| Address                   | Block                  | Register label         | Register name                        | Reset status        |
|---------------------------|------------------------|------------------------|--------------------------------------|---------------------|
| 0x00 5148                 | RTC                    | RTC_CR1                | Control register 1                   | 0x00 <sup>(1)</sup> |
| 0x00 5149                 |                        | RTC_CR2                | Control register 2                   | 0x00 <sup>(1)</sup> |
| 0x00 514A                 |                        | RTC_CR3                | Control register 3                   | 0x00 <sup>(1)</sup> |
| 0x00 514B                 |                        | Reserved area (1 byte) |                                      |                     |
| 0x00 514C                 |                        | RTC_ISR1               | Initialization and status register 1 | 0x01                |
| 0x00 514D                 |                        | RTC_ISR2               | Initialization and Status register 2 | 0x00                |
| 0x00 514E<br>0x00 514F    | Reserved area (2 byte) |                        |                                      |                     |
| 0x00 5150                 | RTC                    | RTC_SPRERH             | Synchronous prescaler register high  | 0x00 <sup>(1)</sup> |
| 0x00 5151                 |                        | RTC_SPRERL             | Synchronous prescaler register low   | 0xFF <sup>(1)</sup> |
| 0x00 5152                 |                        | RTC_APRER              | Asynchronous prescaler register      | 0x7F <sup>(1)</sup> |
| 0x00 5153                 | Reserved area (1 byte) |                        |                                      |                     |
| 0x00 5154                 | RTC                    | RTC_WUTRH              | Wakeup timer register high           | 0xFF <sup>(1)</sup> |
| 0x00 5155                 |                        | RTC_WUTRL              | Wakeup timer register low            | 0xFF <sup>(1)</sup> |
| 0x00 5156                 | Reserved area (1 byte) |                        |                                      |                     |
| 0x00 5157                 | RTC                    | RTC_SSRL               | Subsecond register low               | 0x00                |
| 0x00 5158                 |                        | RTC_SSRH               | Subsecond register high              | 0x00                |
| 0x00 5159                 |                        | RTC_WPR                | Write protection register            | 0x00                |
| 0x00 5158                 |                        | RTC_SSRH               | Subsecond register high              | 0x00                |
| 0x00 5159                 |                        | RTC_WPR                | Write protection register            | 0x00                |
| 0x00 515A                 |                        | RTC_SHIFTRH            | Shift register high                  | 0x00                |
| 0x00 515B                 |                        | RTC_SHIFTRL            | Shift register low                   | 0x00                |
| 0x00 515C                 |                        | RTC_ALRMAR1            | Alarm A register 1                   | 0x00 <sup>(1)</sup> |
| 0x00 515D                 |                        | RTC_ALRMAR2            | Alarm A register 2                   | 0x00 <sup>(1)</sup> |
| 0x00 515E                 |                        | RTC_ALRMAR3            | Alarm A register 3                   | 0x00 <sup>(1)</sup> |
| 0x00 515F                 |                        | RTC_ALRMAR4            | Alarm A register 4                   | 0x00 <sup>(1)</sup> |
| 0x00 5160 to<br>0x00 5163 | Reserved area (4 byte) |                        |                                      |                     |
| 0x00 5164                 | RTC                    | RTC_ALRMASRH           | Alarm A subsecond register high      | 0x00 <sup>(1)</sup> |
| 0x00 5165                 |                        | RTC_ALRMASRL           | Alarm A subsecond register low       | 0x00 <sup>(1)</sup> |
| 0x00 5166                 |                        | RTC_ALRMASMS<br>KR     | Alarm A masking register             | 0x00 <sup>(1)</sup> |
| 0x00 5167 to<br>0x00 5169 | Reserved area (3 byte) |                        |                                      |                     |

Table 9. General hardware register map (continued)

| Address                | Block                  | Register label | Register name                           | Reset status        |
|------------------------|------------------------|----------------|-----------------------------------------|---------------------|
| 0x00 516A              | RTC                    | RTC_CALRH      | Calibration register high               | 0x00 <sup>(1)</sup> |
| 0x00 516B              |                        | RTC_CALRL      | Calibration register low                | 0x00 <sup>(1)</sup> |
| 0x00 516C              |                        | RTC_TCR1       | Tamper control register 1               | 0x00 <sup>(1)</sup> |
| 0x00 516D              |                        | RTC_TCR2       | Tamper control register 2               | 0x00 <sup>(1)</sup> |
| 0x00 516E to 0x00 518A | Reserved area          |                |                                         |                     |
| 0x00 5190              | CSSLSE                 | CSSLSE_CSR     | CSS on LSE control and status register  | 0x00 <sup>(1)</sup> |
| 0x00 519A to 0x00 51FF | Reserved area          |                |                                         |                     |
| 0x00 5200              | SPI1                   | SPI1_CR1       | SPI1 control register 1                 | 0x00                |
| 0x00 5201              |                        | SPI1_CR2       | SPI1 control register 2                 | 0x00                |
| 0x00 5202              |                        | SPI1_ICR       | SPI1 interrupt control register         | 0x00                |
| 0x00 5203              |                        | SPI1_SR        | SPI1 status register                    | 0x02                |
| 0x00 5204              |                        | SPI1_DR        | SPI1 data register                      | 0x00                |
| 0x00 5205              |                        | SPI1_CRCPR     | SPI1 CRC polynomial register            | 0x07                |
| 0x00 5206              |                        | SPI1_RXCR      | SPI1 Rx CRC register                    | 0x00                |
| 0x00 5207              |                        | SPI1_TXCR      | SPI1 Tx CRC register                    | 0x00                |
| 0x00 5208 to 0x00 520F | Reserved area (8 byte) |                |                                         |                     |
| 0x00 5210              | I2C1                   | I2C1_CR1       | I2C1 control register 1                 | 0x00                |
| 0x00 5211              |                        | I2C1_CR2       | I2C1 control register 2                 | 0x00                |
| 0x00 5212              |                        | I2C1_FREQR     | I2C1 frequency register                 | 0x00                |
| 0x00 5213              |                        | I2C1_OARL      | I2C1 own address register low           | 0x00                |
| 0x00 5214              |                        | I2C1_OARH      | I2C1 own address register high          | 0x00                |
| 0x00 5215              |                        | I2C1_OARH      | I2C1 own address register for dual mode | 0x00                |
| 0x00 5216              |                        | I2C1_DR        | I2C1 data register                      | 0x00                |
| 0x00 5217              |                        | I2C1_SR1       | I2C1 status register 1                  | 0x00                |
| 0x00 5218              |                        | I2C1_SR2       | I2C1 status register 2                  | 0x00                |
| 0x00 5219              |                        | I2C1_SR3       | I2C1 status register 3                  | 0x0X                |
| 0x00 521A              |                        | I2C1_ITR       | I2C1 interrupt control register         | 0x00                |
| 0x00 521B              |                        | I2C1_CCRL      | I2C1 clock control register low         | 0x00                |
| 0x00 521C              |                        | I2C1_CCRH      | I2C1 clock control register high        | 0x00                |
| 0x00 521D              |                        | I2C1_TRISER    | I2C1 TRISE register                     | 0x02                |
| 0x00 521E              |                        | I2C1_PECR      | I2C1 packet error checking register     | 0x00                |

Table 9. General hardware register map (continued)

| Address                      | Block                   | Register label | Register name                          | Reset status |
|------------------------------|-------------------------|----------------|----------------------------------------|--------------|
| 0x00 521F<br>to<br>0x00 522F | Reserved area (17 byte) |                |                                        |              |
| 0x00 5230                    | USART1                  | USART1_SR      | USART1 status register                 | 0xC0         |
| 0x00 5231                    |                         | USART1_DR      | USART1 data register                   | 0xFF         |
| 0x00 5232                    |                         | USART1_BRR1    | USART1 baud rate register 1            | 0x00         |
| 0x00 5233                    |                         | USART1_BRR2    | USART1 baud rate register 2            | 0x00         |
| 0x00 5234                    |                         | USART1_CR1     | USART1 control register 1              | 0x00         |
| 0x00 5235                    |                         | USART1_CR2     | USART1 control register 2              | 0x00         |
| 0x00 5236                    |                         | USART1_CR3     | USART1 control register 3              | 0x00         |
| 0x00 5237                    |                         | USART1_CR4     | USART1 control register 4              | 0x00         |
| 0x00 5238                    |                         | USART1_CR5     | USART1 control register 5              | 0x00         |
| 0x00 5239                    |                         | USART1_GTR     | USART1 guard time register             | 0x00         |
| 0x00 523A                    |                         | USART1_PSCR    | USART1 prescaler register              | 0x00         |
| 0x00 523B<br>to<br>0x00 524F | Reserved area (21 byte) |                |                                        |              |
| 0x00 5250                    | TIM2                    | TIM2_CR1       | TIM2 control register 1                | 0x00         |
| 0x00 5251                    |                         | TIM2_CR2       | TIM2 control register 2                | 0x00         |
| 0x00 5252                    |                         | TIM2_SMCR      | TIM2 Slave mode control register       | 0x00         |
| 0x00 5253                    |                         | TIM2_ETR       | TIM2 external trigger register         | 0x00         |
| 0x00 5254                    |                         | TIM2_DER       | TIM2 DMA1 request enable register      | 0x00         |
| 0x00 5255                    |                         | TIM2_IER       | TIM2 interrupt enable register         | 0x00         |
| 0x00 5256                    |                         | TIM2_SR1       | TIM2 status register 1                 | 0x00         |
| 0x00 5257                    |                         | TIM2_SR2       | TIM2 status register 2                 | 0x00         |
| 0x00 5258                    |                         | TIM2_EGR       | TIM2 event generation register         | 0x00         |
| 0x00 5259                    |                         | TIM2_CCMR1     | TIM2 capture/compare mode register 1   | 0x00         |
| 0x00 525A                    |                         | TIM2_CCMR2     | TIM2 capture/compare mode register 2   | 0x00         |
| 0x00 525B                    |                         | TIM2_CCER1     | TIM2 capture/compare enable register 1 | 0x00         |
| 0x00 525C                    |                         | TIM2_CNTRH     | TIM2 counter high                      | 0x00         |
| 0x00 525D                    |                         | TIM2_CNTRL     | TIM2 counter low                       | 0x00         |
| 0x00 525E                    |                         | TIM2_PSCR      | TIM2 prescaler register                | 0x00         |
| 0x00 525F                    |                         | TIM2_ARRH      | TIM2 auto-reload register high         | 0xFF         |
| 0x00 5260                    |                         | TIM2_ARRL      | TIM2 auto-reload register low          | 0xFF         |
| 0x00 5261                    |                         | TIM2_CCR1H     | TIM2 capture/compare register 1 high   | 0x00         |



Table 9. General hardware register map (continued)

| Address                   | Block                   | Register label | Register name                          | Reset status |
|---------------------------|-------------------------|----------------|----------------------------------------|--------------|
| 0x00 5262                 | TIM2                    | TIM2_CCR1L     | TIM2 capture/compare register 1 low    | 0x00         |
| 0x00 5263                 |                         | TIM2_CCR2H     | TIM2 capture/compare register 2 high   | 0x00         |
| 0x00 5264                 |                         | TIM2_CCR2L     | TIM2 capture/compare register 2 low    | 0x00         |
| 0x00 5265                 |                         | TIM2_BKR       | TIM2 break register                    | 0x00         |
| 0x00 5266                 |                         | TIM2_OISR      | TIM2 output idle state register        | 0x00         |
| 0x00 5267 to<br>0x00 527F | Reserved area (25 byte) |                |                                        |              |
| 0x00 5280                 | TIM3                    | TIM3_CR1       | TIM3 control register 1                | 0x00         |
| 0x00 5281                 |                         | TIM3_CR2       | TIM3 control register 2                | 0x00         |
| 0x00 5282                 |                         | TIM3_SMCR      | TIM3 Slave mode control register       | 0x00         |
| 0x00 5283                 |                         | TIM3_ETR       | TIM3 external trigger register         | 0x00         |
| 0x00 5284                 |                         | TIM3_DER       | TIM3 DMA1 request enable register      | 0x00         |
| 0x00 5285                 |                         | TIM3_IER       | TIM3 interrupt enable register         | 0x00         |
| 0x00 5286                 |                         | TIM3_SR1       | TIM3 status register 1                 | 0x00         |
| 0x00 5287                 |                         | TIM3_SR2       | TIM3 status register 2                 | 0x00         |
| 0x00 5288                 |                         | TIM3_EGR       | TIM3 event generation register         | 0x00         |
| 0x00 5289                 |                         | TIM3_CCMR1     | TIM3 Capture/Compare mode register 1   | 0x00         |
| 0x00 528A                 |                         | TIM3_CCMR2     | TIM3 Capture/Compare mode register 2   | 0x00         |
| 0x00 528B                 |                         | TIM3_CCER1     | TIM3 Capture/Compare enable register 1 | 0x00         |
| 0x00 528C                 |                         | TIM3_CNTRH     | TIM3 counter high                      | 0x00         |
| 0x00 528D                 |                         | TIM3_CNTRL     | TIM3 counter low                       | 0x00         |
| 0x00 528E                 |                         | TIM3_PSCR      | TIM3 prescaler register                | 0x00         |
| 0x00 528F                 |                         | TIM3_ARRH      | TIM3 Auto-reload register high         | 0xFF         |
| 0x00 5290                 |                         | TIM3_ARRL      | TIM3 Auto-reload register low          | 0xFF         |
| 0x00 5291                 |                         | TIM3_CCR1H     | TIM3 Capture/Compare register 1 high   | 0x00         |
| 0x00 5292                 |                         | TIM3_CCR1L     | TIM3 Capture/Compare register 1 low    | 0x00         |
| 0x00 5293                 |                         | TIM3_CCR2H     | TIM3 Capture/Compare register 2 high   | 0x00         |
| 0x00 5294                 |                         | TIM3_CCR2L     | TIM3 Capture/Compare register 2 low    | 0x00         |
| 0x00 5295                 |                         | TIM3_BKR       | TIM3 break register                    | 0x00         |
| 0x00 5296                 |                         | TIM3_OISR      | TIM3 output idle state register        | 0x00         |
| 0x00 5297 to<br>0x00 52AF | Reserved area (25 byte) |                |                                        |              |

Table 9. General hardware register map (continued)

| Address   | Block | Register label | Register name                          | Reset status |
|-----------|-------|----------------|----------------------------------------|--------------|
| 0x00 52B0 | TIM1  | TIM1_CR1       | TIM1 control register 1                | 0x00         |
| 0x00 52B1 |       | TIM1_CR2       | TIM1 control register 2                | 0x00         |
| 0x00 52B2 |       | TIM1_SMCR      | TIM1 Slave mode control register       | 0x00         |
| 0x00 52B3 |       | TIM1_ETR       | TIM1 external trigger register         | 0x00         |
| 0x00 52B4 |       | TIM1_DER       | TIM1 DMA1 request enable register      | 0x00         |
| 0x00 52B5 |       | TIM1_IER       | TIM1 Interrupt enable register         | 0x00         |
| 0x00 52B6 |       | TIM1_SR1       | TIM1 status register 1                 | 0x00         |
| 0x00 52B7 |       | TIM1_SR2       | TIM1 status register 2                 | 0x00         |
| 0x00 52B8 |       | TIM1_EGR       | TIM1 event generation register         | 0x00         |
| 0x00 52B9 |       | TIM1_CCMR1     | TIM1 Capture/Compare mode register 1   | 0x00         |
| 0x00 52BA |       | TIM1_CCMR2     | TIM1 Capture/Compare mode register 2   | 0x00         |
| 0x00 52BB |       | TIM1_CCMR3     | TIM1 Capture/Compare mode register 3   | 0x00         |
| 0x00 52BC |       | TIM1_CCMR4     | TIM1 Capture/Compare mode register 4   | 0x00         |
| 0x00 52BD |       | TIM1_CCER1     | TIM1 Capture/Compare enable register 1 | 0x00         |
| 0x00 52BE |       | TIM1_CCER2     | TIM1 Capture/Compare enable register 2 | 0x00         |
| 0x00 52BF |       | TIM1_CNTRH     | TIM1 counter high                      | 0x00         |
| 0x00 52C0 |       | TIM1_CNTRL     | TIM1 counter low                       | 0x00         |
| 0x00 52C1 |       | TIM1_PSCRH     | TIM1 prescaler register high           | 0x00         |
| 0x00 52C2 |       | TIM1_PSCRL     | TIM1 prescaler register low            | 0x00         |
| 0x00 52C3 |       | TIM1_ARRH      | TIM1 Auto-reload register high         | 0xFF         |
| 0x00 52C4 |       | TIM1_ARRL      | TIM1 Auto-reload register low          | 0xFF         |
| 0x00 52C5 |       | TIM1_RCR       | TIM1 Repetition counter register       | 0x00         |
| 0x00 52C6 |       | TIM1_CCR1H     | TIM1 Capture/Compare register 1 high   | 0x00         |
| 0x00 52C7 |       | TIM1_CCR1L     | TIM1 Capture/Compare register 1 low    | 0x00         |
| 0x00 52C8 |       | TIM1_CCR2H     | TIM1 Capture/Compare register 2 high   | 0x00         |
| 0x00 52C9 |       | TIM1_CCR2L     | TIM1 Capture/Compare register 2 low    | 0x00         |
| 0x00 52CA |       | TIM1_CCR3H     | TIM1 Capture/Compare register 3 high   | 0x00         |
| 0x00 52CB |       | TIM1_CCR3L     | TIM1 Capture/Compare register 3 low    | 0x00         |
| 0x00 52CC |       | TIM1_CCR4H     | TIM1 Capture/Compare register 4 high   | 0x00         |
| 0x00 52CD |       | TIM1_CCR4L     | TIM1 Capture/Compare register 4 low    | 0x00         |
| 0x00 52CE |       | TIM1_BKR       | TIM1 break register                    | 0x00         |
| 0x00 52CF |       | TIM1_DTR       | TIM1 dead-time register                | 0x00         |
| 0x00 52D0 |       | TIM1_OISR      | TIM1 output idle state register        | 0x00         |
| 0x00 52D1 |       | TIM1_DCR1      | DMA1 control register 1                | 0x00         |

Table 9. General hardware register map (continued)

| Address                      | Block                   | Register label | Register name                          | Reset status |
|------------------------------|-------------------------|----------------|----------------------------------------|--------------|
| 0x00 52D2                    | TIM1                    | TIM1_DCR2      | TIM1 DMA1 control register 2           | 0x00         |
| 0x00 52D3                    |                         | TIM1_DMA1R     | TIM1 DMA1 address for burst mode       | 0x00         |
| 0x00 52D4<br>to<br>0x00 52DF | Reserved area (12 byte) |                |                                        |              |
| 0x00 52E0                    | TIM4                    | TIM4_CR1       | TIM4 control register 1                | 0x00         |
| 0x00 52E1                    |                         | TIM4_CR2       | TIM4 control register 2                | 0x00         |
| 0x00 52E2                    |                         | TIM4_SMCR      | TIM4 Slave mode control register       | 0x00         |
| 0x00 52E3                    |                         | TIM4_DER       | TIM4 DMA1 request enable register      | 0x00         |
| 0x00 52E4                    |                         | TIM4_IER       | TIM4 Interrupt enable register         | 0x00         |
| 0x00 52E5                    |                         | TIM4_SR1       | TIM4 status register 1                 | 0x00         |
| 0x00 52E6                    |                         | TIM4_EGR       | TIM4 Event generation register         | 0x00         |
| 0x00 52E7                    |                         | TIM4_CNTR      | TIM4 counter                           | 0x00         |
| 0x00 52E8                    |                         | TIM4_PSCR      | TIM4 prescaler register                | 0x00         |
| 0x00 52E9                    |                         | TIM4_ARR       | TIM4 Auto-reload register              | 0x00         |
| 0x00 52EA<br>to<br>0x00 52FE | Reserved area (21 byte) |                |                                        |              |
| 0x00 52FF                    | IRTIM                   | IR_CR          | Infrared control register              | 0x00         |
| 0x00 5300                    | TIM5                    | TIM5_CR1       | TIM5 control register 1                | 0x00         |
| 0x00 5301                    |                         | TIM5_CR2       | TIM5 control register 2                | 0x00         |
| 0x00 5302                    |                         | TIM5_SMCR      | TIM5 Slave mode control register       | 0x00         |
| 0x00 5303                    |                         | TIM5_ETR       | TIM5 external trigger register         | 0x00         |
| 0x00 5304                    |                         | TIM5_DER       | TIM5 DMA1 request enable register      | 0x00         |
| 0x00 5305                    |                         | TIM5_IER       | TIM5 interrupt enable register         | 0x00         |
| 0x00 5306                    |                         | TIM5_SR1       | TIM5 status register 1                 | 0x00         |
| 0x00 5307                    |                         | TIM5_SR2       | TIM5 status register 2                 | 0x00         |
| 0x00 5308                    |                         | TIM5_EGR       | TIM5 event generation register         | 0x00         |
| 0x00 5309                    |                         | TIM5_CCMR1     | TIM5 Capture/Compare mode register 1   | 0x00         |
| 0x00 530A                    |                         | TIM5_CCMR2     | TIM5 Capture/Compare mode register 2   | 0x00         |
| 0x00 530B                    |                         | TIM5_CCER1     | TIM5 Capture/Compare enable register 1 | 0x00         |
| 0x00 530C                    |                         | TIM5_CNTRH     | TIM5 counter high                      | 0x00         |
| 0x00 530D                    |                         | TIM5_CNTRL     | TIM5 counter low                       | 0x00         |
| 0x00 530E                    |                         | TIM5_PSCR      | TIM5 prescaler register                | 0x00         |
| 0x00 530F                    |                         | TIM5_ARRH      | TIM5 Auto-reload register high         | 0xFF         |

Table 9. General hardware register map (continued)

| Address                      | Block                   | Register label | Register name                        | Reset status |
|------------------------------|-------------------------|----------------|--------------------------------------|--------------|
| 0x00 5310                    | TIM5                    | TIM5_ARRL      | TIM5 Auto-reload register low        | 0xFF         |
| 0x00 5311                    |                         | TIM5_CCR1H     | TIM5 Capture/Compare register 1 high | 0x00         |
| 0x00 5312                    |                         | TIM5_CCR1L     | TIM5 Capture/Compare register 1 low  | 0x00         |
| 0x00 5313                    |                         | TIM5_CCR2H     | TIM5 Capture/Compare register 2 high | 0x00         |
| 0x00 5314                    |                         | TIM5_CCR2L     | TIM5 Capture/Compare register 2 low  | 0x00         |
| 0x00 5315                    |                         | TIM5_BKR       | TIM5 break register                  | 0x00         |
| 0x00 5316                    |                         | TIM5_OISR      | TIM5 output idle state register      | 0x00         |
| 0x00 5317<br>to<br>0x00 533F | Reserved area           |                |                                      |              |
| 0x00 5340                    | ADC1                    | ADC1_CR1       | ADC1 configuration register 1        | 0x00         |
| 0x00 5341                    |                         | ADC1_CR2       | ADC1 configuration register 2        | 0x00         |
| 0x00 5342                    |                         | ADC1_CR3       | ADC1 configuration register 3        | 0x1F         |
| 0x00 5343                    |                         | ADC1_SR        | ADC1 status register                 | 0x00         |
| 0x00 5344                    |                         | ADC1_DRH       | ADC1 data register high              | 0x00         |
| 0x00 5345                    |                         | ADC1_DRL       | ADC1 data register low               | 0x00         |
| 0x00 5346                    |                         | ADC1_HTRH      | ADC1 high threshold register high    | 0x0F         |
| 0x00 5347                    |                         | ADC1_HTRL      | ADC1 high threshold register low     | 0xFF         |
| 0x00 5348                    |                         | ADC1_LTRH      | ADC1 low threshold register high     | 0x00         |
| 0x00 5349                    |                         | ADC1_LTRL      | ADC1 low threshold register low      | 0x00         |
| 0x00 534A                    |                         | ADC1_SQR1      | ADC1 channel sequence 1 register     | 0x00         |
| 0x00 534B                    |                         | ADC1_SQR2      | ADC1 channel sequence 2 register     | 0x00         |
| 0x00 534C                    |                         | ADC1_SQR3      | ADC1 channel sequence 3 register     | 0x00         |
| 0x00 534D                    |                         | ADC1_SQR4      | ADC1 channel sequence 4 register     | 0x00         |
| 0x00 534E                    |                         | ADC1_TRIGR1    | ADC1 trigger disable 1               | 0x00         |
| 0x00 534F                    |                         | ADC1_TRIGR2    | ADC1 trigger disable 2               | 0x00         |
| 0x00 5350                    |                         | ADC1_TRIGR3    | ADC1 trigger disable 3               | 0x00         |
| 0x00 5351                    |                         | ADC1_TRIGR4    | ADC1 trigger disable 4               | 0x00         |
| 0x00 5352 to<br>0x00 537F    | Reserved area (46 byte) |                |                                      |              |
| 0x00 5380                    | DAC                     | DAC_CH1CR1     | DAC channel 1 control register 1     | 0x00         |
| 0x00 5381                    |                         | DAC_CH1CR2     | DAC channel 1 control register 2     | 0x00         |
| 0x00 5382                    |                         | DAC_CH2CR1     | DAC channel 2 control register 1     | 0x00         |
| 0x00 5383                    |                         | DAC_CH2CR2     | DAC channel 2 control register 2     | 0x00         |
| 0x00 5384                    |                         | DAC_SWTRIG     | DAC software trigger register        | 0x00         |
| 0x00 5385                    |                         | DAC_SR         | DAC status register                  | 0x00         |

Table 9. General hardware register map (continued)

| Address                | Block                  | Register label | Register name                                          | Reset status |
|------------------------|------------------------|----------------|--------------------------------------------------------|--------------|
| 0x00 5386 to 0x00 5387 | Reserved area (2 byte) |                |                                                        |              |
| 0x00 5388              | DAC                    | DAC_CH1RDHRH   | DAC channel 1 right aligned data holding register high | 0x00         |
| 0x00 5389              |                        | DAC_CH1RDHRL   | DAC channel 1 right aligned data holding register low  | 0x00         |
| 0x00 538A to 0x00 538B | Reserved area (2 byte) |                |                                                        |              |
| 0x00 538C              | DAC                    | DAC_CH1LDHRH   | DAC channel 1 left aligned data holding register high  | 0x00         |
| 0x00 538D              |                        | DAC_CH1LDHRL   | DAC channel 1 left aligned data holding register low   | 0x00         |
| 0x00 538E to 0x00 538F | Reserved area (2 byte) |                |                                                        |              |
| 0x00 5390              | DAC                    | DAC_CH1DHR8    | DAC channel 1 8-bit data holding register              | 0x00         |
| 0x00 5391 to 0x00 5393 | Reserved area (3 byte) |                |                                                        |              |
| 0x00 5394              | DAC                    | DAC_CH2RDHRH   | DAC channel 2 right aligned data holding register high | 0x00         |
| 0x00 5395              |                        | DAC_CH2RDHRL   | DAC channel 2 right aligned data holding register low  | 0x00         |
| 0x00 5396 to 0x00 5397 | Reserved area (2 byte) |                |                                                        |              |
| 0x00 5398              | DAC                    | DAC_CH2LDHRH   | DAC channel 2 left aligned data holding register high  | 0x00         |
| 0x00 5399              |                        | DAC_CH2LDHRL   | DAC channel 2 left aligned data holding register low   | 0x00         |
| 0x00 539A to 0x00 539B | Reserved area (2 byte) |                |                                                        |              |
| 0x00 539C              | DAC                    | DAC_CH2DHR8    | DAC channel 2 8-bit data holding register              | 0x00         |
| 0x00 539D to 0x00 539F | Reserved area (3 byte) |                |                                                        |              |
| 0x00 53A0              | DAC                    | DAC_DCH1RDHRH  | DAC channel 1 right aligned data holding register high | 0x00         |
| 0x00 53A1              |                        | DAC_DCH1RDHRL  | DAC channel 1 right aligned data holding register low  | 0x00         |
| 0x00 53A2 to 0x00 53AB | Reserved area (3 byte) |                |                                                        |              |

Table 9. General hardware register map (continued)

| Address                | Block                  | Register label             | Register name                                          | Reset status |
|------------------------|------------------------|----------------------------|--------------------------------------------------------|--------------|
| 0x00 53AC              | DAC                    | DAC_DORH                   | DAC data output register high                          | 0x00         |
| 0x00 53AD              |                        | DAC_DORL                   | DAC data output register low                           | 0x00         |
| 0x00 53A2              |                        | DAC_DCH2RDHRH              | DAC channel 2 right aligned data holding register high | 0x00         |
| 0x00 53A3              |                        | DAC_DCH2RDHRL              | DAC channel 2 right aligned data holding register low  | 0x00         |
| 0x00 53A4              |                        | DAC_DCH1LDHRH              | DAC channel 1 left aligned data holding register high  | 0x00         |
| 0x00 53A5              |                        | DAC_DCH1LDHRL              | DAC channel 1 left aligned data holding register low   | 0x00         |
| 0x00 53A6              |                        | DAC_DCH2LDHRH              | DAC channel 2 left aligned data holding register high  | 0x00         |
| 0x00 53A7              |                        | DAC_DCH2LDHRL              | DAC channel 2 left aligned data holding register low   | 0x00         |
| 0x00 53A8              |                        | DAC_DCH1DHR8               | DAC channel 1 8-bit mode data holding register         | 0x00         |
| 0x00 53A9              |                        | DAC_DCH2DHR8               | DAC channel 2 8-bit mode data holding register         | 0x00         |
| 0x00 53AA to 0x00 53AB | Reserved area (2 byte) |                            |                                                        |              |
| 0x00 53AC              | DAC                    | DAC_CH1DORH<br>Reset value | DAC channel 1 data output register high                | 0x00         |
| 0x00 53AD              |                        | DAC_CH1DORL<br>Reset value | DAC channel 1 data output register low                 | 0x00         |
| 0x00 53AE to 0x00 53AF | Reserved area (2 byte) |                            |                                                        |              |
| 0x00 53B0              | DAC                    | DAC_CH2DORH<br>Reset value | DAC channel 2 data output register high                | 0x00         |
| 0x00 53B1              |                        | DAC_CH2DORL<br>Reset value | DAC channel 2 data output register low                 | 0x00         |
| 0x00 53B2 to 0x00 53BF | Reserved area          |                            |                                                        |              |
| 0x00 53C0              | SPI2                   | SPI2_CR1                   | SPI2 control register 1                                | 0x00         |
| 0x00 53C1              |                        | SPI2_CR2                   | SPI2 control register 2                                | 0x00         |
| 0x00 53C2              |                        | SPI2_ICR                   | SPI2 interrupt control register                        | 0x00         |
| 0x00 53C3              |                        | SPI2_SR                    | SPI2 status register                                   | 0x02         |
| 0x00 53C4              |                        | SPI2_DR                    | SPI2 data register                                     | 0x00         |
| 0x00 53C5              |                        | SPI2_CRCPR                 | SPI2 CRC polynomial register                           | 0x07         |
| 0x00 53C6              |                        | SPI2_RXCR                  | SPI2 Rx CRC register                                   | 0x00         |
| 0x00 53C7              |                        | SPI2_TXCR                  | SPI2 Tx CRC register                                   | 0x00         |

Table 9. General hardware register map (continued)

| Address                | Block         | Register label | Register name               | Reset status |
|------------------------|---------------|----------------|-----------------------------|--------------|
| 0x00 53C8 to 0x00 53CF | Reserved area |                |                             |              |
| 0x00 53D0              | AES           | AES_CR         | AES control register        | 0x00         |
| 0x00 53D1              |               | AES_SR         | AES status register         | 0x00         |
| 0x00 53D2              |               | AES_DINR       | AES data input register     | 0x00         |
| 0x00 53D3              |               | AES_DOUTR      | AES data output register    | 0x00         |
| 0x00 53D4 to 0x00 53DF | Reserved area |                |                             |              |
| 0x00 53E0              | USART2        | USART2_SR      | USART2 status register      | 0xC0         |
| 0x00 53E1              |               | USART2_DR      | USART2 data register        | 0xFF         |
| 0x00 53E2              |               | USART2_BRR1    | USART2 baud rate register 1 | 0x00         |
| 0x00 53E3              |               | USART2_BRR2    | USART2 baud rate register 2 | 0x00         |
| 0x00 53E4              |               | USART2_CR1     | USART2 control register 1   | 0x00         |
| 0x00 53E5              |               | USART2_CR2     | USART2 control register 2   | 0x00         |
| 0x00 53E6              |               | USART2_CR3     | USART2 control register 3   | 0x00         |
| 0x00 53E7              |               | USART2_CR4     | USART2 control register 4   | 0x00         |
| 0x00 53E8              |               | USART2_CR5     | USART2 control register 5   | 0x00         |
| 0x00 53E9              |               | USART2_GTR     | USART2 guard time register  | 0x00         |
| 0x00 53EA              |               | USART2_PSCR    | USART2 prescaler register   | 0x00         |
| 0x00 53EB to 0x00 53EF | Reserved area |                |                             |              |
| 0x00 53F0              | USART3        | USART3_SR      | USART3 status register      | 0xC0         |
| 0x00 53F1              |               | USART3_DR      | USART3 data register        | 0xFF         |
| 0x00 53F2              |               | USART3_BRR1    | USART3 baud rate register 1 | 0x00         |
| 0x00 53F3              |               | USART3_BRR2    | USART3 baud rate register 2 | 0x00         |
| 0x00 53F4              |               | USART3_CR1     | USART3 control register 1   | 0x00         |
| 0x00 53F5              |               | USART3_CR2     | USART3 control register 2   | 0x00         |
| 0x00 53F6              |               | USART3_CR3     | USART3 control register 3   | 0x00         |
| 0x00 53F7              |               | USART3_CR4     | USART3 control register 4   | 0x00         |
| 0x00 53F8              |               | USART3_CR5     | USART3 control register 5   | 0x00         |
| 0x00 53F9              |               | USART3_GTR     | USART3 guard time register  | 0x00         |
| 0x00 53FA              |               | USART3_PSCR    | USART3 prescaler register   | 0x00         |
| 0x00 53FB to 0x00 53FF | Reserved area |                |                             |              |

Table 9. General hardware register map (continued)

| Address                   | Block                  | Register label | Register name                    | Reset status |
|---------------------------|------------------------|----------------|----------------------------------|--------------|
| 0x00 5400                 | LCD                    | LCD_CR1        | LCD control register 1           | 0x00         |
| 0x00 5401                 |                        | LCD_CR2        | LCD control register 2           | 0x00         |
| 0x00 5402                 |                        | LCD_CR3        | LCD control register 3           | 0x00         |
| 0x00 5403                 |                        | LCD_FRQ        | LCD frequency selection register | 0x00         |
| 0x00 5404                 |                        | LCD_PM0        | LCD Port mask register 0         | 0x00         |
| 0x00 5405                 |                        | LCD_PM1        | LCD Port mask register 1         | 0x00         |
| 0x00 5406                 |                        | LCD_PM2        | LCD Port mask register 2         | 0x00         |
| 0x00 5407                 |                        | LCD_PM3        | LCD Port mask register 3         | 0x00         |
| 0x00 5408                 |                        | LCD_PM4        | LCD Port mask register 4         | 0x00         |
| 0x00 5409                 |                        | LCD_PM5        | LCD Port mask register 5         | 0x00         |
| 0x00 540A to<br>0x00 540B | Reserved area (2 byte) |                |                                  |              |
| 0x00 540C                 | LCD                    | LCD_RAM0       | LCD display memory 0             | 0x00         |
| 0x00 540D                 |                        | LCD_RAM1       | LCD display memory 1             | 0x00         |
| 0x00 540E                 |                        | LCD_RAM2       | LCD display memory 2             | 0x00         |
| 0x00 540F                 |                        | LCD_RAM3       | LCD display memory 3             | 0x00         |
| 0x00 5410                 |                        | LCD_RAM4       | LCD display memory 4             | 0x00         |
| 0x00 5411                 |                        | LCD_RAM5       | LCD display memory 5             | 0x00         |
| 0x00 5412                 |                        | LCD_RAM6       | LCD display memory 6             | 0x00         |
| 0x00 5413                 |                        | LCD_RAM7       | LCD display memory 7             | 0x00         |
| 0x00 5414                 |                        | LCD_RAM8       | LCD display memory 8             | 0x00         |
| 0x00 5415                 |                        | LCD_RAM9       | LCD display memory 9             | 0x00         |
| 0x00 5416                 |                        | LCD_RAM10      | LCD display memory 10            | 0x00         |
| 0x00 5417                 |                        | LCD_RAM11      | LCD display memory 11            | 0x00         |
| 0x00 5418                 |                        | LCD_RAM12      | LCD display memory 12            | 0x00         |
| 0x00 5419                 |                        | LCD_RAM13      | LCD display memory 13            | 0x00         |
| 0x00 541A                 |                        | LCD_RAM14      | LCD display memory 14            | 0x00         |
| 0x00 541B                 |                        | LCD_RAM15      | LCD display memory 15            | 0x00         |
| 0x00 541C                 |                        | LCD_RAM16      | LCD display memory 16            | 0x00         |
| 0x00 541D                 |                        | LCD_RAM17      | LCD display memory 17            | 0x00         |
| 0x00 541E                 |                        | LCD_RAM18      | LCD display memory 18            | 0x00         |
| 0x00 541F                 |                        | LCD_RAM19      | LCD display memory 19            | 0x00         |
| 0x00 5420                 |                        | LCD_RAM20      | LCD display memory 20            | 0x00         |
| 0x00 5421                 |                        | LCD_RAM21      | LCD display memory 21            | 0x00         |



Table 9. General hardware register map (continued)

| Address                | Block           | Register label         | Register name                            | Reset status |
|------------------------|-----------------|------------------------|------------------------------------------|--------------|
| 0x00 5422 to 0x00 542E | Reserved area   |                        |                                          |              |
| 0x00 542F              | LCD             | LCD_CR4                | LCD control register 4                   | 0x00         |
| 0x00 5430              | RI              | Reserved area (1 byte) |                                          | 0x00         |
| 0x00 5431              |                 | RI_ICR1                | Timer input capture routing register 1   | 0x00         |
| 0x00 5432              |                 | RI_ICR2                | Timer input capture routing register 2   | 0x00         |
| 0x00 5433              |                 | RI_IOIR1               | I/O input register 1                     | 0xXX         |
| 0x00 5434              |                 | RI_IOIR2               | I/O input register 2                     | 0xXX         |
| 0x00 5435              |                 | RI_IOIR3               | I/O input register 3                     | 0xXX         |
| 0x00 5436              |                 | RI_IOCMR1              | I/O control mode register 1              | 0x00         |
| 0x00 5437              |                 | RI_IOCMR2              | I/O control mode register 2              | 0x00         |
| 0x00 5438              |                 | RI_IOCMR3              | I/O control mode register 3              | 0x00         |
| 0x00 5439              |                 | RI_IOSR1               | I/O switch register 1                    | 0x00         |
| 0x00 543A              |                 | RI_IOSR2               | I/O switch register 2                    | 0x00         |
| 0x00 543B              |                 | RI_IOSR3               | I/O switch register 3                    | 0x00         |
| 0x00 543C              |                 | RI_I OGCR              | I/O group control register               | 0x3F         |
| 0x00 543D              |                 | RI_ASCR1               | Analog switch register 1                 | 0x00         |
| 0x00 543E              |                 | RI_ASCR2               | Analog switch register 2                 | 0x00         |
| 0x00 543F              |                 | RI_RCR                 | Resistor control register 1              | 0x00         |
| 0x00 5440              | COMP1/<br>COMP2 | COMP_CSR1              | Comparator control and status register 1 | 0x00         |
| 0x00 5441              |                 | COMP_CSR2              | Comparator control and status register 2 | 0x00         |
| 0x00 5442              |                 | COMP_CSR3              | Comparator control and status register 3 | 0x00         |
| 0x00 5443              |                 | COMP_CSR4              | Comparator control and status register 4 | 0x00         |
| 0x00 5444              |                 | COMP_CSR5              | Comparator control and status register 5 | 0x00         |

1. These registers are not impacted by a system reset. They are reset at power-on.

Table 10. CPU/SWIM/debug module/interrupt controller registers

| Address                | Block                   | Register label | Register name                          | Reset status |
|------------------------|-------------------------|----------------|----------------------------------------|--------------|
| 0x00 7F00              | CPU <sup>(1)</sup>      | A              | Accumulator                            | 0x00         |
| 0x00 7F01              |                         | PCE            | Program counter extended               | 0x00         |
| 0x00 7F02              |                         | PCH            | Program counter high                   | 0x00         |
| 0x00 7F03              |                         | PCL            | Program counter low                    | 0x00         |
| 0x00 7F04              |                         | XH             | X index register high                  | 0x00         |
| 0x00 7F05              |                         | XL             | X index register low                   | 0x00         |
| 0x00 7F06              |                         | YH             | Y index register high                  | 0x00         |
| 0x00 7F07              |                         | YL             | Y index register low                   | 0x00         |
| 0x00 7F08              |                         | SPH            | Stack pointer high                     | 0x03         |
| 0x00 7F09              |                         | SPL            | Stack pointer low                      | 0xFF         |
| 0x00 7F0A              |                         | CCR            | Condition code register                | 0x28         |
| 0x00 7F0B to 0x00 7F5F | Reserved area (85 byte) |                |                                        |              |
| 0x00 7F60              | CPU                     | CFG_GCR        | Global configuration register          | 0x00         |
| 0x00 7F70              | ITC-SPR                 | ITC_SPR1       | Interrupt Software priority register 1 | 0xFF         |
| 0x00 7F71              |                         | ITC_SPR2       | Interrupt Software priority register 2 | 0xFF         |
| 0x00 7F72              |                         | ITC_SPR3       | Interrupt Software priority register 3 | 0xFF         |
| 0x00 7F73              |                         | ITC_SPR4       | Interrupt Software priority register 4 | 0xFF         |
| 0x00 7F74              |                         | ITC_SPR5       | Interrupt Software priority register 5 | 0xFF         |
| 0x00 7F75              |                         | ITC_SPR6       | Interrupt Software priority register 6 | 0xFF         |
| 0x00 7F76              |                         | ITC_SPR7       | Interrupt Software priority register 7 | 0xFF         |
| 0x00 7F77              |                         | ITC_SPR8       | Interrupt Software priority register 8 | 0xFF         |
| 0x00 7F78 to 0x00 7F79 | Reserved area (2 byte)  |                |                                        |              |
| 0x00 7F80              | SWIM                    | SWIM_CSR       | SWIM control status register           | 0x00         |
| 0x00 7F81 to 0x00 7F8F | Reserved area (15 byte) |                |                                        |              |

Table 10. CPU/SWIM/debug module/interrupt controller registers (continued)

| Address                      | Block                  | Register label | Register name                             | Reset status |
|------------------------------|------------------------|----------------|-------------------------------------------|--------------|
| 0x00 7F90                    | DM                     | DM_BK1RE       | DM breakpoint 1 register extended byte    | 0xFF         |
| 0x00 7F91                    |                        | DM_BK1RH       | DM breakpoint 1 register high byte        | 0xFF         |
| 0x00 7F92                    |                        | DM_BK1RL       | DM breakpoint 1 register low byte         | 0xFF         |
| 0x00 7F93                    |                        | DM_BK2RE       | DM breakpoint 2 register extended byte    | 0xFF         |
| 0x00 7F94                    |                        | DM_BK2RH       | DM breakpoint 2 register high byte        | 0xFF         |
| 0x00 7F95                    |                        | DM_BK2RL       | DM breakpoint 2 register low byte         | 0xFF         |
| 0x00 7F96                    |                        | DM_CR1         | DM Debug module control register 1        | 0x00         |
| 0x00 7F97                    |                        | DM_CR2         | DM Debug module control register 2        | 0x00         |
| 0x00 7F98                    |                        | DM_CSR1        | DM Debug module control/status register 1 | 0x10         |
| 0x00 7F99                    |                        | DM_CSR2        | DM Debug module control/status register 2 | 0x00         |
| 0x00 7F9A                    |                        | DM_ENFCTR      | DM enable function register               | 0xFF         |
| 0x00 7F9B<br>to<br>0x00 7F9F | Reserved area (5 byte) |                |                                           |              |

1. Accessible by debug module only

## 6 Interrupt vector mapping

*Note:* Slope control of all GPIO pins can be programmed except true open drain pins and by default is limited to 2 MHz.

**Table 11. Interrupt mapping**

| IRQ No. | Source block                | Description                                      | Wakeup from Halt mode | Wakeup from Active-halt mode | Wakeup from Wait (WFI mode) | Wakeup from Wait (WFE mode) <sup>(1)</sup> | Vector address |
|---------|-----------------------------|--------------------------------------------------|-----------------------|------------------------------|-----------------------------|--------------------------------------------|----------------|
|         | RESET                       | Reset                                            | Yes                   | Yes                          | Yes                         | Yes                                        | 0x00 8000      |
|         | TRAP                        | Software interrupt                               | -                     | -                            | -                           | -                                          | 0x00 8004      |
| 0       | TLI <sup>(2)</sup>          | External Top level Interrupt                     | -                     | -                            | -                           | -                                          | 0x00 8008      |
| 1       | FLASH                       | EOP/WR_PG_DIS                                    | -                     | -                            | Yes                         | Yes <sup>(3)</sup>                         | 0x00 800C      |
| 2       | DMA1 0/1                    | DMA1 channels 0/1                                | -                     | -                            | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8010      |
| 3       | DMA1 2/3                    | DMA1 channels 2/3                                | -                     | -                            | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8014      |
| 4       | RTC/LSE_CSS                 | RTC alarm interrupt/LSE CSS interrupt            | Yes                   | Yes                          | Yes                         | Yes                                        | 0x00 8018      |
| 5       | EXTI E/F/PVD <sup>(4)</sup> | PortE/F interrupt/PVD interrupt                  | Yes                   | Yes                          | Yes                         | Yes <sup>(3)</sup>                         | 0x00 801C      |
| 6       | EXTIB/G                     | External interrupt port B/G                      | Yes                   | Yes                          | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8020      |
| 7       | EXTID/H                     | External interrupt port D/H                      | Yes                   | Yes                          | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8024      |
| 8       | EXTI0                       | External interrupt 0                             | Yes                   | Yes                          | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8028      |
| 9       | EXTI1                       | External interrupt 1                             | Yes                   | Yes                          | Yes                         | Yes <sup>(3)</sup>                         | 0x00 802C      |
| 10      | EXTI2                       | External interrupt 2                             | Yes                   | Yes                          | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8030      |
| 11      | EXTI3                       | External interrupt 3                             | Yes                   | Yes                          | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8034      |
| 12      | EXTI4                       | External interrupt 4                             | Yes                   | Yes                          | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8038      |
| 13      | EXTI5                       | External interrupt 5                             | Yes                   | Yes                          | Yes                         | Yes <sup>(3)</sup>                         | 0x00 803C      |
| 14      | EXTI6                       | External interrupt 6                             | Yes                   | Yes                          | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8040      |
| 15      | EXTI7                       | External interrupt 7                             | Yes                   | Yes                          | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8044      |
| 16      | LCD/AES                     | LCD interrupt/AES interrupt                      | -                     | -                            | Yes                         | Yes                                        | 0x00 8048      |
| 17      | CLK/TIM1/DAC                | System clock switch/CSS interrupt/TIM1 break/DAC | -                     | -                            | Yes                         | Yes                                        | 0x00 804C      |
| 18      | COMP1/COMP2/ADC1            | Comparator 1 and 2 interrupt/ADC1                | Yes                   | Yes                          | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8050      |

Table 11. Interrupt mapping (continued)

| IRQ No. | Source block           | Description                                                                                                 | Wakeup from Halt mode | Wakeup from Active-halt mode | Wakeup from Wait (WFI mode) | Wakeup from Wait (WFE mode) <sup>(1)</sup> | Vector address |
|---------|------------------------|-------------------------------------------------------------------------------------------------------------|-----------------------|------------------------------|-----------------------------|--------------------------------------------|----------------|
| 19      | TIM2/ USART2           | TIM2 update /overflow/trigger/break/ USART2 transmission complete/transmit data register empty interrupt    | -                     | -                            | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8054      |
| 20      | TIM2/ USART2           | Capture/Compare/USART 2 interrupt                                                                           | -                     | -                            | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8058      |
| 21      | TIM3/ USART3           | TIM3 Update /Overflow/Trigger/Break/ USART3 transmission complete/transmit data register empty interrupt    | -                     | -                            | Yes                         | Yes <sup>(3)</sup>                         | 0x00 805C      |
| 22      | TIM3/ USART3           | TIM3 Capture/Compare/ USART3 Receive register data full/overflow/idle line detected/parity error/ interrupt | -                     | -                            | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8060      |
| 23      | TIM1                   | Update /overflow/trigger/ COM                                                                               | -                     | -                            | -                           | Yes <sup>(3)</sup>                         | 0x00 8064      |
| 24      | TIM1                   | Capture/Compare                                                                                             | -                     | -                            | -                           | Yes <sup>(3)</sup>                         | 0x00 8068      |
| 25      | TIM4                   | Update/overflow/trigger                                                                                     | -                     | -                            | Yes                         | Yes <sup>(3)</sup>                         | 0x00 806C      |
| 26      | SPI1                   | End of Transfer                                                                                             | Yes                   | Yes                          | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8070      |
| 27      | USART 1/ TIM5          | USART1 transmission complete/transmit data register empty/ TIM5 update/overflow/ trigger/break              | -                     | -                            | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8074      |
| 28      | USART 1/ TIM5          | USART1 Receive register data full/overflow/idle line detected/parity error/ TIM5 capture/compare            | -                     | -                            | Yes                         | Yes <sup>(3)</sup>                         | 0x00 8078      |
| 29      | I <sup>2</sup> C1/SPI2 | I <sup>2</sup> C1 interrupt <sup>(5)</sup> / SPI2                                                           | Yes                   | Yes                          | Yes                         | Yes <sup>(3)</sup>                         | 0x00 807C      |

1. The Low-power wait mode is entered when executing a WFE instruction in Low-power run mode.
2. The TLI interrupt is the logic OR between TIM2 overflow interrupt, and TIM4 overflow interrupts.
3. In WFE mode, this interrupt is served if it has been previously enabled. After processing the interrupt, the processor goes back to WFE mode. When this interrupt is configured as a wakeup event, the CPU wakes up and resumes processing.
4. The interrupt from PVD is logically OR-ed with Port E and F interrupts. Register EXTI\_CONF allows to select between Port E and Port F interrupt. See more details about the external interrupt port select register (EXTI\_CONF) in the STM8L051/L052 Value Line, STM8L151/L152, STM8L162, STM8AL31, STM8AL3L MCU lines reference manual (RM0031).
5. The device is woken up from Halt or Active-halt mode only when the address received matches the interface address.

## 7 Option byte

Option byte contain configurations for device hardware features as well as the memory protection of the device. They are stored in a dedicated memory block.

All option byte can be modified in ICP mode (with SWIM) by accessing the EEPROM address. See [Table 12](#) for details on option byte addresses.

The option byte can also be modified 'on the fly' by the application in IAP mode, except for the ROP, UBC and PCODESIZE values which are only taken into account when they are modified in ICP mode (with the SWIM).

Refer to the STM8AL31E8x/STM8AL3LE8x Flash programming manual (PM0054) and STM8 SWIM and Debug Manual (UM0470) for information on SWIM programming procedures.

**Table 12. Option byte addresses**

| Address | Option name                                                      | Option byte No. | Option bits |   |   |   |             |          |             |          | Factory default setting |
|---------|------------------------------------------------------------------|-----------------|-------------|---|---|---|-------------|----------|-------------|----------|-------------------------|
|         |                                                                  |                 | 7           | 6 | 5 | 4 | 3           | 2        | 1           | 0        |                         |
| 00 4800 | Read-out protection (ROP)                                        | OPT0            | ROP[7:0]    |   |   |   |             |          |             |          | 0xAA                    |
| 00 4802 | UBC (User Boot code size)                                        | OPT1            | UBC[7:0]    |   |   |   |             |          |             |          | 0x00                    |
| 00 4807 | PCODESIZE                                                        | OPT2            | PCODE[7:0]  |   |   |   |             |          |             |          | 0x00                    |
| 00 4808 | Independent watchdog option                                      | OPT3 [3:0]      | Reserved    |   |   |   | WWDG _HALT  | WWDG _HW | IWDG _HALT  | IWDG _HW | 0x00                    |
| 00 4809 | Number of stabilization clock cycles for HSE and LSE oscillators | OPT4            | Reserved    |   |   |   | LSECNT[1:0] |          | HSECNT[1:0] |          | 0x00                    |
| 00 480A | Brownout reset (BOR)                                             | OPT5 [3:0]      | Reserved    |   |   |   | BOR_TH      |          |             | BOR_ON   | 0x01                    |
| 00 480B | Bootloader option byte (OPTBL)                                   | OPTBL [15:0]    | OPTBL[15:0] |   |   |   |             |          |             |          | 0x00                    |
| 00 480C |                                                                  |                 |             |   |   |   |             |          |             |          | 0x00                    |

Table 13. Option byte description

| Option byte no. | Option description                                                                                                                                                                                                                                                                                                                                                                                                                                 |
|-----------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| OPT0            | <b>ROP[7:0]</b> Memory readout protection (ROP)<br>0xAA: Disable readout protection (write access via SWIM protocol)<br>Refer to Readout protection section in STM8L05xx, STM8L15xx, STM8L162x, STM8AL31xx and STM8AL3Lxx microcontroller family reference manual (RM0031).                                                                                                                                                                        |
| OPT1            | <b>UBC[7:0]</b> Size of the user boot code area<br>UBC[7:0] Size of the user boot code area<br>0x00: No UBC<br>0x01: Page 0 reserved for the UBC and write protected.<br>...<br>0xFF: Page 0 to 254 reserved for the UBC and write-protected.<br>Refer to User boot code section in the STM8L05xx, STM8L15xx, STM8L162x, STM8AL31xx and STM8AL3Lxx microcontroller family reference manual (RM0031).                                               |
| OPT2            | <b>PCODESIZE[7:0]</b> Size of the proprietary code area<br>0x00: No proprietary code area<br>0x01: Page 0 reserved for the proprietary code and read/write protected.<br>...<br>0xFF: Page 0 to 254 reserved for the proprietary code and read/write protected.<br>Refer to Proprietary code area (PCODE) section in STM8L05xx, STM8L15xx, STM8L162x, STM8AL31xx and STM8AL3Lxx microcontroller family reference manual (RM0031) for more details. |
| OPT3            | <b>IWDG_HW</b> : Independent watchdog<br>0: Independent watchdog activated by software<br>1: Independent watchdog activated by hardware                                                                                                                                                                                                                                                                                                            |
|                 | <b>IWDG_HALT</b> : Independent watchdog off in Halt/Active-halt<br>0: Independent watchdog continues running in Halt/Active-halt mode<br>1: Independent watchdog stopped in Halt/Active-halt mode                                                                                                                                                                                                                                                  |
|                 | <b>WWDG_HW</b> : Window watchdog<br>0: Window watchdog activated by software<br>1: Window watchdog activated by hardware                                                                                                                                                                                                                                                                                                                           |
|                 | <b>WWDG_HALT</b> : Window window watchdog reset on Halt/Active-halt<br>0: Window watchdog stopped in Halt mode<br>1: Window watchdog generates a reset when MCU enters Halt mode                                                                                                                                                                                                                                                                   |
| OPT4            | <b>HSECNT</b> : Number of HSE oscillator stabilization clock cycles<br>0x00 - 1 clock cycle<br>0x01 - 16 clock cycles<br>0x10 - 512 clock cycles<br>0x11 - 4096 clock cycles                                                                                                                                                                                                                                                                       |
|                 | <b>LSECNT</b> : Number of LSE oscillator stabilization clock cycles<br>0x00 - 1 clock cycle<br>0x01 - 16 clock cycles<br>0x10 - 512 clock cycles<br>0x11 - 4096 clock cycles                                                                                                                                                                                                                                                                       |

Table 13. Option byte description (continued)

| Option byte no. | Option description                                                                                                                                                                                                                                                                       |
|-----------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| OPT5            | <b>BOR_ON:</b><br>0: Brownout reset off<br>1: Brownout reset on                                                                                                                                                                                                                          |
|                 | <b>BOR_TH[3:1]:</b> Brownout reset thresholds. Refer to <a href="#">Table 20</a> for details on the thresholds according to the value of BOR_TH bits.                                                                                                                                    |
| OPTBL           | <b>OPTBL[15:0]:</b><br>This option is checked by the boot ROM code after reset. Depending on the content of addresses 00 480B, 00 480C and 0x8000 (reset vector) the CPU jumps to the bootloader or to the reset vector.<br>Refer to the UM0560 bootloader user manual for more details. |



## 8 Unique ID

STM8 devices feature a 96-bit unique device identifier which provides a reference number that is unique for any device and in any context. The 96 bits of the identifier are never altered by the user.

The unique device identifier is read in single byte and may then be concatenated using a custom algorithm.

The unique device identifier is ideally suited:

- For use as serial numbers
- For use as security keys to increase the code security in the program memory while using and combining this unique ID with software cryptographic primitives and protocols before programming the internal memory.
- To activate secure boot processes

**Table 14. Unique ID registers (96 bits)**

| Address | Content description        | Unique ID bits |   |   |   |   |   |   |   |
|---------|----------------------------|----------------|---|---|---|---|---|---|---|
|         |                            | 7              | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| 0x4926  | X co-ordinate on the wafer | U_ID[7:0]      |   |   |   |   |   |   |   |
| 0x4927  |                            | U_ID[15:8]     |   |   |   |   |   |   |   |
| 0x4928  | Y co-ordinate on the wafer | U_ID[23:16]    |   |   |   |   |   |   |   |
| 0x4929  |                            | U_ID[31:24]    |   |   |   |   |   |   |   |
| 0x492A  | Wafer number               | U_ID[39:32]    |   |   |   |   |   |   |   |
| 0x492B  | Lot number                 | U_ID[47:40]    |   |   |   |   |   |   |   |
| 0x492C  |                            | U_ID[55:48]    |   |   |   |   |   |   |   |
| 0x492D  |                            | U_ID[63:56]    |   |   |   |   |   |   |   |
| 0x492E  |                            | U_ID[71:64]    |   |   |   |   |   |   |   |
| 0x492F  |                            | U_ID[79:72]    |   |   |   |   |   |   |   |
| 0x4930  |                            | U_ID[87:80]    |   |   |   |   |   |   |   |
| 0x4931  |                            | U_ID[95:88]    |   |   |   |   |   |   |   |

## 9 Electrical parameters

### 9.1 Parameter conditions

Unless otherwise specified, all voltages are referred to  $V_{SS}$ .

#### 9.1.1 Minimum and maximum values

Unless otherwise specified the minimum and maximum values are guaranteed in the worst conditions of ambient temperature, supply voltage and frequencies by tests in production on 100% of the devices with an ambient temperature at  $T_A = 25\text{ }^{\circ}\text{C}$  and  $T_A = T_A \text{ max}$  (given by the selected temperature range).

Data based on characterization results, design simulation and/or technology characteristics are indicated in the table footnotes and are not tested in production.

#### 9.1.2 Typical values

Unless otherwise specified, typical data are based on  $T_A = 25\text{ }^{\circ}\text{C}$ ,  $V_{DD} = 3\text{ V}$ . They are given only as design guidelines and are not tested.

Typical ADC and DAC accuracy values are determined by characterization of a batch of samples from a standard diffusion lot over the full temperature range.

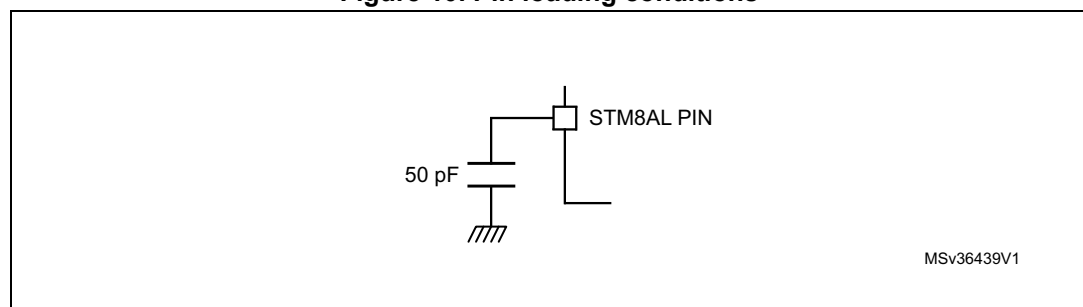
#### 9.1.3 Typical curves

Unless otherwise specified, all typical curves are given only as design guidelines and are not tested.

#### 9.1.4 Loading capacitor

The loading conditions used for pin parameter measurement are shown in [Figure 10](#).

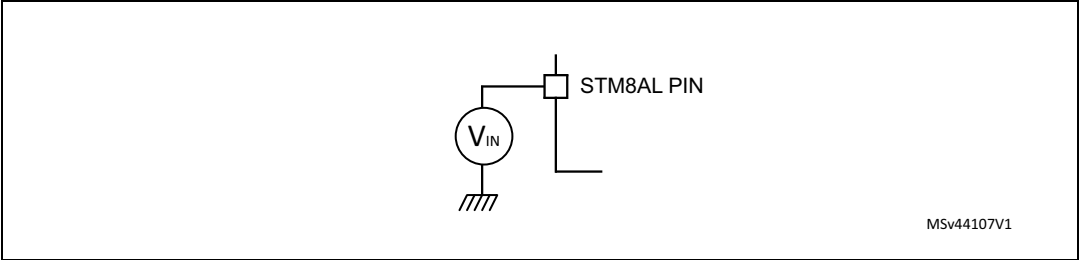
**Figure 10. Pin loading conditions**



### 9.1.5 Pin input voltage

The input voltage measurement on a pin of the device is described in [Figure 11](#).

Figure 11. Pin input voltage



## 9.2 Absolute maximum ratings

Stresses above the absolute maximum ratings listed in [Table 15: Voltage characteristics](#), [Table 16: Current characteristics](#) and [Table 17: Thermal characteristics](#) may cause permanent damage to the device. These are stress ratings only, and a functional operation of the device at these conditions is not implied. Exposure to maximum rating conditions for extended periods of time may affect the device's reliability.

The device's mission profile (application conditions) is compliant with the JEDEC JESD47 qualification standard, its extended mission profiles are available on demand.

Table 15. Voltage characteristics

| Symbol                  | Ratings                                                       | Min                                                                               | Max            | Unit |
|-------------------------|---------------------------------------------------------------|-----------------------------------------------------------------------------------|----------------|------|
| $V_{DD} - V_{SS}$       | External supply voltage (including $V_{DDA}$ ) <sup>(1)</sup> | - 0.3                                                                             | 4.0            | V    |
| $V_{IN}$ <sup>(2)</sup> | Input voltage on true open-drain pins (PC0 and PC1)           | $V_{SS} - 0.3$                                                                    | $V_{DD} + 4.0$ |      |
|                         | Input voltage on five-volt tolerant (FT) pins                 |                                                                                   | $V_{DD} + 4.0$ |      |
|                         | Input voltage on any other pin                                |                                                                                   | 4.0            |      |
| $V_{ESD}$               | Electrostatic discharge voltage                               | see <a href="#">Absolute maximum ratings (electrical sensitivity) on page 118</a> |                |      |

1. All power ( $V_{DD1}$ ,  $V_{DD2}$ ,  $V_{DD3}$ ,  $V_{DD4}$ ,  $V_{DDA}$ ) and ground ( $V_{SS1}$ ,  $V_{SS2}$ ,  $V_{SS3}$ ,  $V_{SS4}$ ,  $V_{SSA}$ ) pins must always be connected to the external power supply.

2.  $V_{IN}$  maximum must always be respected. Refer to [Table 16](#) for maximum allowed injected current values.

Table 16. Current characteristics

| Symbol                | Ratings                                                                  | Max.     | Unit |
|-----------------------|--------------------------------------------------------------------------|----------|------|
| $I_{VDD}$             | Total current into $V_{DD}$ power line (source)                          | 80       | mA   |
| $I_{VSS}$             | Total current out of $V_{SS}$ ground line (sink)                         | 80       |      |
| $I_{IO}$              | Output current sunk by IR_TIM pin (with high sink LED driver capability) | 80       |      |
|                       | Output current sunk by any other I/O and control pin                     | 25       |      |
|                       | Output current sourced by any I/Os and control pin                       | - 25     |      |
| $I_{INJ(PIN)}$        | Injected current on true open-drain pins (PC0 and PC1) <sup>(1)</sup>    | - 5 / +0 |      |
|                       | Injected current on five-volt tolerant (FT) pins <sup>(1)</sup>          | - 5 / +0 |      |
|                       | Injected current on any other pin <sup>(2)</sup>                         | - 5 / +5 |      |
| $\Sigma I_{INJ(PIN)}$ | Total injected current (sum of all I/O and control pins) <sup>(3)</sup>  | ± 25     |      |

1. Positive injection is not possible on these I/Os. A negative injection is induced by  $V_{IN} < V_{SS}$ .  $I_{INJ(PIN)}$  must never be exceeded. Refer to [Table 15](#) for maximum allowed input voltage values.
2. A positive injection is induced by  $V_{IN} > V_{DD}$  while a negative injection is induced by  $V_{IN} < V_{SS}$ .  $I_{INJ(PIN)}$  must never be exceeded. Refer to [Table 15](#) for maximum allowed input voltage values.
3. When several inputs are submitted to a current injection, the maximum  $\Sigma I_{INJ(PIN)}$  is the absolute sum of the positive and negative injected currents (instantaneous values).

Table 17. Thermal characteristics

| Symbol    | Ratings                      | Value       | Unit |
|-----------|------------------------------|-------------|------|
| $T_{STG}$ | Storage temperature range    | -65 to +150 | ° C  |
| $T_J$     | Maximum junction temperature | 150         |      |

Table 18. Operating lifetime (OLF)<sup>(1)</sup>

| Symbol | Ratings                | Value         | Unit    |
|--------|------------------------|---------------|---------|
| OLF    | Conforming to AEC-Q100 | -40 to 125 °C | Grade 1 |

1. For detailed mission profile analysis, please contact your local ST Sales Office.

## 9.3 Operating conditions

Subject to general operating conditions for  $V_{DD}$  and  $T_A$ .

### 9.3.1 General operating conditions

Table 19. General operating conditions

| Symbol             | Parameter                                                       | Conditions                                                    |                                           | Min.         | Max. | Unit |
|--------------------|-----------------------------------------------------------------|---------------------------------------------------------------|-------------------------------------------|--------------|------|------|
| $f_{SYSCLK}^{(1)}$ | System clock frequency                                          | $1.65\text{ V} \leq V_{DD} < 3.6\text{ V}$                    |                                           | 0            | 16   | MHz  |
| $V_{DD}$           | Standard operating voltage                                      | BOR detector enabled                                          |                                           | $1.65^{(2)}$ | 3.6  | V    |
| $V_{DDA}$          | Analog operating voltage                                        | ADC and DAC not used                                          | Must be at the same potential as $V_{DD}$ | $1.65^{(2)}$ | 3.6  | V    |
|                    |                                                                 | ADC or DAC used                                               |                                           | 1.8          | 3.6  | V    |
| $P_D^{(3)}$        | Power dissipation at $T_A = 85\text{ °C}$ for suffix A devices  | LQFP80                                                        | -                                         | -            | 288  | mW   |
|                    |                                                                 | LQFP64                                                        | -                                         | -            | 288  |      |
|                    |                                                                 | LQFP48                                                        | -                                         | -            | 288  |      |
|                    | Power dissipation at $T_A = 125\text{ °C}$ for suffix C devices | LQFP80                                                        | -                                         | -            | 131  |      |
|                    |                                                                 | LQFP64                                                        | -                                         | -            | 104  |      |
|                    |                                                                 | LQFP48                                                        | -                                         | -            | 77   |      |
| $T_A$              | Temperature range                                               | $1.65\text{ V} \leq V_{DD} < 3.6\text{ V}$ (A suffix version) | -                                         | -40          | 85   | °C   |
|                    |                                                                 | $1.65\text{ V} \leq V_{DD} < 3.6\text{ V}$ (C suffix version) | -                                         | -40          | 125  |      |
| $T_J$              | Junction temperature range                                      | $-40\text{ °C} \leq T_A < 85\text{ °C}$ (A suffix version)    |                                           | -40          | 105  |      |
|                    |                                                                 | $-40\text{ °C} \leq T_A < 125\text{ °C}$ (C suffix version)   |                                           | -40          | 130  |      |

1.  $f_{SYSCLK} = f_{CPU}$

2. 1.8 V at power-up, 1.65 V at power-down if BOR is disabled.

3. To calculate  $P_{Dmax}(T_A)$ , use the formula  $P_{Dmax} = (T_{Jmax} - T_A) / \Theta_{JA}$  with  $T_{Jmax}$  in this table and  $\Theta_{JA}$  in "Thermal characteristics" table.

### 9.3.2 Embedded reset and power control block characteristics

Table 20. Embedded reset and power control block characteristics

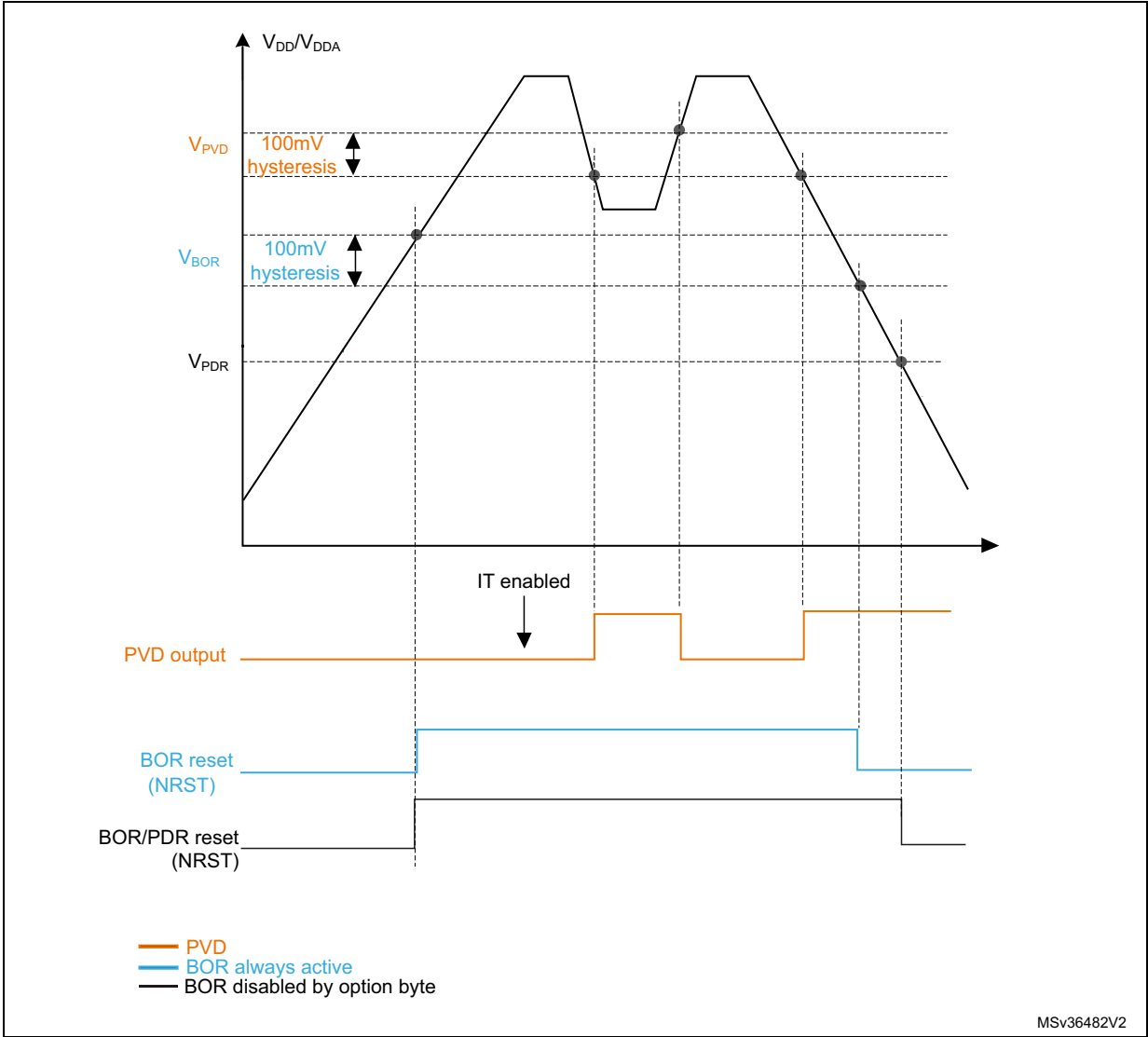
| Symbol     | Parameter                                        | Conditions                              | Min.                | Typ. | Max.                    | Unit            |
|------------|--------------------------------------------------|-----------------------------------------|---------------------|------|-------------------------|-----------------|
| $t_{VDD}$  | $V_{DD}$ rise time rate                          | BOR detector enabled                    | 0 <sup>(1)</sup>    | -    | $\infty$ <sup>(1)</sup> | $\mu\text{s/V}$ |
|            | $V_{DD}$ fall time rate                          | BOR detector enabled                    | 20 <sup>(1)</sup>   | -    | $\infty$ <sup>(1)</sup> | $\mu\text{s/V}$ |
| $t_{TEMP}$ | Reset release delay                              | $V_{DD}$ rising<br>BOR detector enabled | -                   | 3    | -                       | ms              |
| $V_{PDR}$  | Power-down reset threshold                       | Falling edge                            | 1.3                 | 1.5  | 1.65 <sup>(2)</sup>     | V               |
| $V_{BOR0}$ | Brown-out reset threshold 0<br>(BOR_TH[2:0]=000) | Falling edge                            | 1.67                | 1.7  | 1.74 <sup>(2)</sup>     |                 |
|            |                                                  | Rising edge                             | 1.69 <sup>(2)</sup> | 1.75 | 1.80                    |                 |
| $V_{BOR1}$ | Brown-out reset threshold 1<br>(BOR_TH[2:0]=001) | Falling edge                            | 1.87                | 1.93 | 1.97 <sup>(2)</sup>     |                 |
|            |                                                  | Rising edge                             | 1.96 <sup>(2)</sup> | 2.04 | 2.07                    |                 |
| $V_{BOR2}$ | Brown-out reset threshold 2<br>(BOR_TH[2:0]=010) | Falling edge                            | 2.22                | 2.3  | 2.35 <sup>(2)</sup>     |                 |
|            |                                                  | Rising edge                             | 2.31 <sup>(2)</sup> | 2.41 | 2.44                    |                 |
| $V_{BOR3}$ | Brown-out reset threshold 3<br>(BOR_TH[2:0]=011) | Falling edge                            | 2.45                | 2.55 | 2.60 <sup>(2)</sup>     |                 |
|            |                                                  | Rising edge                             | 2.54 <sup>(2)</sup> | 2.66 | 2.7                     |                 |
| $V_{BOR4}$ | Brown-out reset threshold 4<br>(BOR_TH[2:0]=100) | Falling edge                            | 2.68                | 2.80 | 2.85 <sup>(2)</sup>     |                 |
|            |                                                  | Rising edge                             | 2.78 <sup>(2)</sup> | 2.90 | 2.95                    |                 |
| $V_{PVD0}$ | PVD threshold 0                                  | Falling edge                            | 1.80                | 1.84 | 1.88 <sup>(2)</sup>     | V               |
|            |                                                  | Rising edge                             | 1.88 <sup>(2)</sup> | 1.94 | 1.99                    |                 |
| $V_{PVD1}$ | PVD threshold 1                                  | Falling edge                            | 1.98                | 2.04 | 2.09 <sup>(2)</sup>     |                 |
|            |                                                  | Rising edge                             | 2.08 <sup>(2)</sup> | 2.14 | 2.18                    |                 |
| $V_{PVD2}$ | PVD threshold 2                                  | Falling edge                            | 2.2                 | 2.24 | 2.28 <sup>(2)</sup>     |                 |
|            |                                                  | Rising edge                             | 2.28 <sup>(2)</sup> | 2.34 | 2.38                    |                 |
| $V_{PVD3}$ | PVD threshold 3                                  | Falling edge                            | 2.39                | 2.44 | 2.48 <sup>(2)</sup>     |                 |
|            |                                                  | Rising edge                             | 2.47 <sup>(2)</sup> | 2.54 | 2.58                    |                 |
| $V_{PVD4}$ | PVD threshold 4                                  | Falling edge                            | 2.57                | 2.64 | 2.69 <sup>(2)</sup>     |                 |
|            |                                                  | Rising edge                             | 2.68 <sup>(2)</sup> | 2.74 | 2.79                    |                 |
| $V_{PVD5}$ | PVD threshold 5                                  | Falling edge                            | 2.77                | 2.83 | 2.88 <sup>(2)</sup>     |                 |
|            |                                                  | Rising edge                             | 2.87 <sup>(2)</sup> | 2.94 | 2.99                    |                 |
| $V_{PVD6}$ | PVD threshold 6                                  | Falling edge                            | 2.97                | 3.05 | 3.09 <sup>(2)</sup>     |                 |
|            |                                                  | Rising edge                             | 3.08 <sup>(2)</sup> | 3.15 | 3.20                    |                 |

Table 20. Embedded reset and power control block characteristics (continued)

| Symbol | Parameter          | Conditions                                | Min. | Typ.               | Max. | Unit |
|--------|--------------------|-------------------------------------------|------|--------------------|------|------|
| Vhyst  | Hysteresis voltage | BOR0 threshold                            | -    | 40 <sup>(1)</sup>  | -    | mV   |
|        |                    | All BOR and PVD thresholds excepting BOR0 | -    | 100 <sup>(1)</sup> | -    |      |

- 1. Guaranteed by design.
- 2. Guaranteed by characterization results.

Figure 12. Power supply thresholds



### 9.3.3 Supply current characteristics

#### Total current consumption

The MCU is placed under the following conditions:

- All I/O pins in input mode with a static value at  $V_{DD}$  or  $V_{SS}$  (no load)
- All peripherals are disabled except if explicitly mentioned.

General conditions for  $V_{DD}$  apply,  $T_A = -40\text{ }^{\circ}\text{C}$  to  $125\text{ }^{\circ}\text{C}$ .

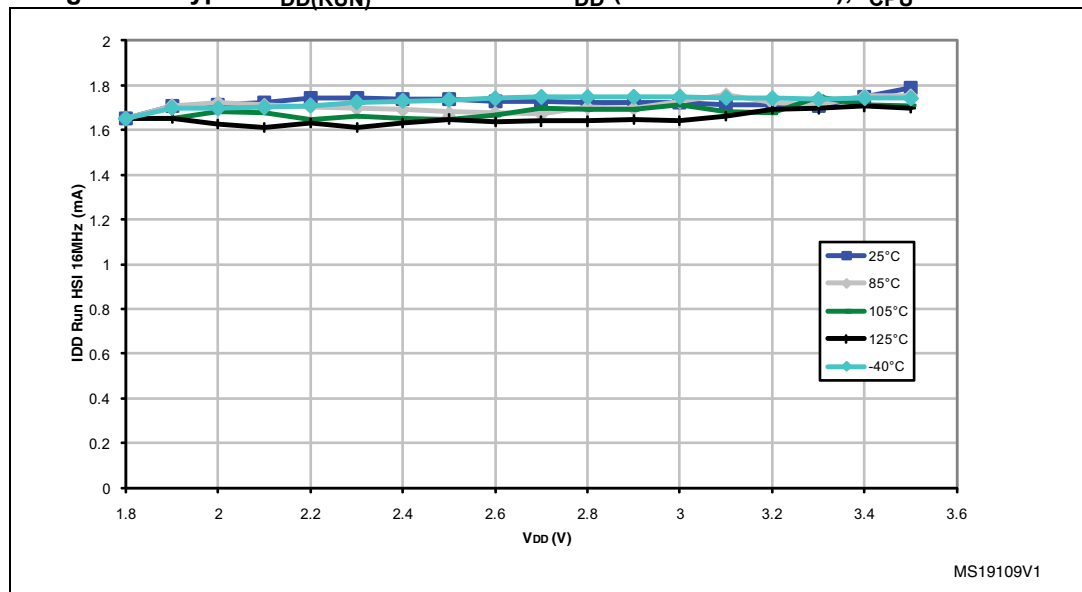
**Table 21. Total current consumption in Run mode**

| Symbol        | Parameter                                 | Conditions                                                                   |                                                         |                            | Typ. | Max.                | Unit          |
|---------------|-------------------------------------------|------------------------------------------------------------------------------|---------------------------------------------------------|----------------------------|------|---------------------|---------------|
| $I_{DD(RUN)}$ | Supply current in run mode <sup>(1)</sup> | All peripherals OFF, code executed from RAM, $V_{DD}$ from 1.65 V to 3.6 V   | HSI RC osc. (16 MHz) <sup>(2)</sup>                     | $f_{CPU} = 125\text{ kHz}$ | 0.40 | 0.55 <sup>(3)</sup> | mA            |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 1\text{ MHz}$   | 0.50 | 0.65 <sup>(3)</sup> |               |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 4\text{ MHz}$   | 0.75 | 1.00 <sup>(3)</sup> |               |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 8\text{ MHz}$   | 1.10 | 1.40 <sup>(3)</sup> |               |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 16\text{ MHz}$  | 1.85 | 2.35                |               |
|               |                                           |                                                                              | HSE external clock ( $f_{CPU}=f_{HSE}$ ) <sup>(4)</sup> | $f_{CPU} = 125\text{ kHz}$ | 0.07 | 0.20 <sup>(3)</sup> |               |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 1\text{ MHz}$   | 0.20 | 0.25 <sup>(3)</sup> |               |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 4\text{ MHz}$   | 0.55 | 0.75 <sup>(3)</sup> |               |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 8\text{ MHz}$   | 1.00 | 1.25 <sup>(3)</sup> |               |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 16\text{ MHz}$  | 1.90 | 2.30 <sup>(3)</sup> |               |
|               |                                           |                                                                              | LSI RC osc. (typ. 38 kHz)                               | $f_{CPU} = f_{LSI}$        | 40   | 50 <sup>(3)</sup>   | $\mu\text{A}$ |
|               |                                           |                                                                              | LSE external clock (32.768 kHz)                         | $f_{CPU} = f_{LSE}$        | 40   | 60 <sup>(3)</sup>   |               |
| $I_{DD(RUN)}$ | Supply current in Run mode                | All peripherals OFF, code executed from Flash, $V_{DD}$ from 1.65 V to 3.6 V | HSI RC osc. <sup>(5)</sup>                              | $f_{CPU} = 125\text{ kHz}$ | 0.45 | 0.60 <sup>(3)</sup> | mA            |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 1\text{ MHz}$   | 0.60 | 0.85 <sup>(3)</sup> |               |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 4\text{ MHz}$   | 1.10 | 1.45 <sup>(3)</sup> |               |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 8\text{ MHz}$   | 1.90 | 2.40 <sup>(3)</sup> |               |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 16\text{ MHz}$  | 3.80 | 4.90                |               |
|               |                                           |                                                                              | HSE external clock ( $f_{CPU}=f_{HSE}$ ) <sup>(4)</sup> | $f_{CPU} = 125\text{ kHz}$ | 0.30 | 0.45 <sup>(3)</sup> |               |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 1\text{ MHz}$   | 0.40 | 0.55 <sup>(3)</sup> |               |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 4\text{ MHz}$   | 1.15 | 1.50 <sup>(3)</sup> |               |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 8\text{ MHz}$   | 2.15 | 2.75 <sup>(3)</sup> |               |
|               |                                           |                                                                              |                                                         | $f_{CPU} = 16\text{ MHz}$  | 4.00 | 4.75 <sup>(3)</sup> |               |
|               |                                           |                                                                              | LSI RC osc.                                             | $f_{CPU} = f_{LSI}$        | 100  | 150 <sup>(3)</sup>  | $\mu\text{A}$ |
|               |                                           |                                                                              | LSE external clock (32.768 kHz) <sup>(6)</sup>          | $f_{CPU} = f_{LSE}$        | 100  | 120 <sup>(3)</sup>  |               |



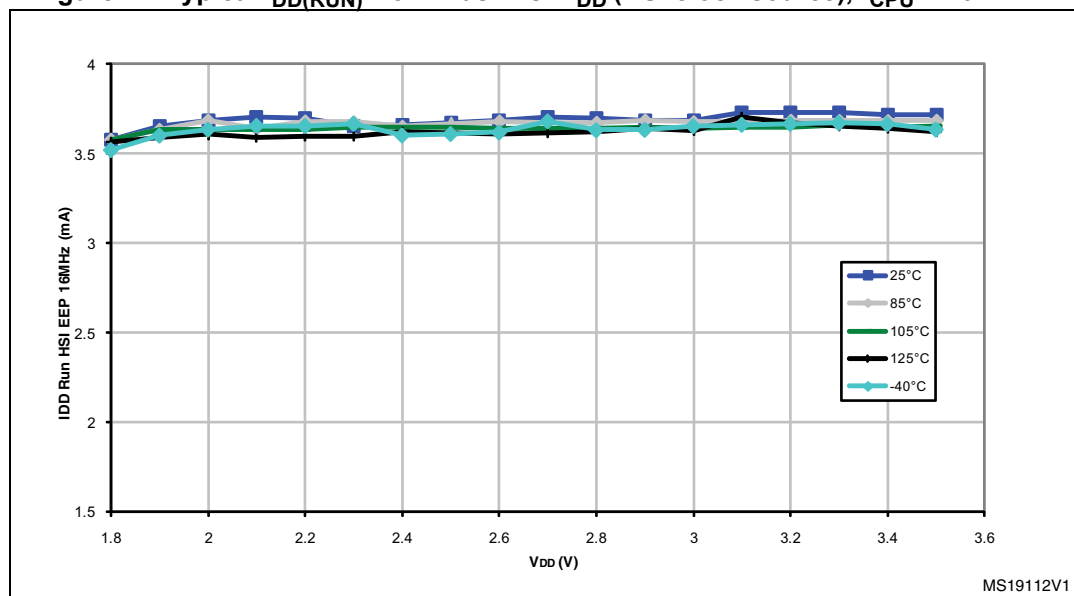
1. CPU executing typical data processing
2. The run from RAM consumption is approximated with the linear formula:  
 $I_{DD}(\text{run\_from\_RAM}) = \text{Freq.} \cdot 95 \mu\text{A/MHz} + 250 \mu\text{A}$
3. Guaranteed by characterization results.
4. Oscillator bypassed (HSEBYP = 1 in CLK\_ECKCR). When configured for external crystal, the HSE consumption ( $I_{DD \text{ HSE}}$ ) must be added. Refer to [Table 32](#).
5. The run from Flash consumption is approximated with the linear formula:  
 $I_{DD}(\text{run\_from\_Flash}) = \text{Freq.} \cdot 200 \mu\text{A/MHz} + 330 \mu\text{A}$
6. Oscillator bypassed (LSEBYP = 1 in CLK\_ECKCR). When configured for external crystal, the LSE consumption ( $I_{DD \text{ LSE}}$ ) must be added. Refer to [Table 33](#)

**Figure 13. Typical  $I_{DD}(\text{RUN})$  from RAM vs.  $V_{DD}$  (HSI clock source),  $f_{CPU} = 16 \text{ MHz}^{(1)}$**



1. Typical current consumption measured with code executed from RAM.

Figure 14. Typical  $I_{DD(RUN)}$  from Flash vs.  $V_{DD}$  (HSI clock source),  $f_{CPU} = 16\text{ MHz}^{(1)}$



1. Typical current consumption measured with code executed from Flash.

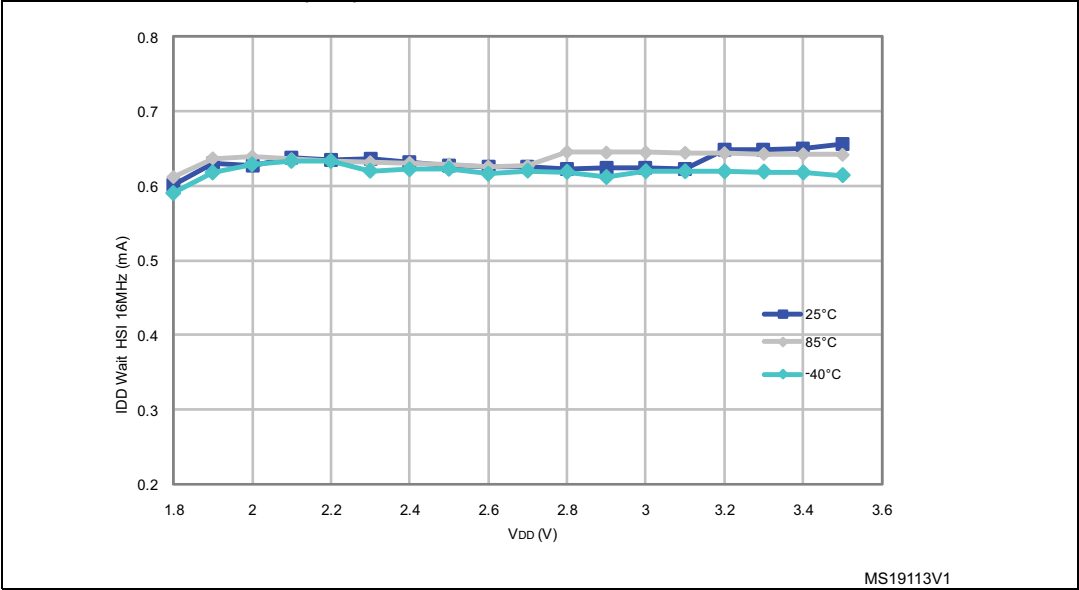
In the following table, data are based on characterization results, unless otherwise specified.

**Table 22. Total current consumption in Wait mode**

| Symbol         | Parameter                   | Conditions <sup>(1)</sup>                                                                                                               |                                                         |                             | Typ  | Max                 | Unit          |
|----------------|-----------------------------|-----------------------------------------------------------------------------------------------------------------------------------------|---------------------------------------------------------|-----------------------------|------|---------------------|---------------|
| $I_{DD(Wait)}$ | Supply current in Wait mode | CPU not clocked, all peripherals OFF, code executed from RAM with Flash in $I_{DDQ}$ mode, <sup>(2)</sup> $V_{DD}$ from 1.65 V to 3.6 V | HSI                                                     | $f_{CPU} = 125 \text{ kHz}$ | 0.35 | 0.45 <sup>(4)</sup> | mA            |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 1 \text{ MHz}$   | 0.35 | 0.50 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 4 \text{ MHz}$   | 0.40 | 0.60 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 8 \text{ MHz}$   | 0.50 | 0.60 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 16 \text{ MHz}$  | 0.70 | 0.85                |               |
|                |                             |                                                                                                                                         | HSE external clock ( $f_{CPU}=f_{HSE}$ ) <sup>(3)</sup> | $f_{CPU} = 125 \text{ kHz}$ | 0.05 | 0.10 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 1 \text{ MHz}$   | 0.10 | 0.20 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 4 \text{ MHz}$   | 0.20 | 0.40 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 8 \text{ MHz}$   | 0.40 | 0.65 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 16 \text{ MHz}$  | 0.76 | 1.15 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         | LSI                                                     | $f_{CPU} = f_{LSI}$         | 60   | 80 <sup>(4)</sup>   | $\mu\text{A}$ |
|                |                             |                                                                                                                                         | LSE <sup>(5)</sup> external clock (32.768 kHz)          | $f_{CPU} = f_{LSE}$         | 50   | 70 <sup>(4)</sup>   |               |
| $I_{DD(Wait)}$ | Supply current in Wait mode | CPU not clocked, all peripherals OFF, code executed from Flash, $V_{DD}$ from 1.65 V to 3.6 V                                           | HSI                                                     | $f_{CPU} = 125 \text{ kHz}$ | 0.38 | 0.55 <sup>(4)</sup> | mA            |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 1 \text{ MHz}$   | 0.40 | 0.60 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 4 \text{ MHz}$   | 0.50 | 0.65 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 8 \text{ MHz}$   | 0.60 | 0.75 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 16 \text{ MHz}$  | 0.80 | 0.90                |               |
|                |                             |                                                                                                                                         | HSE <sup>(3)</sup> external clock ( $f_{CPU}=HSE$ )     | $f_{CPU} = 125 \text{ kHz}$ | 0.07 | 0.15 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 1 \text{ MHz}$   | 0.10 | 0.20 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 4 \text{ MHz}$   | 0.25 | 0.45 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 8 \text{ MHz}$   | 0.50 | 0.65 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         |                                                         | $f_{CPU} = 16 \text{ MHz}$  | 1.00 | 1.20 <sup>(4)</sup> |               |
|                |                             |                                                                                                                                         | LSI                                                     | $f_{CPU} = f_{LSI}$         | 50   | 100 <sup>(4)</sup>  | $\mu\text{A}$ |
|                |                             |                                                                                                                                         | LSE <sup>(5)</sup> external clock (32.768 kHz)          | $f_{CPU} = f_{LSE}$         | 50   | 80 <sup>(4)</sup>   |               |

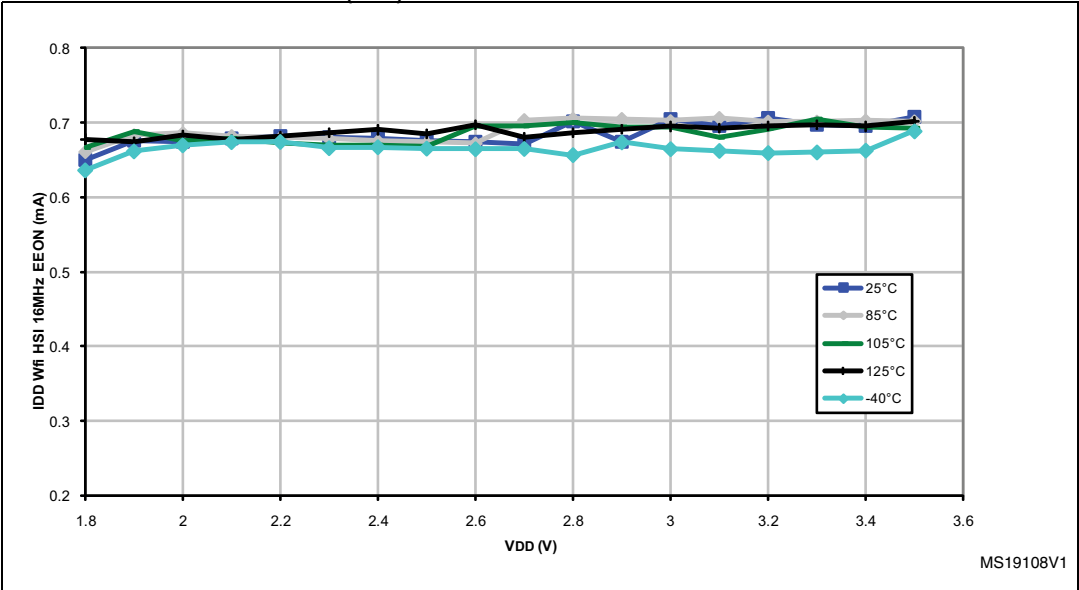
1. All peripherals OFF,  $V_{DD}$  from 1.65 V to 3.6 V, HSI internal RC osc.,  $f_{CPU} = f_{SYSCLK}$
2. Flash is configured in  $I_{DDQ}$  mode in Wait mode by setting the EPM or WAITM bit in the Flash\_CR1 register.
3. Oscillator bypassed (HSEBYP = 1 in CLK\_ECKCR). When configured for external crystal, the HSE consumption ( $I_{DD HSE}$ ) must be added. Refer to [Table 32](#).
4. Guaranteed by characterization results.
5. Oscillator bypassed (LSEBYP = 1 in CLK\_ECKCR). When configured for external crystal, the LSE consumption ( $I_{DD HSE}$ ) must be added. Refer to [Table 33](#)

**Figure 15. Typical  $I_{DD(Wait)}$  from RAM vs.  $V_{DD}$  (HSI clock source),  $f_{CPU} = 16\text{ MHz}^{(1)}$**



1. Typical current consumption measured with code executed from RAM.

**Figure 16. Typical  $I_{DD(Wait)}$  from Flash (HSI clock source),  $f_{CPU} = 16\text{ MHz}^{(1)}$**

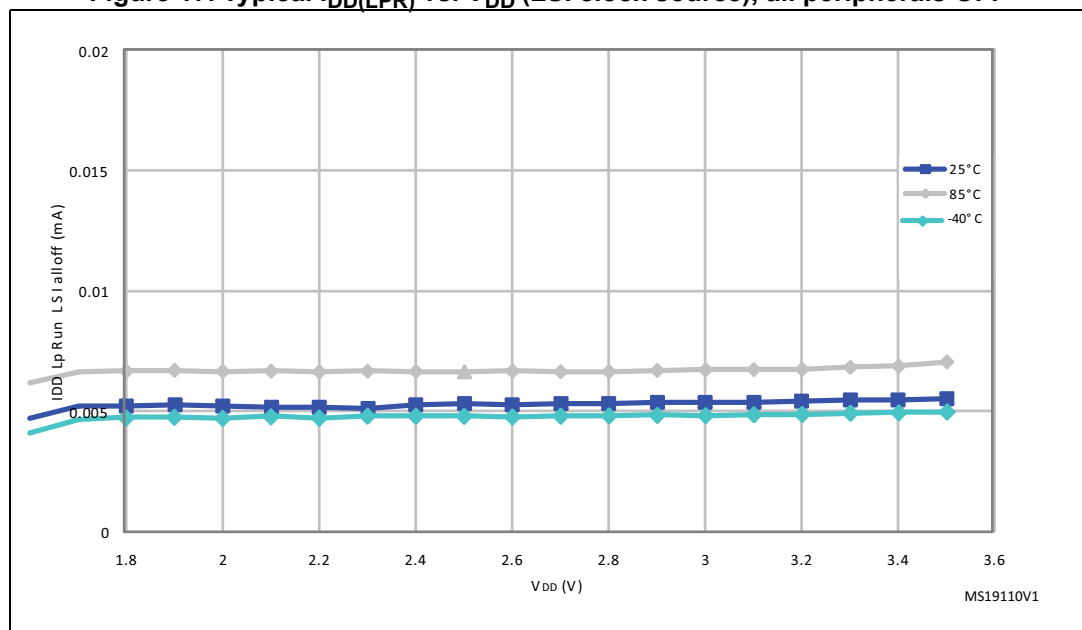


1. Typical current consumption measured with code executed from Flash.

**Table 23. Total current consumption and timing in low-power run mode at  $V_{DD} = 1.65\text{ V}$  to  $3.6\text{ V}$** 

| Symbol               | Parameter                            | Conditions <sup>(1)</sup>                         |                     |                                  | Typ.  | Max.                 | Unit |
|----------------------|--------------------------------------|---------------------------------------------------|---------------------|----------------------------------|-------|----------------------|------|
| I <sub>DD(LPR)</sub> | Supply current in low-power run mode | LSI RC osc.<br>(at 38 kHz)                        | all peripherals OFF | T <sub>A</sub> = -40 °C to 25 °C | 5.10  | 6.50 <sup>(2)</sup>  | μA   |
|                      |                                      |                                                   |                     | T <sub>A</sub> = 85 °C           | 6.80  | 11.00 <sup>(3)</sup> |      |
|                      |                                      |                                                   |                     | T <sub>A</sub> = 125 °C          | 13.40 | 20.00 <sup>(3)</sup> |      |
|                      |                                      | LSE <sup>(4)</sup> external clock<br>(32.768 kHz) |                     | T <sub>A</sub> = -40 °C to 25 °C | 5.25  | 5.60 <sup>(2)</sup>  |      |
|                      |                                      |                                                   |                     | T <sub>A</sub> = 85 °C           | 5.85  | 6.30 <sup>(2)</sup>  |      |
|                      |                                      |                                                   |                     | T <sub>A</sub> = 125 °C          | 14.00 | 16.50 <sup>(2)</sup> |      |

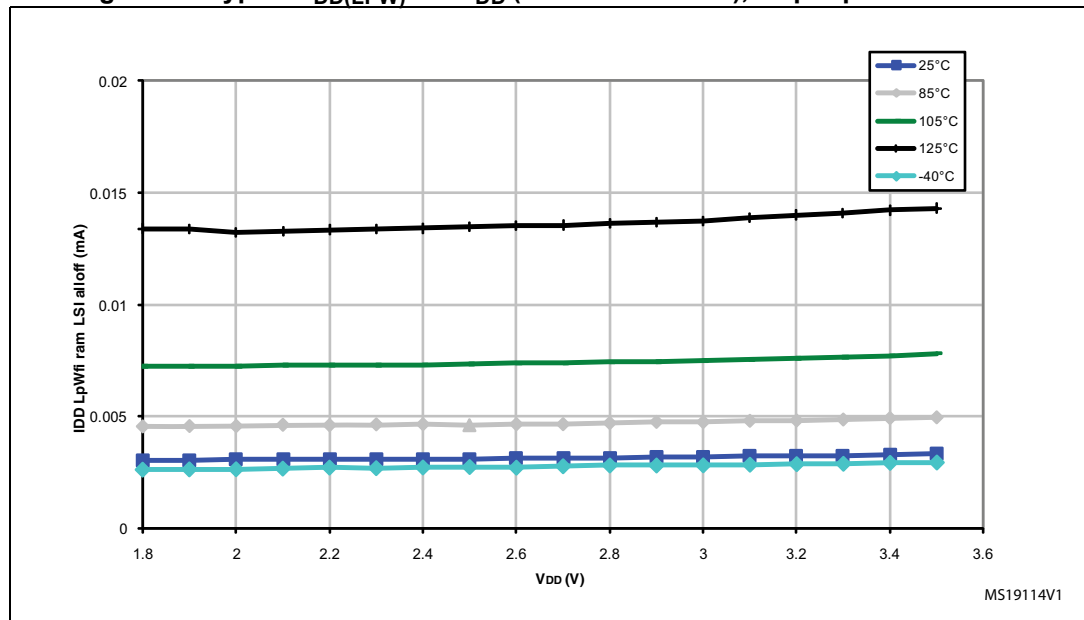
1. No floating I/Os
2. Guaranteed by characterization results.
3. Tested at  $85^{\circ}\text{C}$  for temperature range A or  $125^{\circ}\text{C}$  for temperature range C.
4. Oscillator bypassed (LSEBYP = 1 in CLK\_ECKCR). When configured for external crystal, the LSE consumption ( $I_{DD\text{ LSE}}$ ) must be added. Refer to [Table 33](#)

**Figure 17. Typical  $I_{DD(LPR)}$  vs.  $V_{DD}$  (LSI clock source), all peripherals OFF**

**Table 24. Total current consumption in low-power wait mode at  $V_{DD} = 1.65\text{ V}$  to  $3.6\text{ V}$** 

| Symbol               | Parameter                             | Conditions <sup>(1)</sup>                         |                     |                                  | Typ.  | Max.                 | Unit |
|----------------------|---------------------------------------|---------------------------------------------------|---------------------|----------------------------------|-------|----------------------|------|
| I <sub>DD(LPW)</sub> | Supply current in low-power wait mode | LSI RC osc.<br>(at 38 kHz)                        | all peripherals OFF | T <sub>A</sub> = -40 °C to 25 °C | 3.00  | 3.30 <sup>(2)</sup>  | μA   |
|                      |                                       |                                                   |                     | T <sub>A</sub> = 85 °C           | 4.40  | 9.00 <sup>(3)</sup>  |      |
|                      |                                       |                                                   |                     | T <sub>A</sub> = 125 °C          | 11.00 | 18.00 <sup>(3)</sup> |      |
|                      |                                       | LSE external clock <sup>(4)</sup><br>(32.768 kHz) |                     | T <sub>A</sub> = -40 °C to 25 °C | 2.35  | 2.70 <sup>(2)</sup>  |      |
|                      |                                       |                                                   |                     | T <sub>A</sub> = 85 °C           | 3.10  | 3.70 <sup>(2)</sup>  |      |
|                      |                                       |                                                   |                     | T <sub>A</sub> = 125 °C          | 12.0  | 14.0 <sup>(2)</sup>  |      |

1. No floating I/Os.
2. Guaranteed by characterization results.
3. Tested at  $85\text{ °C}$  for temperature range A or  $125\text{ °C}$  for temperature range C.
4. Oscillator bypassed (LSEBYP = 1 in CLK\_ECKCR). When configured for external crystal, the LSE consumption ( $I_{DD\text{ LSE}}$ ) must be added. Refer to [Table 33](#).

**Figure 18. Typical  $I_{DD(LPW)}$  vs.  $V_{DD}$  (LSI clock source), all peripherals OFF<sup>(1)</sup>**

1. Typical current consumption measured with code executed from RAM.

In the following table, data are based on characterization results, unless otherwise specified.

**Table 25. Total current consumption and timing in Active-halt mode  
at  $V_{DD} = 1.65\text{ V}$  to  $3.6\text{ V}$**

| Symbol          | Parameter                                                           | Conditions <sup>(1)</sup>                      |                                                         |                                         | Typ. | Max. <sup>(2)</sup> | Unit          |
|-----------------|---------------------------------------------------------------------|------------------------------------------------|---------------------------------------------------------|-----------------------------------------|------|---------------------|---------------|
| $I_{DD(AH)}$    | Supply current in Active-halt mode                                  | LSI RC (at 38 kHz)                             | LCD OFF <sup>(3)</sup>                                  | $T_A = -40\text{ °C}$ to $25\text{ °C}$ | 0.90 | 2.10                | $\mu\text{A}$ |
|                 |                                                                     |                                                |                                                         | $T_A = 85\text{ °C}$                    | 1.50 | 3.40                |               |
|                 |                                                                     |                                                |                                                         | $T_A = 125\text{ °C}$                   | 5.10 | 12.00               |               |
|                 |                                                                     |                                                | LCD ON (static duty/external $V_{LCD}$ ) <sup>(4)</sup> | $T_A = -40\text{ °C}$ to $25\text{ °C}$ | 1.40 | 3.10                |               |
|                 |                                                                     |                                                |                                                         | $T_A = 85\text{ °C}$                    | 1.90 | 4.30                |               |
|                 |                                                                     |                                                |                                                         | $T_A = 125\text{ °C}$                   | 5.50 | 13.00               |               |
|                 |                                                                     |                                                | LCD ON (1/4 duty/external $V_{LCD}$ ) <sup>(5)</sup>    | $T_A = -40\text{ °C}$ to $25\text{ °C}$ | 1.90 | 4.30                |               |
|                 |                                                                     |                                                |                                                         | $T_A = 85\text{ °C}$                    | 2.40 | 5.40                |               |
|                 |                                                                     |                                                |                                                         | $T_A = 125\text{ °C}$                   | 6.00 | 15.00               |               |
|                 |                                                                     |                                                | LCD ON (1/4 duty/internal $V_{LCD}$ ) <sup>(6)</sup>    | $T_A = -40\text{ °C}$ to $25\text{ °C}$ | 3.90 | 8.75                |               |
|                 |                                                                     |                                                |                                                         | $T_A = 85\text{ °C}$                    | 4.50 | 10.20               |               |
|                 |                                                                     |                                                |                                                         | $T_A = 125\text{ °C}$                   | 6.80 | 16.30               |               |
| $I_{DD(AH)}$    | Supply current in Active-halt mode                                  | LSE external clock (32.768 kHz) <sup>(7)</sup> | LCD OFF <sup>(8)</sup>                                  | $T_A = -40\text{ °C}$ to $25\text{ °C}$ | 0.50 | 1.20                | $\mu\text{A}$ |
|                 |                                                                     |                                                |                                                         | $T_A = 85\text{ °C}$                    | 0.90 | 2.10                |               |
|                 |                                                                     |                                                |                                                         | $T_A = 125\text{ °C}$                   | 4.80 | 11.00               |               |
|                 |                                                                     |                                                | LCD ON (static duty/external $V_{LCD}$ ) <sup>(4)</sup> | $T_A = -40\text{ °C}$ to $25\text{ °C}$ | 0.85 | 1.90                |               |
|                 |                                                                     |                                                |                                                         | $T_A = 85\text{ °C}$                    | 1.30 | 3.20                |               |
|                 |                                                                     |                                                |                                                         | $T_A = 125\text{ °C}$                   | 5.00 | 12.00               |               |
|                 |                                                                     |                                                | LCD ON (1/4 duty/external $V_{LCD}$ ) <sup>(5)</sup>    | $T_A = -40\text{ °C}$ to $25\text{ °C}$ | 1.50 | 2.50                |               |
|                 |                                                                     |                                                |                                                         | $T_A = 85\text{ °C}$                    | 1.80 | 4.20                |               |
|                 |                                                                     |                                                |                                                         | $T_A = 125\text{ °C}$                   | 5.70 | 14.00               |               |
|                 |                                                                     |                                                | LCD ON (1/4 duty/internal $V_{LCD}$ ) <sup>(6)</sup>    | $T_A = -40\text{ °C}$ to $25\text{ °C}$ | 3.40 | 7.60                |               |
|                 |                                                                     |                                                |                                                         | $T_A = 85\text{ °C}$                    | 3.90 | 9.20                |               |
|                 |                                                                     |                                                |                                                         | $T_A = 125\text{ °C}$                   | 6.30 | 15.20               |               |
| $I_{DD(WUFAH)}$ | Supply current during wakeup time from Active-halt mode (using HSI) | -                                              | -                                                       | -                                       | 2.40 | -                   | mA            |

**Table 25. Total current consumption and timing in Active-halt mode at  $V_{DD} = 1.65\text{ V}$  to  $3.6\text{ V}$  (continued)**

| Symbol                      | Parameter                                                 | Conditions <sup>(1)</sup> |   |   | Typ.  | Max. <sup>(2)</sup> | Unit          |
|-----------------------------|-----------------------------------------------------------|---------------------------|---|---|-------|---------------------|---------------|
| $t_{WU\_HSI(AH)}^{(9)(10)}$ | Wakeup time from Active-halt mode to Run mode (using HSI) | -                         | - | - | 4.70  | 7.00                | $\mu\text{s}$ |
| $t_{WU\_LSI(AH)}^{(9)(10)}$ | Wakeup time from Active-halt mode to Run mode (using LSI) | -                         | - | - | 150.0 | -                   | $\mu\text{s}$ |

1. No floating I/O, unless otherwise specified.
2. Guaranteed by characterization results.
3. RTC enabled. Clock source = LSI
4. RTC enabled, LCD enabled with external  $V_{LCD} = 3\text{ V}$ , static duty, division ratio = 256, all pixels active, no LCD connected.
5. RTC enabled, LCD enabled with external  $V_{LCD}$ , 1/4 duty, 1/3 bias, division ratio = 64, all pixels active, no LCD connected.
6. LCD enabled with internal LCD booster  $V_{LCD} = 3\text{ V}$ , 1/4 duty, 1/3 bias, division ratio = 64, all pixels active, no LCD connected.
7. Oscillator bypassed (LSEBYP = 1 in CLK\_ECKCR). When configured for external crystal, the LSE consumption ( $I_{DD\ LSE}$ ) must be added. Refer to [Table 33](#)
8. RTC enabled. Clock source = LSE
9. Wakeup time until start of interrupt vector fetch.  
The first word of interrupt routine is fetched 4 CPU cycles after  $t_{WU}$ .
10. ULP=0 or ULP=1 and FWU=1 in the PWR\_CSR2 register.

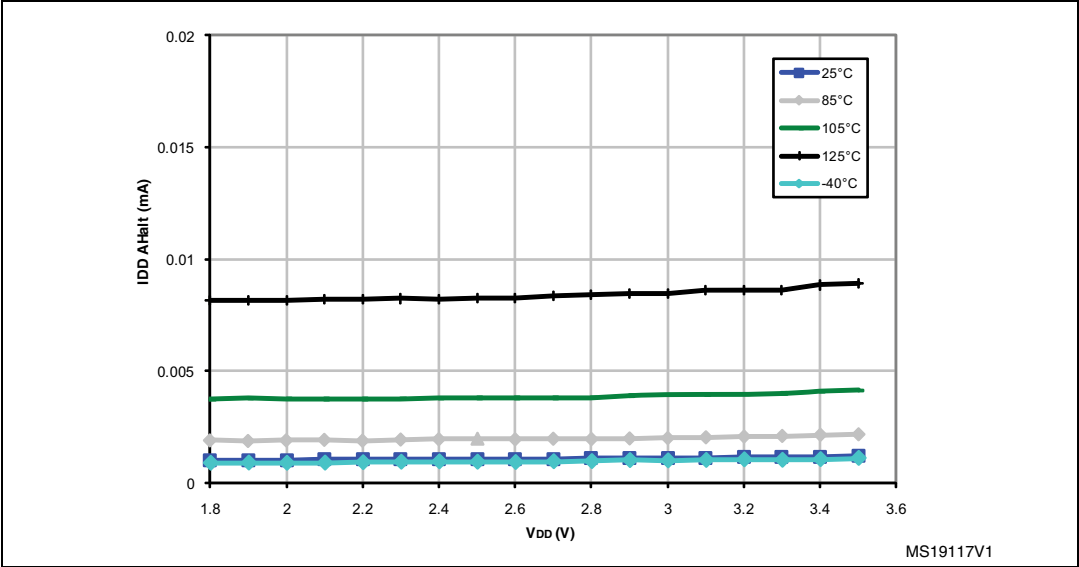
**Table 26. Typical current consumption in Active-halt mode, RTC clocked by LSE external crystal**

| Symbol             | Parameter                          | Condition <sup>(1)</sup> |                       | Typ. | Unit          |
|--------------------|------------------------------------|--------------------------|-----------------------|------|---------------|
| $I_{DD(AH)}^{(2)}$ | Supply current in Active-halt mode | $V_{DD} = 1.8\text{ V}$  | LSE                   | 1.15 | $\mu\text{A}$ |
|                    |                                    |                          | LSE/32 <sup>(3)</sup> | 1.05 |               |
|                    |                                    | $V_{DD} = 3\text{ V}$    | LSE                   | 1.30 |               |
|                    |                                    |                          | LSE/32 <sup>(3)</sup> | 1.20 |               |
|                    |                                    | $V_{DD} = 3.6\text{ V}$  | LSE                   | 1.45 |               |
|                    |                                    |                          | LSE/32 <sup>(3)</sup> | 1.35 |               |

1. No floating I/O, unless otherwise specified.
2. Based on measurements on bench with 32.768 kHz external crystal oscillator.
3. RTC clock is LSE divided by 32.



Figure 19. Typical  $I_{DD(AH)}$  vs.  $V_{DD}$  (LSI clock source)



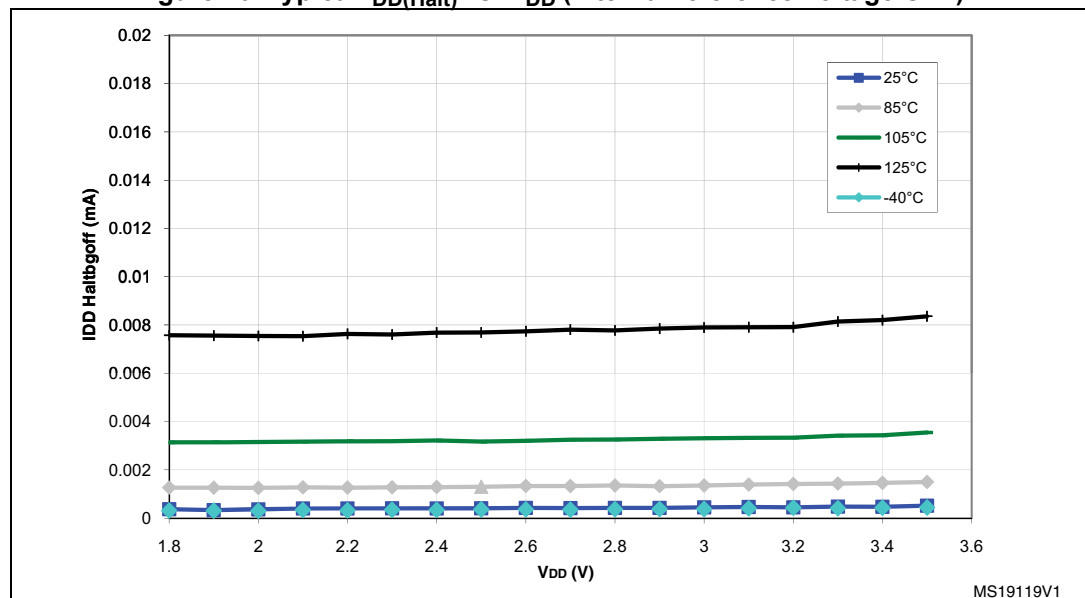
In the following table, data are based on characterization results, unless otherwise specified.

**Table 27. Total current consumption and timing in Halt mode at  $V_{DD} = 1.65$  to  $3.6$  V**

| Symbol                                | Parameter                                                                         | Condition <sup>(1)</sup>                                            | Typ. | Max.               | Unit          |
|---------------------------------------|-----------------------------------------------------------------------------------|---------------------------------------------------------------------|------|--------------------|---------------|
| $I_{DD(Halt)}$                        | Supply current in Halt mode (ultra-low-power ULP bit =1 in the PWR_CSR2 register) | $T_A = -40\text{ }^{\circ}\text{C}$ to $25\text{ }^{\circ}\text{C}$ | 0.4  | 0.9 <sup>(2)</sup> | $\mu\text{A}$ |
|                                       |                                                                                   | $T_A = 85\text{ }^{\circ}\text{C}$                                  | 0.9  | 2.8 <sup>(3)</sup> |               |
|                                       |                                                                                   | $T_A = 125\text{ }^{\circ}\text{C}$                                 | 4.4  | 13 <sup>(3)</sup>  |               |
| $I_{DD(WUHalt)}$                      | Supply current during wakeup time from Halt mode (using HSI)                      | -                                                                   | 2.4  | -                  | mA            |
| $t_{WU\_HSI(Halt)}$ <sup>(4)(5)</sup> | Wakeup time from Halt to Run mode (using HSI)                                     | -                                                                   | 4.7  | 7 <sup>(2)</sup>   | $\mu\text{s}$ |
| $t_{WU\_LSI(Halt)}$ <sup>(4)(5)</sup> | Wakeup time from Halt mode to Run mode (using LSI)                                | -                                                                   | 150  | -                  |               |

1.  $T_A = -40$  to  $125\text{ }^{\circ}\text{C}$ , no floating I/O, unless otherwise specified.
2. Guaranteed by characterization results.
3. Tested at  $85\text{ }^{\circ}\text{C}$  for temperature range A or  $125\text{ }^{\circ}\text{C}$  for temperature range C.
4. ULP=0 or ULP=1 and FWU=1 in the PWR\_CSR2 register.
5. Wakeup time until start of interrupt vector fetch. The first word of interrupt routine is fetched 4 CPU cycles after  $t_{WU}$ .

**Figure 20. Typical  $I_{DD(Halt)}$  vs.  $V_{DD}$  (internal reference voltage OFF)**



## Current consumption of on-chip peripherals

Table 28. Peripheral current consumption

| Symbol           | Parameter                                       | Typ.<br>$V_{DD} = 3.0\text{ V}$ | Unit              |
|------------------|-------------------------------------------------|---------------------------------|-------------------|
| $I_{DD}(TIM1)$   | TIM1 supply current <sup>(1)</sup>              | 10                              | $\mu\text{A/MHz}$ |
| $I_{DD}(TIM2)$   | TIM2 supply current <sup>(1)</sup>              | 7                               |                   |
| $I_{DD}(TIM3)$   | TIM3 supply current <sup>(1)</sup>              | 7                               |                   |
| $I_{DD}(TIM5)$   | TIM5 supply current <sup>(1)</sup>              | 7                               |                   |
| $I_{DD}(TIM4)$   | TIM4 timer supply current <sup>(1)</sup>        | 3                               |                   |
| $I_{DD}(USART1)$ | USART1 supply current <sup>(2)</sup>            | 5                               |                   |
| $I_{DD}(USART2)$ | USART2 supply current <sup>(2)</sup>            | 5                               |                   |
| $I_{DD}(USART3)$ | USART3 supply current <sup>(2)</sup>            | 5                               |                   |
| $I_{DD}(SPI1)$   | SPI1 supply current <sup>(2)</sup>              | 3                               |                   |
| $I_{DD}(SPI2)$   | SPI2 supply current <sup>(2)</sup>              | 3                               |                   |
| $I_{DD}(I2C1)$   | I <sup>2</sup> C1 supply current <sup>(2)</sup> | 4                               |                   |
| $I_{DD}(DMA1)$   | DMA1 supply current <sup>(2)</sup>              | 3                               |                   |
| $I_{DD}(WWDG)$   | WWDG supply current <sup>(2)</sup>              | 1                               |                   |
| $I_{DD}(ALL)$    | Peripherals ON <sup>(3)</sup>                   | 63                              |                   |

Table 28. Peripheral current consumption (continued)

| Symbol                    | Parameter                                                                     |                              | Typ.<br>V <sub>DD</sub> = 3.0 V | Unit   |
|---------------------------|-------------------------------------------------------------------------------|------------------------------|---------------------------------|--------|
| I <sub>DD</sub> (TIM1)    | TIM1 supply current <sup>(1)</sup>                                            |                              | 10                              | μA/MHz |
| I <sub>DD</sub> (TIM2)    | TIM2 supply current <sup>(4)</sup>                                            |                              | 7                               |        |
| I <sub>DD</sub> (TIM3)    | TIM3 supply current <sup>(1)</sup>                                            |                              | 7                               |        |
| I <sub>DD</sub> (TIM5)    | TIM5 supply current <sup>(1)</sup>                                            |                              | 7                               |        |
| I <sub>DD</sub> (TIM4)    | TIM4 timer supply current <sup>(1)</sup>                                      |                              | 3                               |        |
| I <sub>DD</sub> (USART1)  | USART1 supply current <sup>(5)</sup>                                          |                              | 5                               |        |
| I <sub>DD</sub> (USART2)  | USART2 supply current <sup>(6)</sup>                                          |                              | 5                               |        |
| I <sub>DD</sub> (USART3)  | USART3 supply current <sup>(7)</sup>                                          |                              | 5                               |        |
| I <sub>DD</sub> (SPI1)    | SPI1 supply current <sup>(4)</sup>                                            |                              | 3                               |        |
| I <sub>DD</sub> (SPI2)    | SPI2 supply current <sup>(4)</sup>                                            |                              | 3                               |        |
| I <sub>DD</sub> (I2C1)    | I <sup>2</sup> C1 supply current <sup>(4)</sup>                               |                              | 4                               |        |
| I <sub>DD</sub> (DMA1)    | DMA1 supply current                                                           |                              | 3                               |        |
| I <sub>DD</sub> (AES)     | AES supply current                                                            |                              | 4                               |        |
| I <sub>DD</sub> (WWDG)    | WWDG supply current                                                           |                              | 1                               |        |
| I <sub>DD</sub> (ALL)     | Peripherals ON <sup>(8)</sup>                                                 |                              | 67                              |        |
| I <sub>DD</sub> (ADC1)    | ADC1 supply current <sup>(9)</sup>                                            |                              | 1500                            | μA     |
| I <sub>DD</sub> (DAC)     | DAC supply current <sup>(10)</sup>                                            |                              | 370                             |        |
| I <sub>DD</sub> (COMP1)   | Comparator 1 supply current <sup>(11)</sup>                                   |                              | 0.160                           |        |
| I <sub>DD</sub> (COMP2)   | Comparator 2 supply current <sup>(11)</sup>                                   | Slow mode                    | 2                               |        |
|                           |                                                                               | Fast mode                    | 5                               |        |
| I <sub>DD</sub> (PVD/BOR) | Power voltage detector and brownout Reset unit supply current <sup>(12)</sup> |                              | 2.6                             |        |
| I <sub>DD</sub> (BOR)     | Brownout Reset unit supply current <sup>(12)</sup>                            |                              | 2.4                             |        |
| I <sub>DD</sub> (IDWDG)   | Independent watchdog supply current                                           | including LSI supply current | 0.45                            |        |
|                           |                                                                               | excluding LSI supply current | 0.05                            |        |

1. Data based on a differential I<sub>DD</sub> measurement between all peripherals OFF and a timer counter running at 16 MHz. The CPU is in Wait mode in both cases. No IC/OC programmed, no I/O pins toggling. Not tested in production.
2. Data based on a differential I<sub>DD</sub> measurement between the on-chip peripheral in reset configuration and not clocked and the on-chip peripheral when clocked and not kept under reset. The CPU is in Wait mode in both cases. No I/O pins toggling. Not tested in production.
3. Peripherals listed above the I<sub>DD</sub>(ALL) parameter ON: TIM1, TIM2, TIM3, TIM4, TIM5, USART1, USART2, USART3, SPI1, SPI2, I2C1, DMA1, WWDG.
4. Data based on a differential I<sub>DD</sub> measurement between all peripherals OFF and a timer counter running at 16 MHz. The CPU is in Wait mode in both cases. No IC/OC programmed, no I/O pins toggling. Not tested in production.

5. Data based on a differential  $I_{DD}$  measurement between the on-chip peripheral in reset configuration and not clocked and the on-chip peripheral when clocked and not kept under reset. The CPU is in Wait mode in both cases. No I/O pins toggling. Not tested in production.
6. Data based on a differential  $I_{DD}$  measurement between the on-chip peripheral in reset configuration and not clocked and the on-chip peripheral when clocked and not kept under reset. The CPU is in Wait mode in both cases. No I/O pins toggling. Not tested in production.
7. Data based on a differential  $I_{DD}$  measurement between the on-chip peripheral in reset configuration and not clocked and the on-chip peripheral when clocked and not kept under reset. The CPU is in Wait mode in both cases. No I/O pins toggling. Not tested in production.
8. Peripherals listed above the  $I_{DD(ALL)}$  parameter ON: TIM1, TIM2, TIM3, TIM4, USART1, SPI1, I2C1, DMA1, WWDG.
9. Data based on a differential  $I_{DD}$  measurement between ADC in reset configuration and continuous ADC conversion.
10. Data based on a differential  $I_{DD}$  measurement between DAC in reset configuration and continuous DAC conversion of  $V_{DD}/2$ . Floating DAC output.
11. Data based on a differential  $I_{DD}$  measurement between COMP1 or COMP2 in reset configuration and COMP1 or COMP2 enabled with static inputs. Supply current of internal reference voltage excluded.
12. Including supply current of internal reference voltage.

**Table 29. Current consumption under external reset**

| Symbol               | Parameter                                          | Conditions                                              |                         | Typ. | Unit |
|----------------------|----------------------------------------------------|---------------------------------------------------------|-------------------------|------|------|
| I <sub>DD(RST)</sub> | Supply current under external reset <sup>(1)</sup> | PB1/PB3/PA5 pins are externally tied to V <sub>DD</sub> | V <sub>DD</sub> = 1.8 V | 48   | μA   |
|                      |                                                    |                                                         | V <sub>DD</sub> = 3 V   | 80   |      |
|                      |                                                    |                                                         | V <sub>DD</sub> = 3.6 V | 95   |      |

1. All pins except PA0, PB0 and PB4 are floating under reset. PA0, PB0 and PB4 are configured with pull-up under reset. PB1, PB3 and PA5 must be tied externally under reset to avoid the consumption due to their schmitt trigger.

### 9.3.4 Clock and timing characteristics

#### HSE external clock (HSEBYP = 1 in CLK\_ECKCR)

Subject to general operating conditions for  $V_{DD}$  and  $T_A$ .

**Table 30. HSE external clock characteristics**

| Symbol               | Parameter                           | Conditions                 | Min.                | Typ. | Max.                | Unit |
|----------------------|-------------------------------------|----------------------------|---------------------|------|---------------------|------|
| $f_{HSE\_ext}^{(1)}$ | External clock source frequency     | -                          | 1                   | -    | 16                  | MHz  |
| $V_{HSEH}$           | OSC_IN input pin high-level voltage |                            | $0.7 \times V_{DD}$ | -    | $V_{DD}$            | V    |
| $V_{HSEL}$           | OSC_IN input pin low-level voltage  |                            | $V_{SS}$            | -    | $0.3 \times V_{DD}$ |      |
| $C_{in(HSE)}^{(1)}$  | OSC_IN input capacitance            | -                          | -                   | 2.6  | -                   | pF   |
| $I_{LEAK\_HSE}$      | OSC_IN input leakage current        | $V_{SS} < V_{IN} < V_{DD}$ | -                   | -    | $\pm 500$           | nA   |

1. Guaranteed by design.

**LSE external clock (LSEBYP=1 in CLK\_ECKCR)**

The LSE is available on STM8AL31E8x devices only.

Subject to general operating conditions for  $V_{DD}$  and  $T_A$ .

**Table 31. LSE external clock characteristics**

| Symbol          | Parameter                             | Min.                      | Typ.   | Max.                      | Unit |
|-----------------|---------------------------------------|---------------------------|--------|---------------------------|------|
| $f_{LSE\_ext}$  | External clock source frequency       | -                         | 32.768 | -                         | kHz  |
| $V_{LSEH}$      | OSC32_IN input pin high-level voltage | $0.7 \times V_{DD}^{(1)}$ | -      | $V_{DD}^{(1)}$            | V    |
| $V_{LSEL}$      | OSC32_IN input pin low-level voltage  | $V_{SS}^{(1)}$            | -      | $0.3 \times V_{DD}^{(1)}$ |      |
| $C_{in(LSE)}$   | OSC32_IN input capacitance            | -                         | 0.6    | -                         | pF   |
| $I_{LEAK\_LSE}$ | OSC32_IN input leakage current        | -                         | -      | $\pm 500$                 | nA   |

1. Guaranteed by characterization results.

**HSE crystal/ceramic resonator oscillator**

The HSE clock can be supplied with a 1 to 16 MHz crystal/ceramic resonator oscillator. All the information given in this paragraph is based on characterization results with specified typical external components. In the application, the resonator and the load capacitors have to be placed as close as possible to the oscillator pins in order to minimize output distortion and startup stabilization time. Refer to the crystal resonator manufacturer for more details (frequency, package, accuracy...).

**Table 32. HSE oscillator characteristics**

| Symbol              | Parameter                                | Conditions                       | Min.               | Typ. | Max.                                              | Unit       |
|---------------------|------------------------------------------|----------------------------------|--------------------|------|---------------------------------------------------|------------|
| $f_{HSE}$           | High speed external oscillator frequency | -                                | 1                  | -    | 16                                                | MHz        |
| $R_F$               | Feedback resistor                        | -                                | -                  | 200  | -                                                 | k $\Omega$ |
| $C^{(1)(2)}$        | Recommended load capacitance             | -                                | -                  | 20   | -                                                 | pF         |
| $I_{DD(HSE)}$       | HSE oscillator power consumption         | C = 20 pF,<br>$f_{OSC} = 16$ MHz | -                  | -    | 2.5 (startup)<br>0.7 (stabilized) <sup>(3)</sup>  | mA         |
|                     |                                          | C = 10 pF,<br>$f_{OSC} = 16$ MHz | -                  | -    | 2.5 (startup)<br>0.46 (stabilized) <sup>(3)</sup> |            |
| $g_m$               | Oscillator transconductance              | -                                | 3.5 <sup>(3)</sup> | -    | -                                                 | mA/V       |
| $t_{SU(HSE)}^{(4)}$ | Startup time                             | $V_{DD}$ is stabilized           | -                  | 1    | -                                                 | ms         |

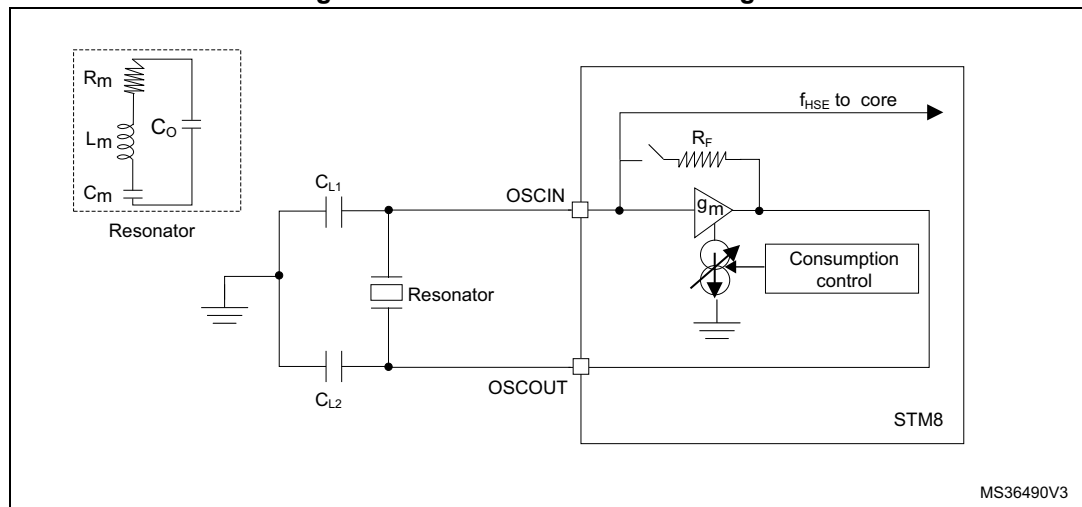
1.  $C = C_{L1} = C_{L2}$  is approximately equivalent to 2 x crystal  $C_{LOAD}$ .

2. The oscillator selection can be optimized in terms of supply current using a high quality resonator with small  $R_m$  value. Refer to crystal manufacturer for more details

3. Guaranteed by design.

4.  $t_{SU(HSE)}$  is the startup time measured from the moment it is enabled (by software) to a stabilized 16 MHz oscillation. This value is measured for a standard crystal resonator and it varies significantly with the crystal manufacturer.

Figure 21. HSE oscillator circuit diagram

**HSE oscillator critical  $g_m$  formula**

$$g_{m\text{crit}} = (2 \times \pi \times f_{\text{HSE}})^2 \times R_m (2C_o + C)^2$$

$R_m$ : Motional resistance (see crystal specification),  $L_m$ : Motional inductance (see crystal specification),

$C_m$ : Motional capacitance (see crystal specification),  $C_o$ : Shunt capacitance (see crystal specification),

$C_{L1}=C_{L2}=C$ : Grounded external capacitance

$g_m \gg g_{m\text{crit}}$

**LSE crystal/ceramic resonator oscillator**

The LSE is available on STM8AL31E8x devices only.

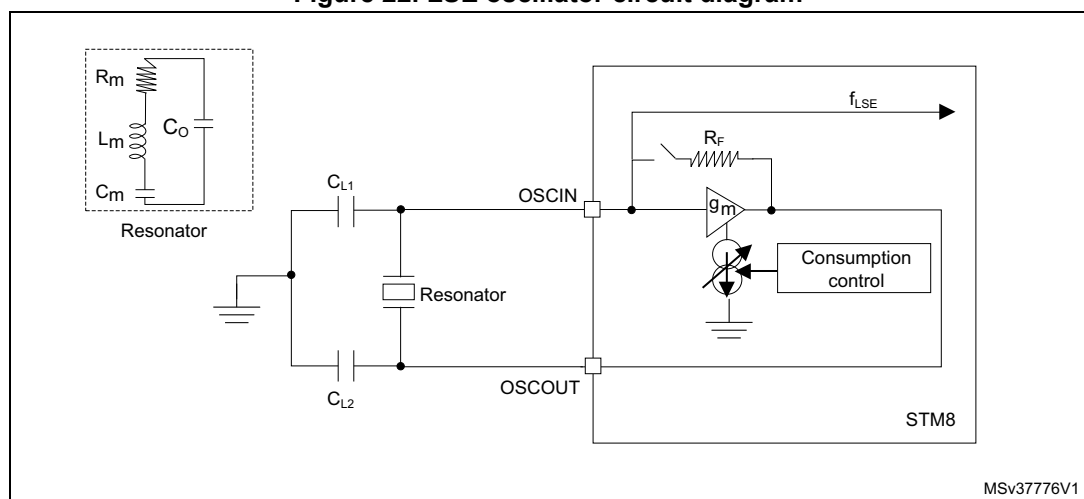
The LSE clock can be supplied with a 32.768 kHz crystal/ceramic resonator oscillator. All the information given in this paragraph is based on characterization results with specified typical external components. In the application, the resonator and the load capacitors have to be placed as close as possible to the oscillator pins in order to minimize output distortion and startup stabilization time. Refer to the crystal resonator manufacturer for more details (frequency, package, accuracy...).

Table 33. LSE oscillator characteristics

| Symbol              | Parameter                               | Conditions                  | Min.      | Typ.   | Max. | Unit      |
|---------------------|-----------------------------------------|-----------------------------|-----------|--------|------|-----------|
| $f_{LSE}$           | Low speed external oscillator frequency | -                           | -         | 32.768 | -    | kHz       |
| $R_F$               | Feedback resistor                       | $\Delta V = 200 \text{ mV}$ | -         | 1.2    | -    | $M\Omega$ |
| $C^{(1)(2)}$        | Recommended load capacitance            | -                           | -         | 8      | -    | pF        |
| $I_{DD(LSE)}$       | LSE oscillator power consumption        | $V_{DD} = 1.8 \text{ V}$    | -         | 450    | -    | nA        |
|                     |                                         | $V_{DD} = 3 \text{ V}$      | -         | 600    | -    |           |
|                     |                                         | $V_{DD} = 3.6 \text{ V}$    | -         | 750    | -    |           |
| $g_m$               | Oscillator transconductance             | -                           | $3^{(3)}$ | -      | -    | $\mu A/V$ |
| $t_{SU(LSE)}^{(4)}$ | Startup time                            | $V_{DD}$ is stabilized      | -         | 1      | -    | s         |

1.  $C=C_{L1}=C_{L2}$  is approximately equivalent to 2 x crystal  $C_{LOAD}$ .
2. The oscillator selection can be optimized in terms of supply current using a high quality resonator with a small  $R_m$  value. Refer to crystal manufacturer for more details.
3. Guaranteed by design.
4.  $t_{SU(LSE)}$  is the startup time measured from the moment it is enabled (by software) to a stabilized 32.768 kHz oscillation. This value is measured for a standard crystal resonator and it varies significantly with the crystal manufacturer.

Figure 22. LSE oscillator circuit diagram



### Internal clock sources

Subject to general operating conditions for  $V_{DD}$ , and  $T_A$ .

### High speed internal RC oscillator (HSI)

In the following table, data are based on characterization results, not tested in production, unless otherwise specified.



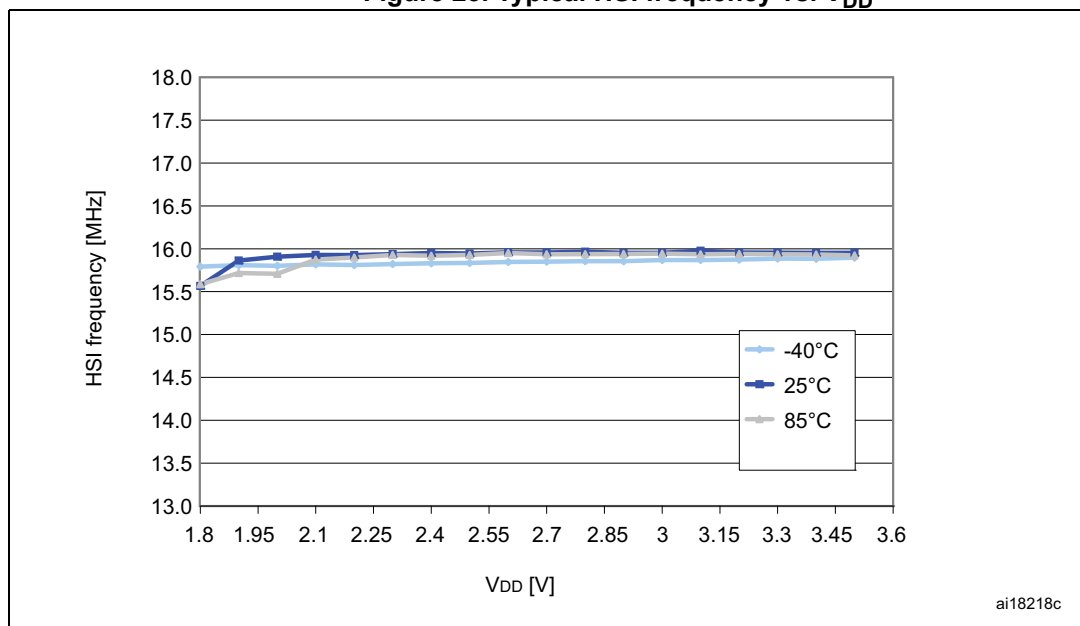
Table 34. HSI oscillator characteristics

| Symbol                      | Parameter                                    | Conditions <sup>(1)</sup>                                                                                                                                      | Min. | Typ. | Max.            | Unit          |
|-----------------------------|----------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------|------|------|-----------------|---------------|
| $f_{\text{HSI}}$            | Frequency                                    | $V_{\text{DD}} = 3.0 \text{ V}$                                                                                                                                | -    | 16   | -               | MHz           |
| $\text{ACC}_{\text{HSI}}$   | HSI oscillator user trimming accuracy        | Trimmed by the application for any $V_{\text{DD}}$ and $T_{\text{A}}$ conditions                                                                               | -1   | -    | 1               | %             |
|                             | HSI oscillator accuracy (factory calibrated) | $V_{\text{DD}} \leq 1.8 \text{ V} \leq V_{\text{DD}} \leq 3.6 \text{ V}$<br>$-40 \text{ }^{\circ}\text{C} \leq T_{\text{A}} \leq 125 \text{ }^{\circ}\text{C}$ | -5   | -    | 5               |               |
| TRIM                        | HSI user trimming step <sup>(2)</sup>        | Trimming code $\neq$ multiple of 16                                                                                                                            | -    | 0.4  | $0.7^{(2)}$     | %             |
|                             |                                              | Trimming code = multiple of 16                                                                                                                                 | -    | -    | $\pm 1.5^{(2)}$ |               |
| $t_{\text{su}}(\text{HSI})$ | HSI oscillator setup time (wakeup time)      | -                                                                                                                                                              | -    | 3.7  | $6^{(3)}$       | $\mu\text{s}$ |
| $I_{\text{DD}}(\text{HSI})$ | HSI oscillator power consumption             | -                                                                                                                                                              | -    | 100  | $140^{(3)}$     | $\mu\text{A}$ |

1.  $V_{\text{DD}} = 3.0 \text{ V}$ ,  $T_{\text{A}} = -40$  to  $125 \text{ }^{\circ}\text{C}$  unless otherwise specified.

2. The trimming step differs depending on the trimming code. It is usually negative on the codes which are multiples of 16 (0x00, 0x10, 0x20, 0x30...0xE0). Refer to the AN3101 "STM8L15x internal RC oscillator calibration" application note for more details.

3. Guaranteed by design.

Figure 23. Typical HSI frequency vs.  $V_{\text{DD}}$ 

### Low speed internal RC oscillator (LSI)

In the following table, data are based on characterization results, not tested in production, unless otherwise specified.

**Table 35. LSI oscillator characteristics**

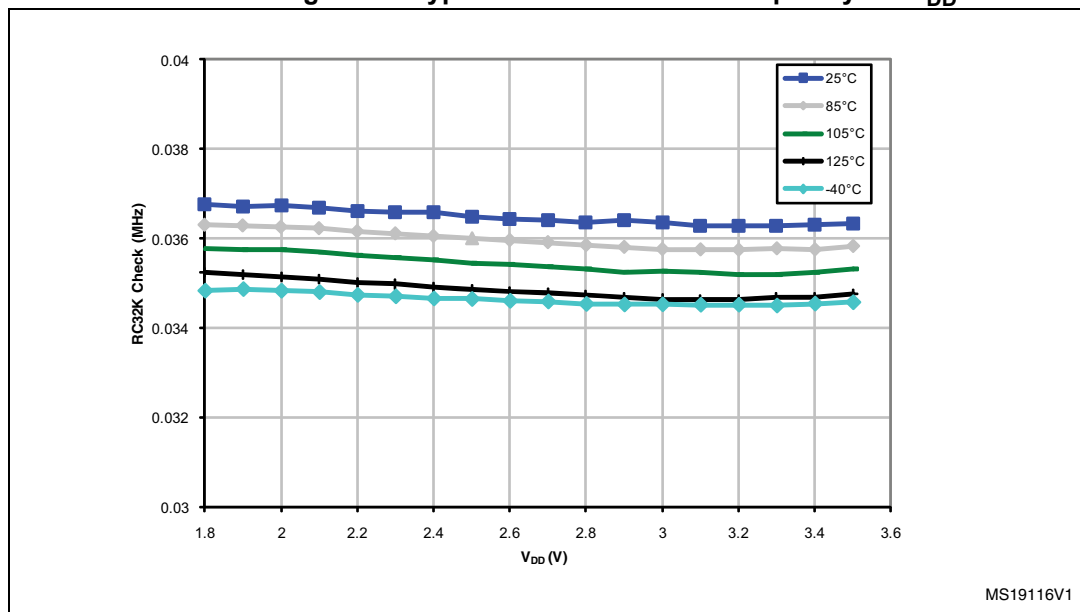
| Symbol        | Parameter                                     | Conditions <sup>(1)</sup>                                            | Min. | Typ. | Max.               | Unit    |
|---------------|-----------------------------------------------|----------------------------------------------------------------------|------|------|--------------------|---------|
| $f_{LSI}$     | Frequency                                     | -                                                                    | 26   | 38   | 56                 | kHz     |
| $t_{su(LSI)}$ | LSI oscillator wakeup time                    | -                                                                    | -    | -    | 200 <sup>(2)</sup> | $\mu s$ |
| $D_{(LSI)}$   | LSI oscillator frequency drift <sup>(3)</sup> | $0\text{ }^{\circ}\text{C} \leq T_A \leq 85\text{ }^{\circ}\text{C}$ | -12  | -    | 11                 | %       |

1.  $V_{DD} = 1.65\text{ V}$  to  $3.6\text{ V}$ ,  $T_A = -40$  to  $125\text{ }^{\circ}\text{C}$  unless otherwise specified.

2. Guaranteed by design.

3. This is a deviation for an individual part, once the initial frequency has been measured.

**Figure 24. Typical LSI clock source frequency vs.  $V_{DD}$**



### 9.3.5 Memory characteristics

$T_A = -40$  to  $125\text{ }^{\circ}\text{C}$  unless otherwise specified.

**Table 36. RAM and hardware registers**

| Symbol   | Parameter                          | Conditions           | Min. | Typ. | Max. | Unit |
|----------|------------------------------------|----------------------|------|------|------|------|
| $V_{RM}$ | Data retention mode <sup>(1)</sup> | Halt mode (or Reset) | 1.65 | -    | -    | V    |

1. Minimum supply voltage without losing data stored in RAM (in Halt mode or under Reset) or in hardware registers (only in Halt mode). Guaranteed by characterization results.

## Flash memory

Table 37. Flash program memory/data EEPROM memory

| Symbol     | Parameter                                                                             | Conditions                                           | Min. | Typ. | Max. | Unit |
|------------|---------------------------------------------------------------------------------------|------------------------------------------------------|------|------|------|------|
| $V_{DD}$   | Operating voltage<br>(all modes, read/write/erase)                                    | $f_{SYSCLK} = 16 \text{ MHz}$                        | 1.65 | -    | 3.6  | V    |
| $t_{prog}$ | Programming time for 1 or 128 byte (block)<br>erase/write cycles (on programmed byte) | -                                                    | -    | 6    | -    | ms   |
|            | Programming time for 1 to 128 byte (block)<br>write cycles (on erased byte)           | -                                                    | -    | 3    | -    | ms   |
| $I_{prog}$ | Programming/ erasing consumption                                                      | $T_A = +25^\circ\text{C}$ , $V_{DD} = 3.0 \text{ V}$ | -    | 0.7  | -    | mA   |
|            |                                                                                       | $T_A = +25^\circ\text{C}$ , $V_{DD} = 1.8 \text{ V}$ | -    |      | -    |      |

Table 38. Flash program memory

| Symbol    | Parameter                                                             | Conditions               | Min. | Max. | Unit             |
|-----------|-----------------------------------------------------------------------|--------------------------|------|------|------------------|
| $T_{WE}$  | Temperature for writing and erasing                                   | -                        | -40  | 125  | $^\circ\text{C}$ |
| $N_{WE}$  | Flash program memory endurance<br>(erase/write cycles) <sup>(1)</sup> | $T_A = 25^\circ\text{C}$ | 1000 | -    | cycles           |
| $t_{RET}$ | Data retention time                                                   | $T_A = 25^\circ\text{C}$ | 40   | -    | years            |
|           |                                                                       | $T_A = 55^\circ\text{C}$ | 20   | -    |                  |

1. The physical granularity of the memory is 4 byte, so cycling is performed on 4 byte even when a write/erase operation addresses a single byte.

## Data memory

Table 39. Data memory

| Symbol    | Parameter                                                    | Conditions                                | Min.                  | Max. | Unit             |
|-----------|--------------------------------------------------------------|-------------------------------------------|-----------------------|------|------------------|
| $T_{WE}$  | Temperature for writing and erasing                          | -                                         | -40                   | 125  | $^\circ\text{C}$ |
| $N_{WE}$  | Data memory endurance<br>(erase/write cycles) <sup>(1)</sup> | $T_A = 25^\circ\text{C}$                  | 300 k                 | -    | cycles           |
|           |                                                              | $T_A = -40 \text{ to } 125^\circ\text{C}$ | 100 k <sup>(2)</sup>  | -    |                  |
| $t_{RET}$ | Data retention time                                          | $T_A = 25^\circ\text{C}$                  | 40 <sup>(2)</sup> (3) | -    | years            |
|           |                                                              | $T_A = 55^\circ\text{C}$                  | 20 <sup>(2)</sup> (3) | -    |                  |

1. The physical granularity of the memory is 4 byte, so cycling is performed on 4 byte even when a write/erase operation addresses a single byte.
2. More information on the relationship between data retention time and number of write/erase cycles is available in a separate technical document.
3. Retention time for 256B of data memory after up to 1000 cycles at 125  $^\circ\text{C}$ .

### 9.3.6 I/O current injection characteristics

As a general rule, current injection to the I/O pins, due to external voltage below  $V_{SS}$  or above  $V_{DD}$  (for standard pins) should be avoided during normal product operation. However, in order to give an indication of the robustness of the microcontroller in cases when abnormal injection accidentally happens, susceptibility tests are performed on a sample basis during device characterization.

#### Functional susceptibility to I/O current injection

While a simple application is executed on the device, the device is stressed by injecting current into the I/O pins programmed in floating input mode. While current is injected into the I/O pin, one at a time, the device is checked for functional failures.

The failure is indicated by an out of range parameter: ADC error, out of spec current injection on adjacent pins or other functional failure (for example reset, oscillator frequency deviation, LCD levels, etc.).

The test results are given in the following table.

**Table 40. I/O current injection susceptibility**

| Symbol    | Description                                    | Functional susceptibility |                    | Unit |
|-----------|------------------------------------------------|---------------------------|--------------------|------|
|           |                                                | Negative injection        | Positive injection |      |
| $I_{INJ}$ | Injected current on true open-drain pins       | -5                        | +0                 | mA   |
|           | Injected current on all 5 V tolerant (FT) pins | -5                        | +0                 |      |
|           | Injected current on any other pin              | -5                        | +5                 |      |

### 9.3.7 I/O port pin characteristics

#### General characteristics

Subject to general operating conditions for  $V_{DD}$  and  $T_A$  unless otherwise specified. All unused pins must be kept at a fixed voltage: using the output mode of the I/O for example or an external pull-up or pull-down resistor.

Table 41. I/O static characteristics

| Symbol    | Parameter                                         | Conditions <sup>(1)</sup>                                                    | Min.                 | Typ. | Max.                | Unit       |
|-----------|---------------------------------------------------|------------------------------------------------------------------------------|----------------------|------|---------------------|------------|
| $V_{IL}$  | Input low-level voltage                           | Input voltage on all pins                                                    | $V_{SS}-0.3$         | -    | $0.3 \times V_{DD}$ | V          |
| $V_{IH}$  | Input high-level voltage                          | Input voltage on true open-drain pins (PC0 and PC1) with $V_{DD} < 2$ V      | $0.70 \times V_{DD}$ | -    | $5.2^{(2)}$         | V          |
|           |                                                   | Input voltage on true open-drain pins (PC0 and PC1) with $V_{DD} \geq 2$ V   |                      | -    | $5.5^{(2)}$         |            |
|           |                                                   | Input voltage on five-volt tolerant (FT) pins with $V_{DD} < 2$ V            |                      | -    | $5.2^{(2)}$         |            |
|           |                                                   | Input voltage on five-volt tolerant (FT) pins with $V_{DD} \geq 2$ V         |                      | -    | $5.5^{(2)}$         |            |
|           |                                                   | Input voltage on any other pin                                               |                      | -    | $V_{DD}+0.3^{(2)}$  |            |
| $V_{hys}$ | Schmitt trigger voltage hysteresis <sup>(3)</sup> | Standard I/Os                                                                | -                    | 200  | -                   | mV         |
|           |                                                   | True open drain I/Os                                                         | -                    | 200  | -                   |            |
| $I_{lkg}$ | Input leakage current <sup>(4)</sup>              | $V_{SS} \leq V_{IN} \leq V_{DD}$<br>Standard I/Os                            | -                    | -    | 50                  | nA         |
|           |                                                   | $V_{SS} \leq V_{IN} \leq V_{DD}$<br>True open drain I/Os                     | -                    | -    | 200                 |            |
|           |                                                   | $V_{SS} \leq V_{IN} \leq V_{DD}$<br>PA0 with high sink LED driver capability | -                    | -    | 200                 |            |
| $R_{PU}$  | Weak pull-up equivalent resistor <sup>(5)</sup>   | $V_{IN}=V_{SS}$                                                              | $30^{(6)}$           | 45   | $60^{(6)}$          | k $\Omega$ |
| $C_{IO}$  | I/O pin capacitance                               | -                                                                            | -                    | 5    | -                   | pF         |

- $V_{DD} = 3.0$  V,  $T_A = -40$  to  $125$  °C unless otherwise specified.
- If  $V_{IH}$  maximum is not respected, the injection current must be limited externally to  $I_{INJ(PIN)}$  maximum.
- Hysteresis voltage between Schmitt trigger switching levels. Based on characterization results, not tested.
- The max. value may be exceeded if negative current is injected on adjacent pins.
- $R_{PU}$  pull-up equivalent resistor based on a resistive transistor (corresponding  $I_{PU}$  current characteristics described in [Figure 28](#)).
- Guaranteed by characterization results.

Figure 25. Typical  $V_{IL}$  and  $V_{IH}$  vs.  $V_{DD}$  (standard I/Os)

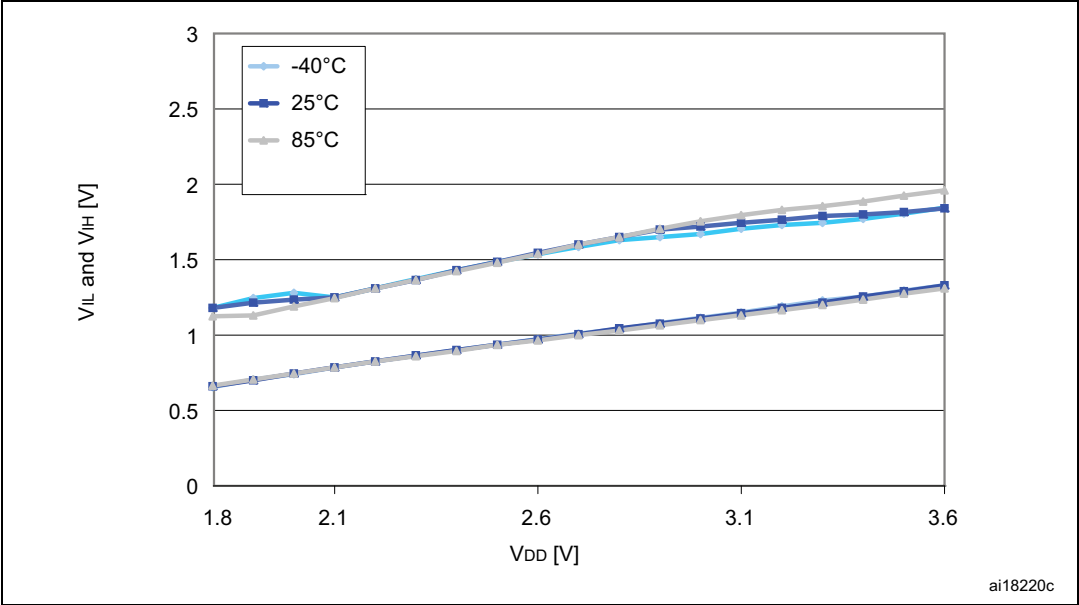


Figure 26. Typical  $V_{IL}$  and  $V_{IH}$  vs.  $V_{DD}$  (true open drain I/Os)

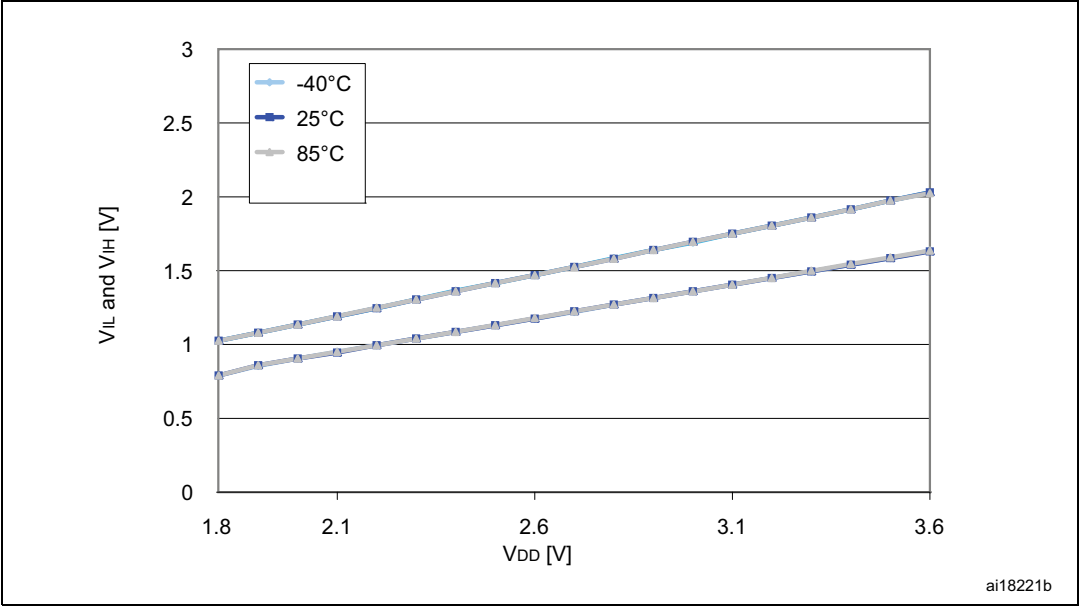
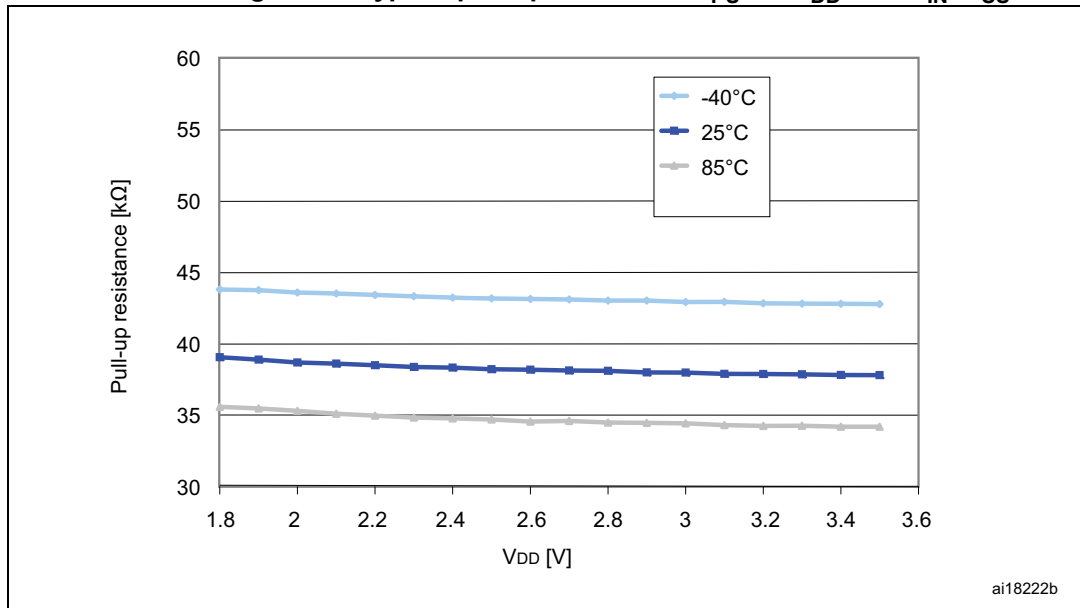
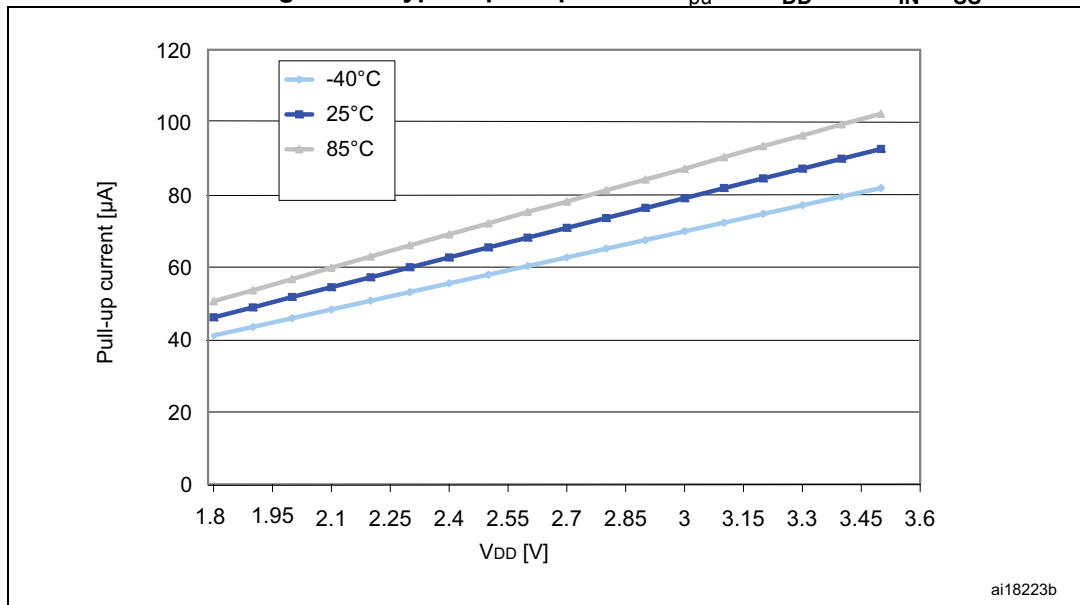


Figure 27. Typical pull-up resistance  $R_{PU}$  vs.  $V_{DD}$  with  $V_{IN}=V_{SS}$ Figure 28. Typical pull-up current  $I_{PU}$  vs.  $V_{DD}$  with  $V_{IN}=V_{SS}$ 

### Output driving current

Subject to general operating conditions for  $V_{DD}$  and  $T_A$  unless otherwise specified.

Table 42. Output driving current (high sink ports)

| I/O Type | Symbol         | Parameter                                | Conditions                                              | Min.          | Max. | Unit |
|----------|----------------|------------------------------------------|---------------------------------------------------------|---------------|------|------|
| Standard | $V_{OL}^{(1)}$ | Output low-level voltage for an I/O pin  | $I_{IO} = +2 \text{ mA}$ ,<br>$V_{DD} = 3.0 \text{ V}$  | -             | 0.45 | V    |
|          |                |                                          | $I_{IO} = +2 \text{ mA}$ ,<br>$V_{DD} = 1.8 \text{ V}$  | -             | 0.45 | V    |
|          |                |                                          | $I_{IO} = +10 \text{ mA}$ ,<br>$V_{DD} = 3.0 \text{ V}$ | -             | 0.7  | V    |
|          | $V_{OH}^{(2)}$ | Output high-level voltage for an I/O pin | $I_{IO} = -2 \text{ mA}$ ,<br>$V_{DD} = 3.0 \text{ V}$  | $V_{DD}-0.45$ | -    | V    |
|          |                |                                          | $I_{IO} = -1 \text{ mA}$ ,<br>$V_{DD} = 1.8 \text{ V}$  | $V_{DD}-0.45$ | -    | V    |
|          |                |                                          | $I_{IO} = -10 \text{ mA}$ ,<br>$V_{DD} = 3.0 \text{ V}$ | $V_{DD}-0.7$  | -    | V    |

1. The  $I_{IO}$  current sunk must always respect the absolute maximum rating specified in [Table 16](#) and the sum of  $I_{IO}$  (I/O ports and control pins) must not exceed  $I_{VSS}$ .
2. The  $I_{IO}$  current sourced must always respect the absolute maximum rating specified in [Table 16](#) and the sum of  $I_{IO}$  (I/O ports and control pins) must not exceed  $I_{VDD}$ .

Table 43. Output driving current (true open drain ports)

| I/O Type   | Symbol         | Parameter                               | Conditions                                             | Min. | Max. | Unit |
|------------|----------------|-----------------------------------------|--------------------------------------------------------|------|------|------|
| Open drain | $V_{OL}^{(1)}$ | Output low-level voltage for an I/O pin | $I_{IO} = +3 \text{ mA}$ ,<br>$V_{DD} = 3.0 \text{ V}$ | -    | 0.45 | V    |
|            |                |                                         | $I_{IO} = +1 \text{ mA}$ ,<br>$V_{DD} = 1.8 \text{ V}$ | -    | 0.45 |      |

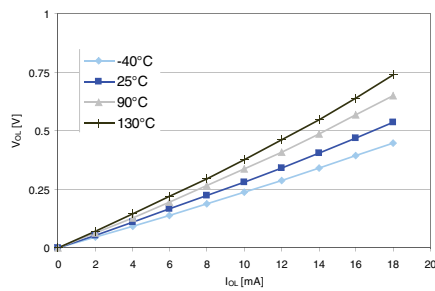
1. The  $I_{IO}$  current sunk must always respect the absolute maximum rating specified in [Table 16](#) and the sum of  $I_{IO}$  (I/O ports and control pins) must not exceed  $I_{VSS}$ .

Table 44. Output driving current (PA0 with high sink LED driver capability)

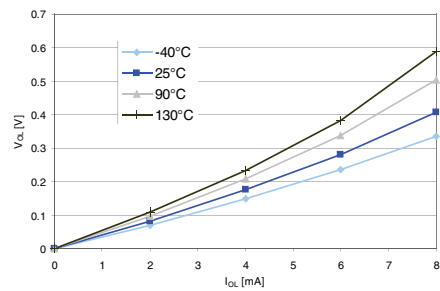
| I/O Type              | Symbol         | Parameter                               | Conditions                                              | Min. | Max. | Unit |
|-----------------------|----------------|-----------------------------------------|---------------------------------------------------------|------|------|------|
| $\overline{\text{K}}$ | $V_{OL}^{(1)}$ | Output low-level voltage for an I/O pin | $I_{IO} = +20 \text{ mA}$ ,<br>$V_{DD} = 2.0 \text{ V}$ | -    | 0.45 | V    |

1. The  $I_{IO}$  current sunk must always respect the absolute maximum rating specified in [Table 16](#) and the sum of  $I_{IO}$  (I/O ports and control pins) must not exceed  $I_{VSS}$ .

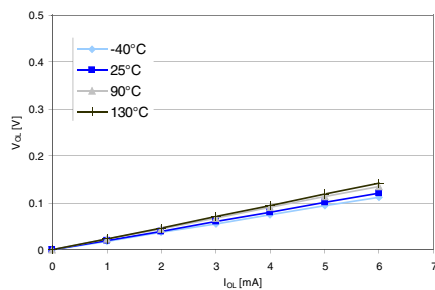


**Figure 29. Typical  $V_{OL}$  @  $V_{DD} = 3.0$  V (high sink ports)**

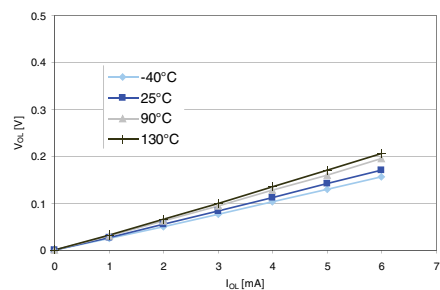
ai18226

**Figure 30. Typical  $V_{OL}$  @  $V_{DD} = 1.8$  V (high sink ports)**

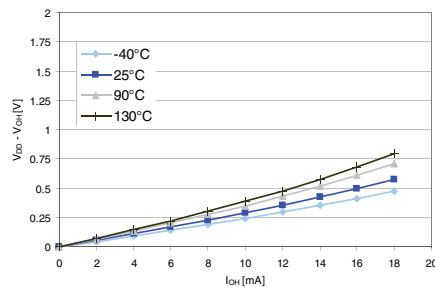
ai18227

**Figure 31. Typical  $V_{OL}$  @  $V_{DD} = 3.0$  V (true open drain ports)**

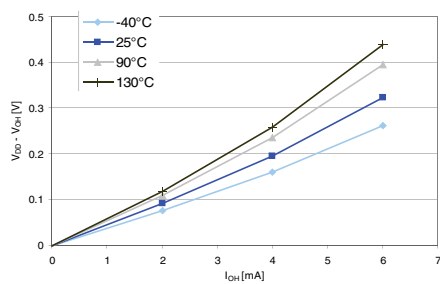
ai18228

**Figure 32. Typical  $V_{OL}$  @  $V_{DD} = 1.8$  V (true open drain ports)**

ai18229

**Figure 33. Typical  $V_{DD} - V_{OH}$  @  $V_{DD} = 3.0$  V (high sink ports)**

ai12830

**Figure 34. Typical  $V_{DD} - V_{OH}$  @  $V_{DD} = 1.8$  V (high sink ports)**

ai18231

**NRST pin**

Subject to general operating conditions for  $V_{DD}$  and  $T_A$  unless otherwise specified.

**Table 45. NRST pin characteristics**

| Symbol                | Parameter                                    | Conditions                                                  | Min.                           | Typ. | Max.                           | Unit |
|-----------------------|----------------------------------------------|-------------------------------------------------------------|--------------------------------|------|--------------------------------|------|
| V <sub>IL(NRST)</sub> | NRST input low-level voltage                 | -                                                           | V <sub>SS</sub> <sup>(1)</sup> | -    | 0.8 <sup>(1)</sup>             | V    |
| V <sub>IH(NRST)</sub> | NRST input high-level voltage <sup>(1)</sup> | -                                                           | 1.4 <sup>(1)</sup>             | -    | V <sub>DD</sub> <sup>(1)</sup> |      |
| V <sub>OL(NRST)</sub> | NRST output low-level voltage <sup>(1)</sup> | I <sub>OL</sub> = 2 mA<br>for 2.7 V ≤V <sub>DD</sub> ≤3.6 V | -                              | -    | 0.4 <sup>(1)</sup>             |      |
|                       |                                              | I <sub>OL</sub> = 1.5 mA<br>for V <sub>DD</sub> < 2.7 V     | -                              | -    |                                |      |
| V <sub>HYST</sub>     | NRST input hysteresis                        | -                                                           | 10%V <sub>DD</sub><br>(2)(3)   | -    | -                              | mV   |
| R <sub>PU(NRST)</sub> | NRST pull-up equivalent resistor             | -                                                           | 30 <sup>(1)</sup>              | 45   | 60 <sup>(1)</sup>              | kΩ   |
| V <sub>F(NRST)</sub>  | NRST input filtered pulse                    | -                                                           | -                              | -    | 50 <sup>(3)</sup>              | ns   |
| V <sub>NF(NRST)</sub> | NRST input not filtered pulse                | -                                                           | 300 <sup>(3)</sup>             | -    | -                              |      |

1. Guaranteed by characterization results.

2. 200 mV min.

3. Guaranteed by design.

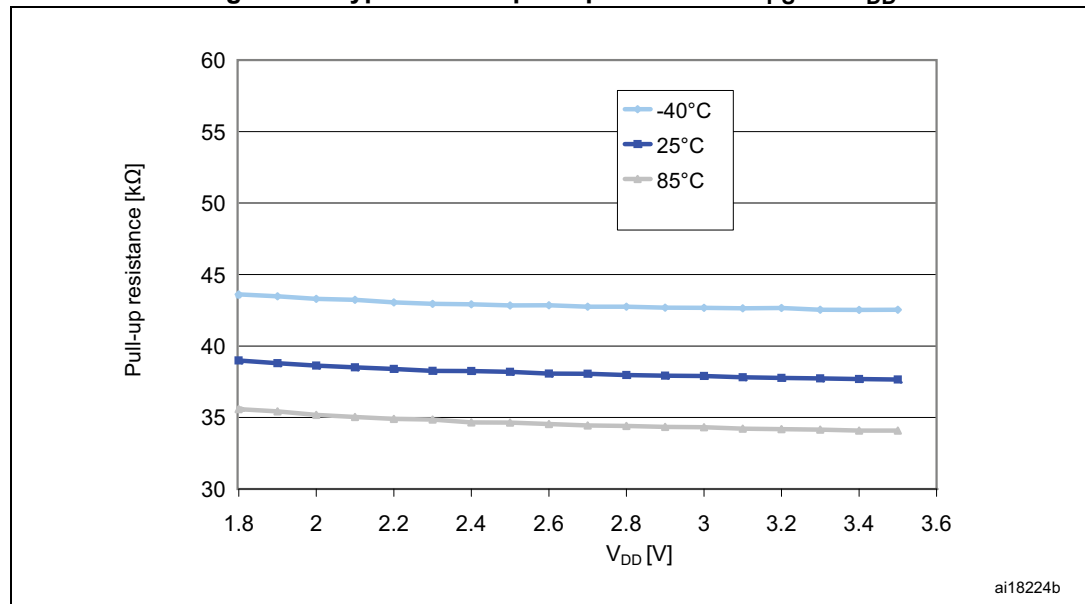
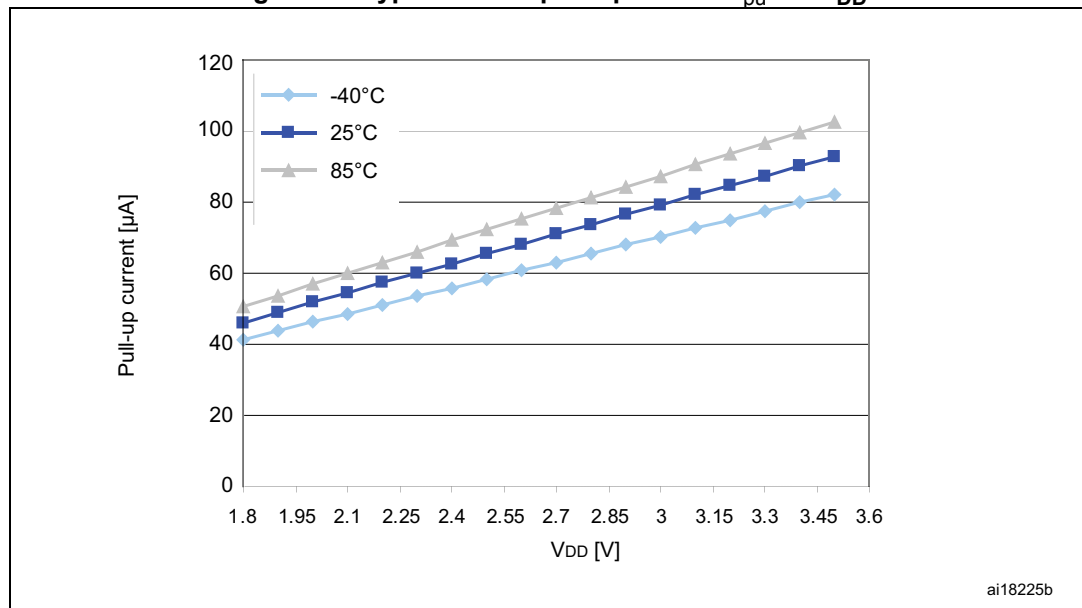
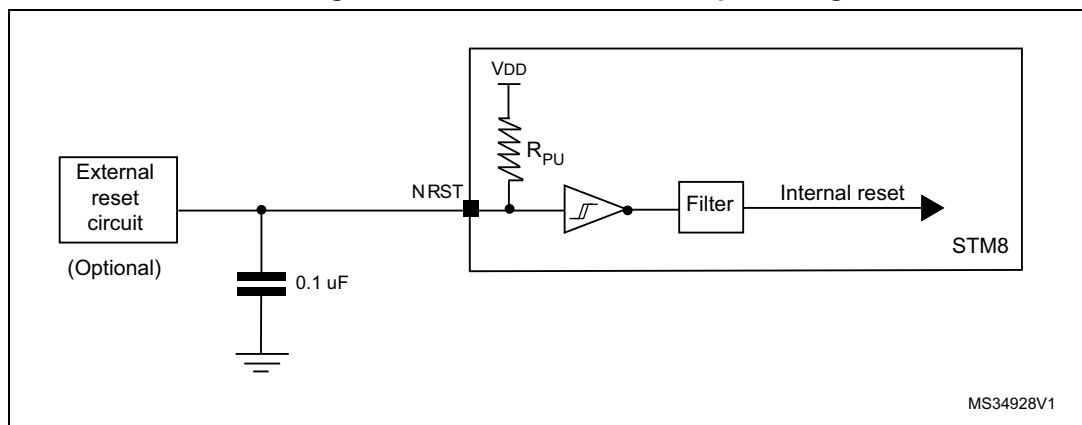
**Figure 35. Typical NRST pull-up resistance  $R_{PU}$  vs.  $V_{DD}$** 

Figure 36. Typical NRST pull-up current  $I_{PU}$  vs.  $V_{DD}$ 

The reset network shown in [Figure 37](#) protects the device against parasitic resets. The user must ensure that the level on the NRST pin goes below the  $V_{IL}$  max. level specified in [Table 45](#). Otherwise the reset is not taken into account internally. For power consumption-sensitive applications, the capacity of the external reset capacitor has to be reduced to limit the charge/discharge current. If the NRST signal is used to reset the external circuitry, the user must pay attention to the charge/discharge time of the external capacitor to meet the reset timing conditions of the external devices. The minimum recommended capacity is 10 nF.

Figure 37. Recommended NRST pin configuration



### 9.3.8 Communication interfaces

#### SPI1 - Serial peripheral interface

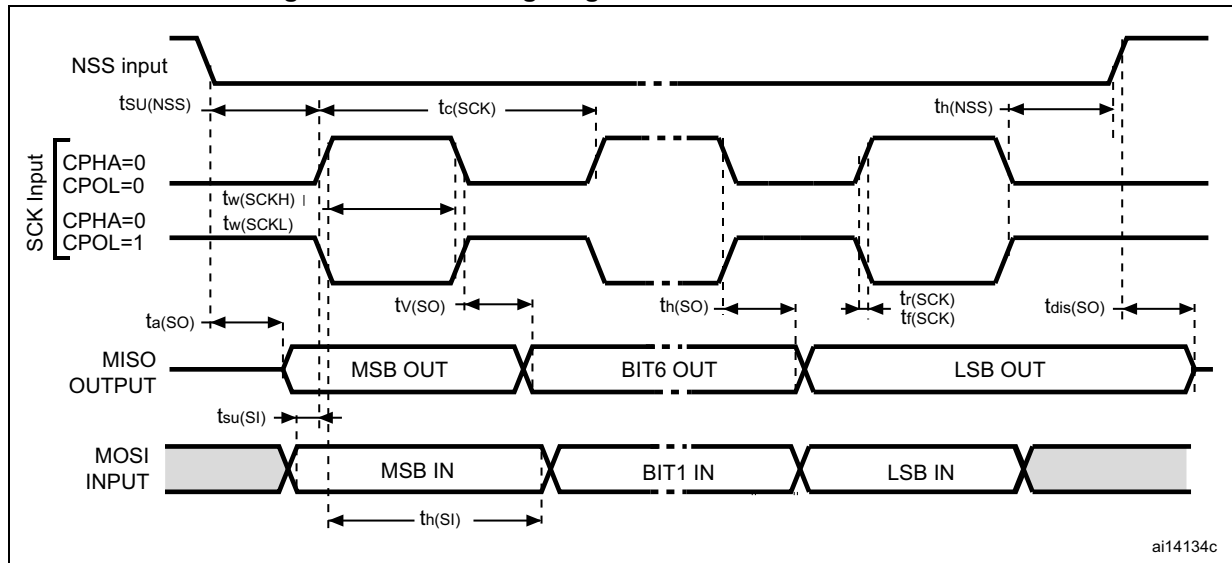
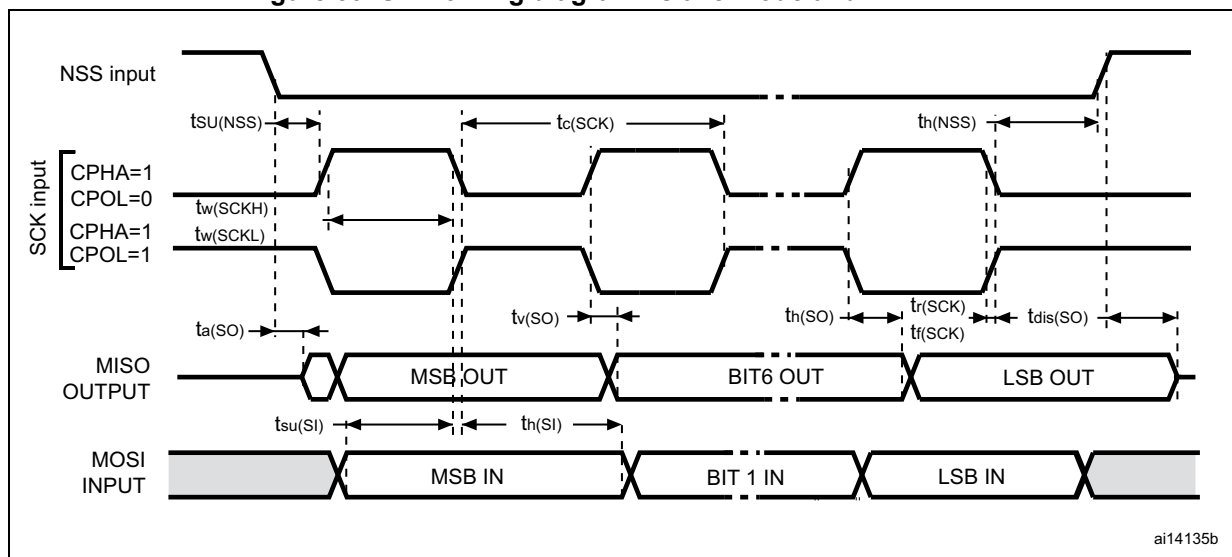
Unless otherwise specified, the parameters given in [Table 46](#) are derived from tests performed under ambient temperature,  $f_{\text{SYSCLK}}$  frequency and  $V_{\text{DD}}$  supply voltage conditions summarized in [Section 9.3.1](#). Refer to I/O port characteristics for more details on the input/output alternate function characteristics (NSS, SCK, MOSI, MISO).

**Table 46. SPI1 characteristics**

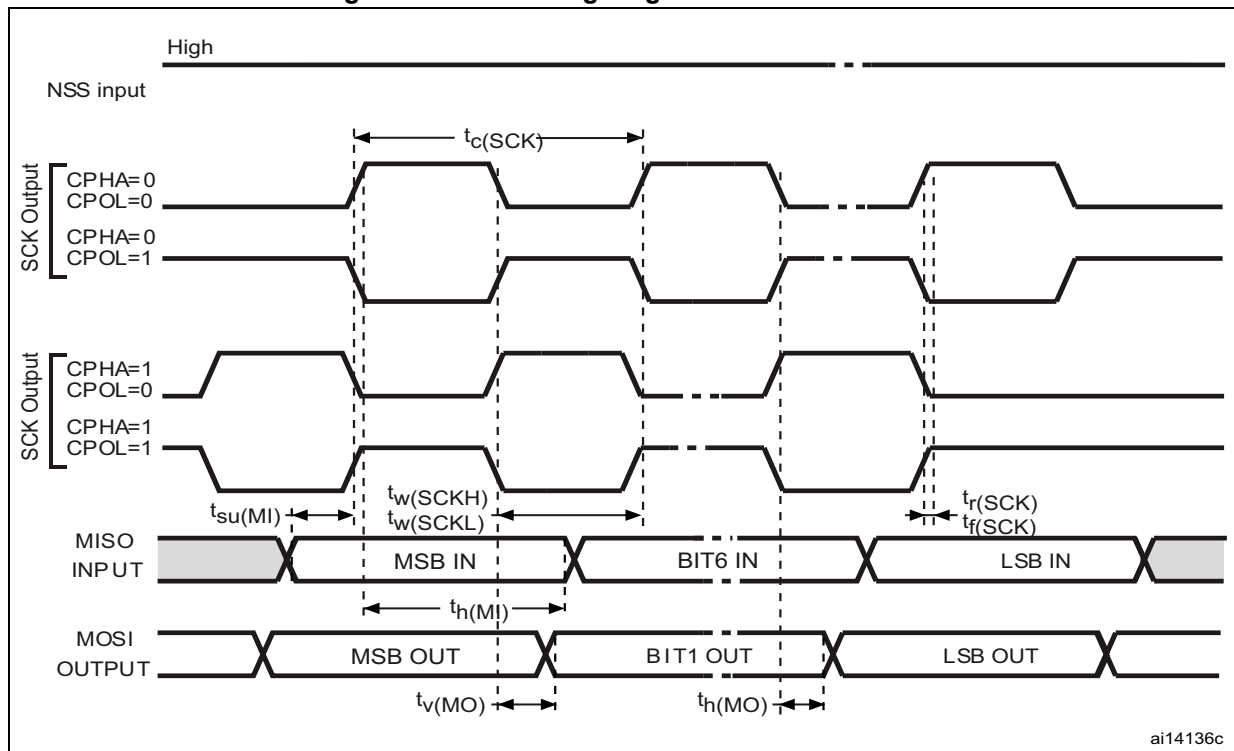
| Symbol                                                   | Parameter                     | Conditions <sup>(1)</sup>                                                              | Min.                           | Max.                           | Unit |
|----------------------------------------------------------|-------------------------------|----------------------------------------------------------------------------------------|--------------------------------|--------------------------------|------|
| $f_{\text{SCK}}$<br>$1/t_{\text{c(SCK)}}$                | SPI1 clock frequency          | Master mode                                                                            | 0                              | 8                              | MHz  |
|                                                          |                               | Slave mode                                                                             | 0                              | 8                              |      |
| $t_{\text{r(SCK)}}$<br>$t_{\text{f(SCK)}}$               | SPI1 clock rise and fall time | Capacitive load: C = 30 pF                                                             | -                              | 30                             | ns   |
| $t_{\text{su(NSS)}}^{(2)}$                               | NSS setup time                | Slave mode                                                                             | $4 \times 1/f_{\text{SYSCLK}}$ | -                              |      |
| $t_{\text{h(NSS)}}^{(2)}$                                | NSS hold time                 | Slave mode                                                                             | 80                             | -                              |      |
| $t_{\text{w(SCKH)}}^{(2)}$<br>$t_{\text{w(SCKL)}}^{(2)}$ | SCK high and low time         | Master mode,<br>$f_{\text{MASTER}} = 8 \text{ MHz}$ , $f_{\text{SCK}} = 4 \text{ MHz}$ | 105                            | 145                            |      |
| $t_{\text{su(MI)}}^{(2)}$<br>$t_{\text{su(SI)}}^{(2)}$   | Data input setup time         | Master mode                                                                            | 30                             | -                              |      |
|                                                          |                               | Slave mode                                                                             | 3                              | -                              |      |
| $t_{\text{h(MI)}}^{(2)}$<br>$t_{\text{h(SI)}}^{(2)}$     | Data input hold time          | Master mode                                                                            | 15                             | -                              |      |
|                                                          |                               | Slave mode                                                                             | 0                              | -                              |      |
| $t_{\text{a(SO)}}^{(2)(3)}$                              | Data output access time       | Slave mode                                                                             | -                              | $3 \times 1/f_{\text{SYSCLK}}$ |      |
| $t_{\text{dis(SO)}}^{(2)(4)}$                            | Data output disable time      | Slave mode                                                                             | 30                             | -                              |      |
| $t_{\text{v(SO)}}^{(2)}$                                 | Data output valid time        | Slave mode (after enable edge)                                                         | -                              | 60                             |      |
| $t_{\text{v(MO)}}^{(2)}$                                 | Data output valid time        | Master mode (after enable edge)                                                        | -                              | 20                             |      |
| $t_{\text{h(SO)}}^{(2)}$<br>$t_{\text{h(MO)}}^{(2)}$     | Data output hold time         | Slave mode (after enable edge)                                                         | 15                             | -                              |      |
|                                                          |                               | Master mode (after enable edge)                                                        | 1                              | -                              |      |

- Parameters are given by selecting 10 MHz I/O output frequency.
- Guaranteed by characterization results or by design.
- Min. time is for the minimum time to drive the output and max. time is for the maximum time to validate the data.
- Min. time is for the minimum time to invalidate the output and max. time is for the maximum time to put the data in Hi-Z.

Figure 38. SPI1 timing diagram - slave mode and CPHA=0

Figure 39. SPI1 timing diagram - slave mode and CPHA=1<sup>(1)</sup>

1. Measurement points are done at CMOS levels:  $0.3V_{DD}$  and  $0.7V_{DD}$ .

Figure 40. SPI1 timing diagram - master mode<sup>(1)</sup>

1. Measurement points are done at CMOS levels:  $0.3V_{DD}$  and  $0.7V_{DD}$ .

**I<sup>2</sup>C - Inter IC control interface**

Subject to general operating conditions for  $V_{DD}$ ,  $f_{SYSCLK}$ , and  $T_A$  unless otherwise specified.

The STM8AL I<sup>2</sup>C interface (I2C1) meets the requirements of the Standard I<sup>2</sup>C communication protocol described in the following table with the restriction mentioned below:

Refer to I/O port characteristics for more details on the input/output alternate function characteristics (SDA and SCL).

**Table 47. I2C characteristics**

| Symbol                       | Parameter                               | Standard mode I <sup>2</sup> C |                     | Fast mode I <sup>2</sup> C <sup>(1)</sup> |                     | Unit    |
|------------------------------|-----------------------------------------|--------------------------------|---------------------|-------------------------------------------|---------------------|---------|
|                              |                                         | Min. <sup>(2)</sup>            | Max. <sup>(2)</sup> | Min. <sup>(2)</sup>                       | Max. <sup>(2)</sup> |         |
| $t_{w(SCLL)}$                | SCL clock low time                      | 4.7                            | -                   | 1.3                                       | -                   | $\mu s$ |
| $t_{w(SCLH)}$                | SCL clock high time                     | 4.0                            | -                   | 0.6                                       | -                   |         |
| $t_{su(SDA)}$                | SDA setup time                          | 250                            | -                   | 100                                       | -                   | ns      |
| $t_{h(SDA)}$                 | SDA data hold time                      | 0                              | -                   | 0                                         | 900                 |         |
| $t_{r(SDA)}$<br>$t_{r(SCL)}$ | SDA and SCL rise time                   | -                              | 1000                | -                                         | 300                 |         |
| $t_{f(SDA)}$<br>$t_{f(SCL)}$ | SDA and SCL fall time                   | -                              | 300                 | -                                         | 300                 |         |
| $t_{h(STA)}$                 | START condition hold time               | 4.0                            | -                   | 0.6                                       | -                   | $\mu s$ |
| $t_{su(STA)}$                | Repeated START condition setup time     | 4.7                            | -                   | 0.6                                       | -                   |         |
| $t_{su(STO)}$                | STOP condition setup time               | 4.0                            | -                   | 0.6                                       | -                   |         |
| $t_{w(STO:STA)}$             | STOP to START condition time (bus free) | 4.7                            | -                   | 1.3                                       | -                   |         |
| $C_b$                        | Capacitive load for each bus line       | -                              | 400                 | -                                         | 400                 | pF      |

1.  $f_{SYSCLK}$  must be at least equal to 8 MHz to achieve max fast I<sup>2</sup>C speed (400 kHz).

2. Data based on standard I<sup>2</sup>C protocol requirement, not tested in production.

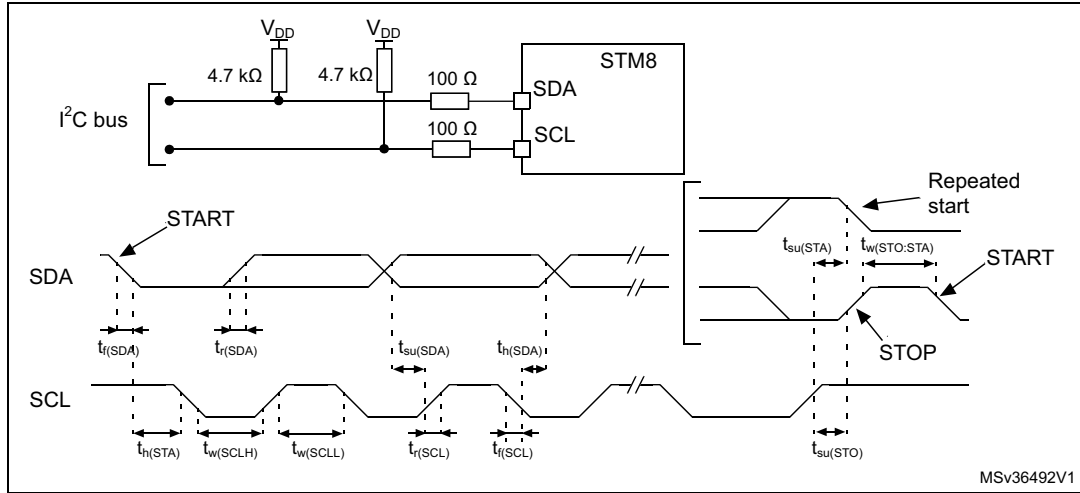
**Note:**

*For speeds around 200 kHz, the achieved speed has a  $\pm 5\%$  tolerance.*

*For other speed ranges, the achieved speed has a  $\pm 2\%$  tolerance.*

*The above variations depend on the accuracy of the external components used.*

**Figure 41. Typical application with I<sup>2</sup>C bus and timing diagram<sup>(1)</sup>**



1. Measurement points are done at CMOS levels:  $0.3 \times V_{DD}$  and  $0.7 \times V_{DD}$



### 9.3.9 LCD controller (STM8AL3LE8x only)

In the following table, data are guaranteed by design, not tested in production.

**Table 48. LCD characteristics**

| Symbol         | Parameter                                         | Min. | Typ.           | Max.       | Unit      |
|----------------|---------------------------------------------------|------|----------------|------------|-----------|
| $V_{LCD}$      | LCD external voltage                              | -    | -              | 3.6        | V         |
| $V_{LCD0}$     | LCD internal reference voltage 0                  | -    | 2.6            | -          |           |
| $V_{LCD1}$     | LCD internal reference voltage 1                  | -    | 2.7            | -          |           |
| $V_{LCD2}$     | LCD internal reference voltage 2                  | -    | 2.8            | -          |           |
| $V_{LCD3}$     | LCD internal reference voltage 3                  | -    | 3.0            | -          |           |
| $V_{LCD4}$     | LCD internal reference voltage 4                  | -    | 3.1            | -          |           |
| $V_{LCD5}$     | LCD internal reference voltage 5                  | -    | 3.2            | -          |           |
| $V_{LCD6}$     | LCD internal reference voltage 6                  | -    | 3.4            | -          |           |
| $V_{LCD7}$     | LCD internal reference voltage 7                  | -    | 3.5            | -          |           |
| $C_{EXT}$      | $V_{LCD}$ external capacitance                    | 0.1  | 1              | 2          | $\mu F$   |
| $I_{DD}$       | Supply current <sup>(1)</sup> at $V_{DD} = 1.8 V$ | -    | 3              | -          | $\mu A$   |
|                | Supply current <sup>(1)</sup> at $V_{DD} = 3 V$   | -    | 3              | -          |           |
| $R_{HN}^{(2)}$ | High value resistive network (low drive)          | -    | 6.6            | -          | $M\Omega$ |
| $R_{LN}^{(3)}$ | Low value resistive network (high drive)          | -    | 240            | -          | $k\Omega$ |
| $V_{33}$       | Segment/Common higher level voltage               | -    | -              | $V_{LCDx}$ | V         |
| $V_{34}$       | Segment/Common 3/4 level voltage                  | -    | $3/4 V_{LCDx}$ | -          |           |
| $V_{23}$       | Segment/Common 2/3 level voltage                  | -    | $2/3 V_{LCDx}$ | -          |           |
| $V_{12}$       | Segment/Common 1/2 level voltage                  | -    | $1/2 V_{LCDx}$ | -          |           |
| $V_{13}$       | Segment/Common 1/3 level voltage                  | -    | $1/3 V_{LCDx}$ | -          |           |
| $V_{14}$       | Segment/Common 1/4 level voltage                  | -    | $1/4 V_{LCDx}$ | -          |           |
| $V_0$          | Segment/Common lowest level voltage               | 0    | -              | -          |           |

1. LCD enabled with 3 V internal booster (LCD\_CR1 = 0x08), 1/4 duty, 1/3 bias, division ratio= 64, all pixels active, no LCD connected.

2.  $R_{HN}$  is the total high value resistive network.

3.  $R_{LN}$  is the total low value resistive network.

#### VLCD external capacitor (STM8AL3LE8x only)

The application achieves a stabilized LCD reference voltage when connecting an external capacitor  $C_{EXT}$  to the  $V_{LCD}$  pin.  $C_{EXT}$  is specified in [Table 48](#).

### 9.3.10 Embedded reference voltage

In the following table, data are based on characterization results, not tested in production, unless otherwise specified.

**Table 49. Reference voltage characteristics**

| Symbol                    | Parameter                                                                                | Conditions                                  | Min.                 | Typ.  | Max.                 | Unit            |
|---------------------------|------------------------------------------------------------------------------------------|---------------------------------------------|----------------------|-------|----------------------|-----------------|
| $I_{REFINT}$              | Internal reference voltage consumption                                                   | -                                           | -                    | 1.4   | -                    | $\mu A$         |
| $T_{S\_VREFINT}^{(1)(2)}$ | ADC sampling time when reading the internal reference voltage                            | -                                           | -                    | 5     | 10                   | $\mu s$         |
| $I_{BUF}^{(1)}$           | Internal reference voltage buffer consumption (used for ADC)                             | -                                           | -                    | 13.5  | 25                   | $\mu A$         |
| $V_{REFINT\ out}$         | Reference voltage output                                                                 | -                                           | 1.202 <sub>(3)</sub> | 1.224 | 1.242 <sub>(3)</sub> | V               |
| $I_{LPBUF}^{(1)}$         | Internal reference voltage low-power buffer consumption (used for comparators or output) | -                                           | -                    | 730   | 1200                 | nA              |
| $I_{REFOUT}^{(1)(4)}$     | Buffer output current                                                                    | -                                           | -                    | -     | 1                    | $\mu A$         |
| $C_{REFOUT}$              | Reference voltage output load                                                            | -                                           | -                    | -     | 50                   | pF              |
| $t_{VREFINT}^{(1)}$       | Internal reference voltage startup time                                                  | -                                           | -                    | 2     | 3                    | ms              |
| $t_{BUFEN}^{(1)(2)}$      | Internal reference voltage buffer startup time once enabled                              | -                                           | -                    | -     | 10                   | $\mu s$         |
| $ACC_{VREFINT}^{(5)}$     | Accuracy of $V_{REFINT}$ stored in the $VREFINT\_Factory\_CONV$ byte                     | -                                           | -                    | -     | $\pm 5$              | mV              |
| $STAB_{VREFINT}$          | Stability of $V_{REFINT}$ over temperature                                               | $-40\ ^\circ C \leq T_A \leq 125\ ^\circ C$ | -                    | 20    | 50                   | ppm/ $^\circ C$ |
|                           | Stability of $V_{REFINT}$ over temperature                                               | $0\ ^\circ C \leq T_A \leq 50\ ^\circ C$    | -                    | -     | 20                   | ppm/ $^\circ C$ |
| $STAB_{VREFINT}$          | Stability of $V_{REFINT}$ after 1000 hours                                               | -                                           | -                    | -     | TBD                  | ppm             |

1. Guaranteed by design.
2. Defined when ADC output reaches its final value  $\pm 1/2LSB$
3. Tested in production at  $V_{DD} = 3\ V \pm 10\ mV$ .
4. To guarantee less than 1%  $V_{REFOUT}$  deviation
5. Measured at  $V_{DD} = 3\ V \pm 10\ mV$ . This value takes into account  $V_{DD}$  accuracy and ADC conversion accuracy.

### 9.3.11 Temperature sensor

In the following table, data are based on characterization results, not tested in production, unless otherwise specified.

**Table 50. TS characteristics**

| Symbol                   | Parameter                                             | Min.                | Typ.  | Max.                | Unit  |
|--------------------------|-------------------------------------------------------|---------------------|-------|---------------------|-------|
| $V_{125}^{(1)}$          | Sensor reference voltage at 125°C<br>±5 °C,           | 0.640               | 0.660 | 0.680               | V     |
| $T_L$                    | $V_{\text{SENSOR}}$ linearity with temperature        | -                   | ±1    | ±2                  | °C    |
| Avg_slope                | Average slope                                         | 1.59 <sup>(2)</sup> | 1.62  | 1.65 <sup>(2)</sup> | mV/°C |
| $I_{DD(\text{TEMP})}$    | Consumption                                           | -                   | 3.4   | 6 <sup>(2)</sup>    | μA    |
| $T_{\text{START}}^{(3)}$ | Temperature sensor startup time                       | -                   | -     | 10 <sup>(2)</sup>   | μs    |
| $T_{S\_TEMP}$            | ADC sampling time when reading the temperature sensor | -                   | 5     | 10 <sup>(2)</sup>   | μs    |

1. Tested in production at  $V_{DD} = 3 \text{ V} \pm 10 \text{ mV}$ . The 8 LSB of the  $V_{125}$  ADC conversion result are stored in the TS\_Factory\_CONV\_V125 byte.

2. Guaranteed by design.

3. Defined for ADC output reaching its final value ±1/2LSB.

### 9.3.12 Comparator characteristics

In the following table, data are guaranteed by design, not tested in production.

**Table 51. Comparator 1 characteristics**

| Symbol                  | Parameter                                                      | Conditions                                                                                                     | Min <sup>(1)</sup> | Typ | Max <sup>(1)</sup> | Unit      |
|-------------------------|----------------------------------------------------------------|----------------------------------------------------------------------------------------------------------------|--------------------|-----|--------------------|-----------|
| $V_{DDA}$               | Analog supply voltage                                          | -                                                                                                              | 1.65               |     | 3.6                | V         |
| $R_{400K}$              | $R_{400K}$ value                                               | -                                                                                                              | -                  | 400 | -                  | kΩ        |
| $R_{10K}$               | $R_{10K}$ value                                                | -                                                                                                              | -                  | 10  | -                  |           |
| $V_{IN}$                | Comparator 1 input voltage range                               | -                                                                                                              | 0.6                |     | $V_{DDA}$          | V         |
| $t_{\text{START}}$      | Comparator startup time                                        | -                                                                                                              | -                  | 7   | 10                 | μs        |
| $t_d$                   | Propagation delay <sup>(2)</sup>                               | -                                                                                                              | -                  | 3   | 10                 |           |
| $V_{\text{offset}}$     | Comparator offset                                              | -                                                                                                              | -                  | ±3  | ±10                | mV        |
| $d_{\text{Voffset}}/dt$ | Comparator offset variation in worst voltage stress conditions | $V_{DDA} = 3.6 \text{ V}$<br>$V_{IN+} = 0 \text{ V}$<br>$V_{IN-} = V_{\text{REFINT}}$<br>$T_A = 25 \text{ °C}$ | 0                  | 1.5 | 10                 | mV/1000 h |
| $I_{\text{COMP1}}$      | Current consumption <sup>(3)</sup>                             | -                                                                                                              | -                  | 160 | 260                | nA        |

1. Guaranteed by characterization results .

2. The delay is characterized for 100 mV input step with 10 mV overdrive on the inverting input, the non-inverting input set to the reference.

3. Comparator consumption only. Internal reference voltage not included.

In the following table, data are guaranteed by design, not tested in production, unless otherwise specified.

**Table 52. Comparator 2 characteristics**

| Symbol             | Parameter                                     | Conditions                                                                                                                  | Min  | Typ     | Max <sup>(1)</sup> | Unit            |
|--------------------|-----------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------|------|---------|--------------------|-----------------|
| $V_{DDA}$          | Analog supply voltage                         | -                                                                                                                           | 1.65 | -       | 3.6                | V               |
| $V_{IN}$           | Comparator 2 input voltage range              | -                                                                                                                           | 0    | -       | $V_{DDA}$          | V               |
| $t_{START}$        | Comparator startup time                       | Fast mode                                                                                                                   | -    | 15      | 20                 | $\mu s$         |
|                    |                                               | Slow mode                                                                                                                   | -    | 20      | 25                 |                 |
| $t_{d\ slow}$      | Propagation delay <sup>(2)</sup> in slow mode | $1.65\ V \leq V_{DDA} \leq 2.7\ V$                                                                                          | -    | 1.8     | 3.5                |                 |
|                    |                                               | $2.7\ V \leq V_{DDA} \leq 3.6\ V$                                                                                           | -    | 2.5     | 6                  |                 |
| $t_{d\ fast}$      | Propagation delay <sup>(2)</sup> in fast mode | $1.65\ V \leq V_{DDA} \leq 2.7\ V$                                                                                          | -    | 0.8     | 2                  |                 |
|                    |                                               | $2.7\ V \leq V_{DDA} \leq 3.6\ V$                                                                                           | -    | 1.2     | 4                  |                 |
| $V_{offset}$       | Comparator offset error                       | -                                                                                                                           | -    | $\pm 4$ | $\pm 20$           | mV              |
| $d_{Threshold}/dt$ | Threshold voltage temperature coefficient     | $V_{DDA} = 3.3V$<br>$T_A = 0\ \text{to}\ 50\ ^\circ C$<br>$V_- = V_{REF+}, 3/4$<br>$V_{REF+}, 1/2\ V_{REF+}, 1/4\ V_{REF+}$ | -    | 15      | 30                 | ppm/ $^\circ C$ |
| $I_{COMP2}$        | Current consumption <sup>(3)</sup>            | Fast mode                                                                                                                   | -    | 3.5     | 5                  | $\mu A$         |
|                    |                                               | Slow mode                                                                                                                   | -    | 0.5     | 2                  |                 |

1. Guaranteed by characterization results.
2. The delay is characterized for 100 mV input step with 10 mV overdrive on the inverting input, the non-inverting input set to the reference.
3. Comparator consumption only. Internal reference voltage (necessary for comparator operation) is not included.

### 9.3.13 12-bit DAC characteristics

In the following table, data are guaranteed by design, not tested in production.

**Table 53. DAC characteristics**

| Symbol                 | Parameter                                                                                                                                                      | Conditions                                       | Min. | Typ. | Max.               | Unit         |
|------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------------------|------|------|--------------------|--------------|
| $V_{DDA}$              | Analog supply voltage                                                                                                                                          | -                                                | 1.8  | -    | 3.6                | V            |
| $V_{REF+}$             | Reference supply voltage                                                                                                                                       | -                                                | 1.8  | -    | $V_{DDA}$          |              |
| $I_{VREF}$             | Current consumption on $V_{REF+}$ supply                                                                                                                       | $V_{REF+} = 3.3$ V, no load, middle code (0x800) | -    | 130  | 220                | $\mu$ A      |
|                        |                                                                                                                                                                | $V_{REF+} = 3.3$ V, no load, worst code (0x000)  | -    | 220  | 350                |              |
| $I_{VDDA}$             | Current consumption on $V_{DDA}$ supply                                                                                                                        | $V_{DDA} = 3.3$ V, no load, middle code (0x800)  | -    | 210  | 320                |              |
|                        |                                                                                                                                                                | $V_{DDA} = 3.3$ V, no load, worst code (0x000)   | -    | 320  | 520                |              |
| $T_A$                  | Temperature range                                                                                                                                              | -                                                | -40  | -    | 125                | $^{\circ}$ C |
| $R_L^{(1)(2)}$         | Resistive load                                                                                                                                                 | DACOUT buffer ON                                 | 5    | -    |                    | k $\Omega$   |
| $R_O$                  | Output impedance                                                                                                                                               | DACOUT buffer OFF                                | -    | 8    | 10                 | k $\Omega$   |
| $C_L^{(3)}$            | Capacitive load                                                                                                                                                | -                                                | -    | -    | 50                 | pF           |
| DAC_OUT <sub>(4)</sub> | DAC_OUT voltage                                                                                                                                                | DACOUT buffer ON                                 | 0.2  | -    | $V_{DDA} - 0.2$    | V            |
|                        |                                                                                                                                                                | DACOUT buffer OFF                                | 0    | -    | $V_{REF+} - 1$ LSB | V            |
| $t_{\text{settling}}$  | Settling time (full scale: for a 12-bit input code transition between the lowest and the highest input codes when DAC_OUT reaches the final value $\pm 1$ LSB) | $R_L \geq 5$ k $\Omega$ , $C_L \leq 50$ pF       | -    | 7    | 12                 | $\mu$ s      |
| Update rate            | Max frequency for a correct DAC_OUT (@95%) change when small variation of the input code (from code i to i+1LSB).                                              | $R_L \geq 5$ k $\Omega$ , $C_L \leq 50$ pF       | -    | -    | 1                  | Msp/s        |
| $t_{\text{WAKEUP}}$    | Wakeup time from OFF state. Input code between lowest and highest possible codes.                                                                              | $R_L \geq 5$ k $\Omega$ , $C_L \leq 50$ pF       | -    | 9    | 15                 | $\mu$ s      |
| PSRR+                  | Power supply rejection ratio (to $V_{DDA}$ ) (static DC measurement)                                                                                           | $R_L \geq 5$ k $\Omega$ , $C_L \leq 50$ pF       | -    | -60  | -35                | dB           |

1. Resistive load between DACOUT and GNDA

2. Output on PF0 or PF1

3. Capacitive load at DACOUT pin

4. It gives the output excursion of the DAC

In the following table, data are based on characterization results, not tested in production.

**Table 54. DAC accuracy**

| Symbol     | Parameter                                 | Conditions                                                                                 | Typ.      | Max. <sup>(1)</sup> | Unit          |
|------------|-------------------------------------------|--------------------------------------------------------------------------------------------|-----------|---------------------|---------------|
| DNL        | Differential non linearity <sup>(2)</sup> | $R_L \geq 5 \text{ k}\Omega$ , $C_L \leq 50 \text{ pF}$<br>DACOUT buffer ON <sup>(3)</sup> | 1.5       | 3                   | 12-bit<br>LSB |
|            |                                           | No load<br>DACOUT buffer OFF                                                               | 1.5       | 3                   |               |
| INL        | Integral non linearity <sup>(4)</sup>     | $R_L \geq 5 \text{ k}\Omega$ , $C_L \leq 50 \text{ pF}$<br>DACOUT buffer ON <sup>(3)</sup> | 2         | 4                   |               |
|            |                                           | No load<br>DACOUT buffer OFF                                                               | 2         | 4                   |               |
| Offset     | Offset error <sup>(5)</sup>               | $R_L \geq 5 \text{ k}\Omega$ , $C_L \leq 50 \text{ pF}$<br>DACOUT buffer ON <sup>(3)</sup> | $\pm 10$  | $\pm 25$            |               |
|            |                                           | No load<br>DACOUT buffer OFF                                                               | $\pm 5$   | $\pm 8$             |               |
| Offset1    | Offset error at Code 1 <sup>(6)</sup>     | DACOUT buffer OFF                                                                          | $\pm 1.5$ | $\pm 5$             |               |
| Gain error | Gain error <sup>(7)</sup>                 | $R_L \geq 5 \text{ k}\Omega$ , $C_L \leq 50 \text{ pF}$<br>DACOUT buffer ON <sup>(3)</sup> | +0.1/-0.2 | +0.2/-0.5           | %             |
|            |                                           | No load<br>DACOUT buffer OFF                                                               | +0/-0.2   | +0/-0.4             |               |
| TUE        | Total unadjusted error                    | $R_L \geq 5 \text{ k}\Omega$ , $C_L \leq 50 \text{ pF}$<br>DACOUT buffer ON <sup>(3)</sup> | 12        | 30                  | 12-bit<br>LSB |
|            |                                           | No load -DACOUT buffer OFF                                                                 | 8         | 12                  |               |

1. Not tested in production.

2. Difference between two consecutive codes - 1 LSB.

3. In 48-pin package devices the DAC2 output buffer must be kept off and no load must be applied on the DAC\_OUT2 output.

4. Difference between measured value at Code i and the value at Code i on a line drawn between Code 0 and last Code 1023.

5. Difference between the value measured at Code (0x800) and the ideal value =  $V_{REF+}/2$ .

6. Difference between the value measured at Code (0x001) and the ideal value.

7. Difference between the ideal slope of the transfer function and the measured slope computed from Code 0x000 and 0xFFFF when buffer is ON, and from Code giving 0.2 V and ( $V_{DDA} - 0.2$ ) V when buffer is OFF.

In the following table, data are guaranteed by design, not tested in production.

**Table 55. DAC output on PB4-PB5-PB6<sup>(1)</sup>**

| Symbol    | Parameter                                                     | Conditions                             | Max | Unit      |
|-----------|---------------------------------------------------------------|----------------------------------------|-----|-----------|
| $R_{int}$ | Internal resistance between DAC output and PB4-PB5-PB6 output | $2.7\text{ V} < V_{DD} < 3.6\text{ V}$ | 1.4 | $k\Omega$ |
|           |                                                               | $2.4\text{ V} < V_{DD} < 3.6\text{ V}$ | 1.6 |           |
|           |                                                               | $2.0\text{ V} < V_{DD} < 3.6\text{ V}$ | 3.2 |           |
|           |                                                               | $1.8\text{ V} < V_{DD} < 3.6\text{ V}$ | 8.2 |           |

1. 32 or 28-pin packages only. The DAC channel is routed either on PB4, PB5 or PB6 using the routing interface I/O switch registers.

### 9.3.14 12-bit ADC1 characteristics

In the following table, data are guaranteed by design, not tested in production.

**Table 56. ADC1 characteristics**

| Symbol      | Parameter                           | Conditions                                                    | Min.             | Typ. | Max.                         | Unit               |
|-------------|-------------------------------------|---------------------------------------------------------------|------------------|------|------------------------------|--------------------|
| $V_{DDA}$   | Analog supply voltage               | -                                                             | 1.8              | -    | 3.6                          | V                  |
| $V_{REF+}$  | Reference supply voltage            | $2.4\text{ V} \leq V_{DDA} \leq 3.6\text{ V}$                 | 2.4              | -    | $V_{DDA}$                    | V                  |
|             |                                     | $1.8\text{ V} \leq V_{DDA} \leq 2.4\text{ V}$                 | $V_{DDA}$        |      |                              | V                  |
| $V_{REF-}$  | Lower reference voltage             | -                                                             | $V_{SSA}$        |      |                              | V                  |
| $I_{VDDA}$  | Current on the $V_{DDA}$ input pin  | -                                                             | -                | 1000 | 1450                         | $\mu\text{A}$      |
| $I_{VREF+}$ | Current on the $V_{REF+}$ input pin | -                                                             | -                | 400  | 700 (peak) <sup>(1)</sup>    | $\mu\text{A}$      |
|             |                                     | -                                                             | -                |      | 450 (average) <sup>(1)</sup> | $\mu\text{A}$      |
| $V_{AIN}$   | Conversion voltage range            | -                                                             | 0 <sup>(2)</sup> | -    | $V_{REF+}$                   |                    |
| $T_A$       | Temperature range                   | -                                                             | -40              | -    | 125                          | $^{\circ}\text{C}$ |
| $R_{AIN}$   | External resistance on $V_{AIN}$    | on PF0/1/2/3 fast channels                                    | -                | -    | 50 <sup>(3)</sup>            | $\text{k}\Omega$   |
|             |                                     | on all other channels                                         | -                | -    |                              |                    |
| $C_{ADC}$   | Internal sample and hold capacitor  | on PF0/1/2/3 fast channels                                    | -                | 16   | -                            | $\text{pF}$        |
|             |                                     | on all other channels                                         | -                |      | -                            |                    |
| $f_{ADC}$   | ADC sampling clock frequency        | $2.4\text{ V} \leq V_{DDA} \leq 3.6\text{ V}$ without zooming | 0.320            | -    | 16                           | MHz                |
|             |                                     | $1.8\text{ V} \leq V_{DDA} \leq 2.4\text{ V}$ with zooming    | 0.320            | -    | 8                            | MHz                |
| $f_{CONV}$  | 12-bit conversion rate              | $V_{AIN}$ on PF0/1/2/3 fast channels                          | -                | -    | 1 <sup>(3)(4)</sup>          | MHz                |
|             |                                     | $V_{AIN}$ on all other channels                               | -                | -    | 760 <sup>(3)(4)</sup>        | kHz                |
| $f_{TRIG}$  | External trigger frequency          | -                                                             | -                | -    | $t_{conv}$                   | $1/f_{ADC}$        |
| $t_{LAT}$   | External trigger latency            | -                                                             | -                | -    | 3.5                          | $1/f_{SYSCLK}$     |



Table 56. ADC1 characteristics (continued)

| Symbol           | Parameter                               | Conditions                                                             | Min.                       | Typ. | Max.                              | Unit    |
|------------------|-----------------------------------------|------------------------------------------------------------------------|----------------------------|------|-----------------------------------|---------|
| $t_S$            | Sampling time                           | $V_{AIN}$ PF0/1/2/3 fast channels<br>$V_{DDA} < 2.4$ V                 | 0.43 <sup>(3)(4)</sup>     | -    | -                                 | $\mu s$ |
|                  |                                         | $V_{AIN}$ PF0/1/2/3 fast channels<br>$2.4$ V $\leq V_{DDA} \leq 3.6$ V | 0.22 <sup>(3)(4)</sup>     | -    | -                                 |         |
|                  |                                         | $V_{AIN}$ on slow channels<br>$V_{DDA} < 2.4$ V                        | 0.86 <sup>(3)(4)</sup>     | -    | -                                 |         |
|                  |                                         | $V_{AIN}$ on slow channels<br>$2.4$ V $\leq V_{DDA} \leq 3.6$ V        | 0.41 <sup>(3)(4)</sup>     | -    | -                                 |         |
| $t_{conv}$       | 12-bit conversion time                  | -                                                                      | 12000000 / $f_{ADC} + t_S$ |      |                                   | $\mu s$ |
|                  |                                         | 16 MHz                                                                 | 1 <sup>(3)</sup>           | -    | -                                 |         |
| $t_{WKUP}$       | Wakeup time from OFF state              | -                                                                      | -                          | -    | 3                                 | $\mu s$ |
| $t_{IDLE}^{(5)}$ | Time before a new conversion            | -                                                                      | -                          | -    | $\infty$                          | s       |
| $t_{VREFINT}$    | Internal reference voltage startup time | -                                                                      | -                          | -    | refer to <a href="#">Table 49</a> | ms      |

- The current consumption through  $V_{REF}$  is composed of two parameters:  
 - one constant (max 300  $\mu A$ )  
 - one variable (max 400  $\mu A$ ), only during sampling time + 2 first conversion pulses.  
 So, peak consumption is 300+400 = 700  $\mu A$  and average consumption is 300 + [(4 sampling + 2) / 16] x 400 = 450  $\mu A$  at 1MSPS
- $V_{REF-}$  must be tied to ground.
- Minimum sampling and conversion time is reached for maximum  $R_{AIN} = 0.5$  k $\Omega$ .
- Value obtained for continuous conversion on fast channel.
- In the RM0031,  $t_{IDLE}$  defines the time between 2 conversions, or between ADC ON and the first conversion.  $t_{IDLE}$  is not relevant for this device.

In the following three tables, data are guaranteed by characterization result, not tested in production.

**Table 57. ADC1 accuracy with  $V_{DDA} = 3.3\text{ V}$  to  $2.5\text{ V}$**

| Symbol | Parameter                  | Conditions                | Typ. | Max. <sup>(1)</sup> | Unit |
|--------|----------------------------|---------------------------|------|---------------------|------|
| DNL    | Differential non linearity | f <sub>ADC</sub> = 16 MHz | 1    | 1.6                 | LSB  |
|        |                            | f <sub>ADC</sub> = 8 MHz  | 1    | 1.6                 |      |
|        |                            | f <sub>ADC</sub> = 4 MHz  | 1    | 1.5                 |      |
| INL    | Integral non linearity     | f <sub>ADC</sub> = 16 MHz | 1.2  | 2                   |      |
|        |                            | f <sub>ADC</sub> = 8 MHz  | 1.2  | 1.8                 |      |
|        |                            | f <sub>ADC</sub> = 4 MHz  | 1.2  | 1.7                 |      |
| TUE    | Total unadjusted error     | f <sub>ADC</sub> = 16 MHz | 2.2  | 3.0                 |      |
|        |                            | f <sub>ADC</sub> = 8 MHz  | 1.8  | 2.5                 |      |
|        |                            | f <sub>ADC</sub> = 4 MHz  | 1.8  | 2.3                 |      |
| Offset | Offset error               | f <sub>ADC</sub> = 16 MHz | 1.5  | 2                   | LSB  |
|        |                            | f <sub>ADC</sub> = 8 MHz  | 1    | 1.5                 |      |
|        |                            | f <sub>ADC</sub> = 4 MHz  | 0.7  | 1.2                 |      |
| Gain   | Gain error                 | f <sub>ADC</sub> = 16 MHz | 1    | 1.5                 |      |
|        |                            | f <sub>ADC</sub> = 8 MHz  |      |                     |      |
|        |                            | f <sub>ADC</sub> = 4 MHz  |      |                     |      |

1. Guaranteed by characterization results.

**Table 58. ADC1 accuracy with  $V_{DDA} = 2.4\text{ V}$  to  $3.6\text{ V}$**

| Symbol | Parameter                  | Typ. | Max. <sup>(1)</sup> | Unit |
|--------|----------------------------|------|---------------------|------|
| DNL    | Differential non linearity | 1    | 2                   | LSB  |
| INL    | Integral non linearity     | 1.7  | 3                   | LSB  |
| TUE    | Total unadjusted error     | 2    | 4                   | LSB  |
| Offset | Offset error               | 1    | 2                   | LSB  |
| Gain   | Gain error                 | 1.5  | 3                   | LSB  |

1. Guaranteed by characterization results.

**Table 59. ADC1 accuracy with  $V_{DDA} = V_{\text{REF}}^+ = 1.8\text{ V}$  to  $2.4\text{ V}$**

| Symbol | Parameter                  | Typ. | Max. <sup>(1)</sup> | Unit |
|--------|----------------------------|------|---------------------|------|
| DNL    | Differential non linearity | 1    | 2                   | LSB  |
| INL    | Integral non linearity     | 2    | 3                   | LSB  |
| TUE    | Total unadjusted error     | 3    | 5                   | LSB  |

Table 59. ADC1 accuracy with  $V_{DDA} = V_{REF+} = 1.8 \text{ V to } 2.4 \text{ V}$  (continued)

| Symbol | Parameter    | Typ. | Max. <sup>(1)</sup> | Unit |
|--------|--------------|------|---------------------|------|
| Offset | Offset error | 2    | 3                   | LSB  |
| Gain   | Gain error   | 2    | 3                   | LSB  |

1. Guaranteed by characterization results.

Figure 42. ADC1 accuracy characteristics

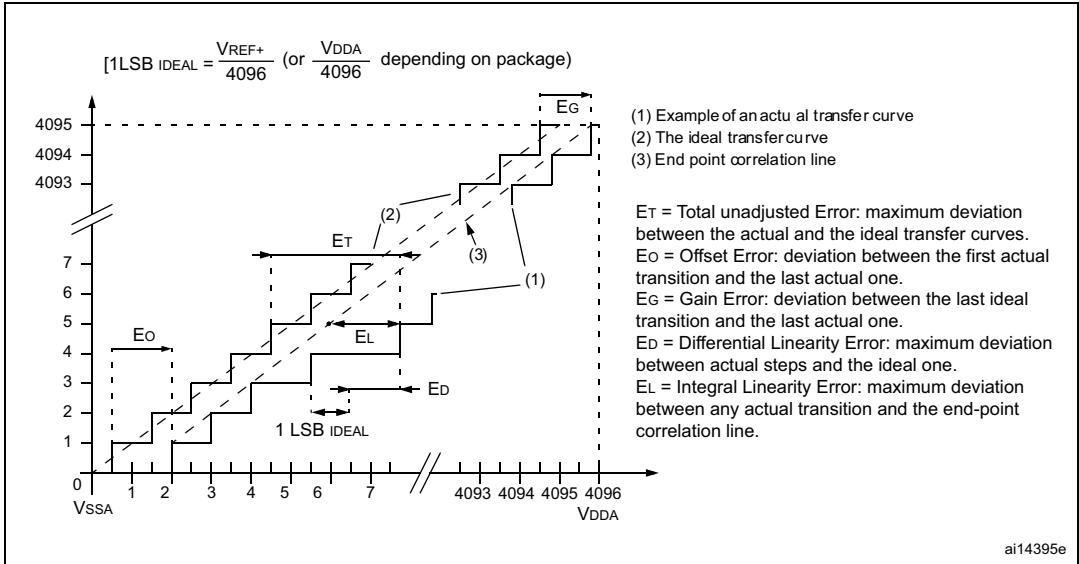
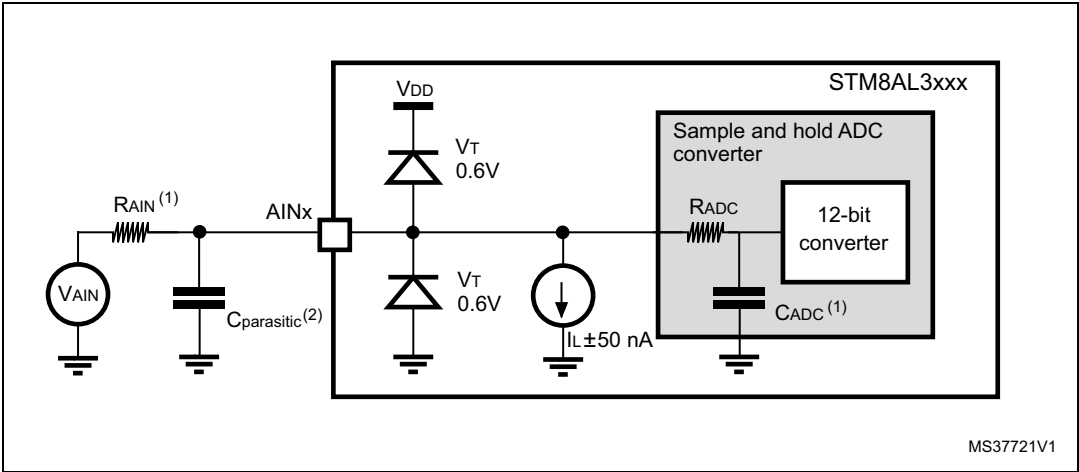


Figure 43. Typical connection diagram using the ADC

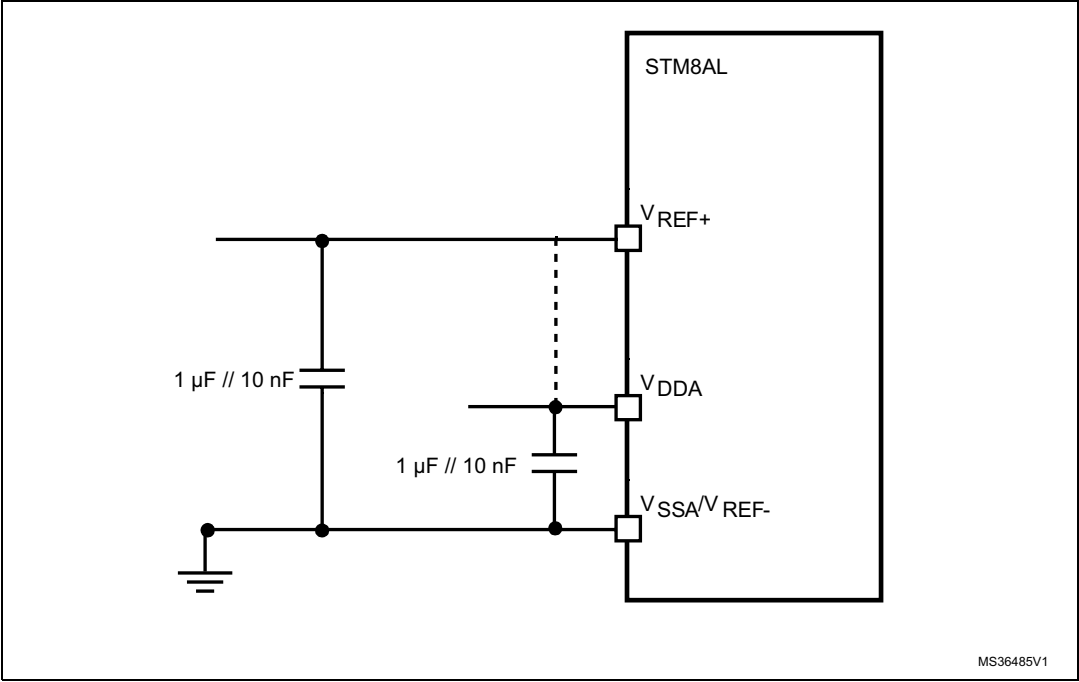


1. Refer to [Table 56](#) for the values of  $R_{AIN}$  and  $C_{ADC}$ .
2.  $C_{parasitic}$  represents the capacitance of the PCB (dependent on soldering and PCB layout quality) plus the pad capacitance (roughly 7 pF). A high  $C_{parasitic}$  value will downgrade conversion accuracy. To remedy this,  $f_{ADC}$  should be reduced.

### General PCB design guidelines

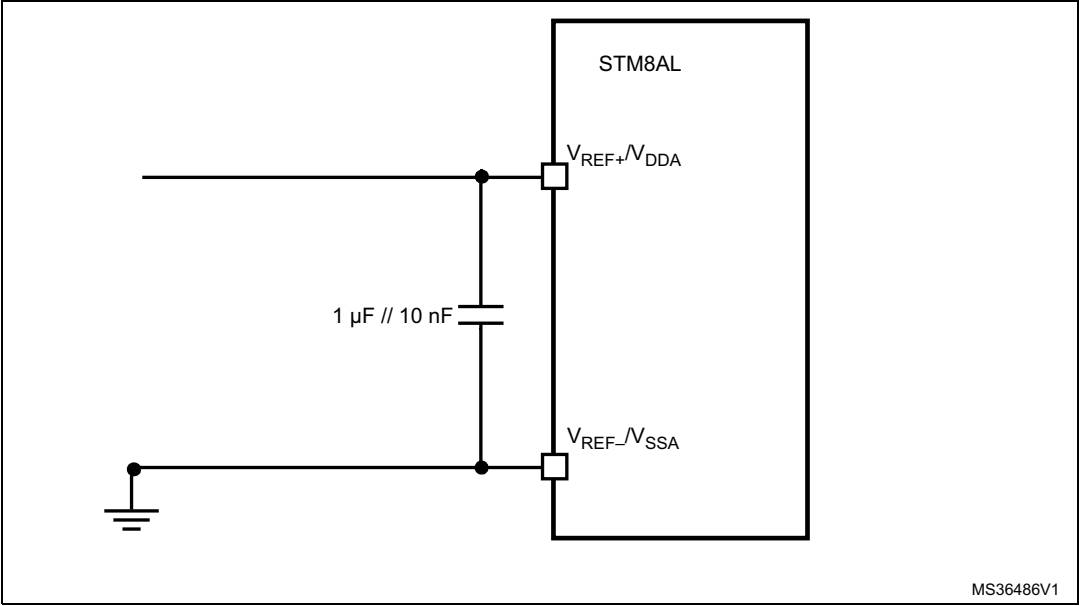
Power supply decoupling should be performed as shown in [Figure 44](#) or [Figure 45](#), depending on whether  $V_{REF+}$  is connected to  $V_{DDA}$  or not. Good quality ceramic 10 nF capacitors should be used. They should be placed as close as possible to the chip.

Figure 44. Power supply and reference decoupling ( $V_{REF+}$  not connected to  $V_{DDA}$ )



MS36485V1

Figure 45. Power supply and reference decoupling ( $V_{REF+}$  connected to  $V_{DDA}$ )



MS36486V1

### 9.3.15 EMC characteristics

Susceptibility tests are performed on a sample basis during product characterization.

#### Functional EMS (electromagnetic susceptibility)

Based on a simple running application on the product (toggling 2 LEDs through I/O ports), the product is stressed by two electromagnetic events until a failure occurs (indicated by the LEDs).

- **ESD:** Electrostatic discharge (positive and negative) is applied on all pins of the device until a functional disturbance occurs. This test conforms to the ANSI/ESDA/JEDEC JS-001, JESD22-A115 and ANSI/ESD S5.3.1.
- **FTB:** A burst of fast transient voltage (positive and negative) is applied to  $V_{DD}$  and  $V_{SS}$  through a 100 pF capacitor, until a functional disturbance occurs. This test conforms with the IEC 61000 standard.

A device reset allows normal operations to be resumed. The test results are given in the table below based on the EMS levels and classes defined in application note AN1709.

#### Designing hardened software to avoid noise problems

EMC characterization and optimization are performed at component level with a typical application environment and simplified MCU software. It should be noted that good EMC performance is highly dependent on the user application and the software in particular.

Therefore it is recommended that the user applies EMC software optimization and prequalification tests in relation with the EMC level requested for his application.

#### Prequalification trials:

Most of the common failures (unexpected reset and program counter corruption) are reproduced by manually forcing a low state on the NRST pin or the Oscillator pins for 1 second.

To complete these trials, ESD stress is applied directly on the device, over the range of specification values. When unexpected behavior is detected, the software is hardened to prevent unrecoverable errors occurring (see application note AN1015).

**Table 60. EMS data**

| Symbol     | Parameter                                                                                                                         | Conditions                                                                                                              |           | Level/<br>Class |
|------------|-----------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------|-----------|-----------------|
| $V_{FESD}$ | Voltage limits to be applied on any I/O pin to induce a functional disturbance                                                    | $V_{DD} = 3.3\text{ V}$ , $T_A = +25\text{ }^{\circ}\text{C}$ ,<br>$f_{CPU} = 16\text{ MHz}$ ,<br>conforms to IEC 61000 |           | 2B              |
| $V_{EFTB}$ | Fast transient voltage burst limits to be applied through 100 pF on $V_{DD}$ and $V_{SS}$ pins to induce a functional disturbance | $V_{DD} = 3.3\text{ V}$ , $T_A = +25\text{ }^{\circ}\text{C}$ ,<br>$f_{CPU} = 16\text{ MHz}$ ,<br>conforms to IEC 61000 | Using HSI | 4A              |
|            |                                                                                                                                   |                                                                                                                         | Using HSE | 2B              |

**Electromagnetic interference (EMI)**

Based on a simple application running on the product (toggling 2 LEDs through the I/O ports), the product is monitored in terms of emission. This emission test is in line with the norm IEC61967-2 which specifies the board and the loading of each pin.

**Table 61. EMI data <sup>(1)</sup>**

| Symbol           | Parameter  | Conditions                                                                                    | Monitored frequency band | Max vs. | Unit |
|------------------|------------|-----------------------------------------------------------------------------------------------|--------------------------|---------|------|
|                  |            |                                                                                               |                          | 16 MHz  |      |
| S <sub>EMI</sub> | Peak level | V <sub>DD</sub> = 3.6 V,<br>T <sub>A</sub> = +25 °C,<br>LQFP80<br>conforming to<br>IEC61967-2 | 0.1 MHz to 30 MHz        | 10      | dBμV |
|                  |            |                                                                                               | 30 MHz to 130 MHz        | 4       |      |
|                  |            |                                                                                               | 130 MHz to 1 GHz         | 1       |      |
|                  |            |                                                                                               | EMI Level                | 1.5     | -    |

1. Guaranteed by characterization results.

**Absolute maximum ratings (electrical sensitivity)**

Based on two different tests (ESD and LU) using specific measurement methods, the product is stressed in order to determine its performance in terms of electrical sensitivity. For more details, refer to the application note AN1181.

**Electrostatic discharge (ESD)**

Electrostatic discharges (a positive then a negative pulse separated by 1 second) are applied to the pins of each sample according to each pin combination. The sample size depends on the number of supply pins in the device (3 parts\*(n+1) supply pin). Two models are simulated: human body model and charge device model. This test conforms to the ANSI/ESDA/JEDEC JS-001, JESD22-A115 and ANSI/ESD S5.3.1.

**Table 62. ESD absolute maximum ratings**

| Symbol                | Ratings                                               | Conditions                                                   | Class | Maximum value <sup>(1)</sup> | Unit |
|-----------------------|-------------------------------------------------------|--------------------------------------------------------------|-------|------------------------------|------|
| V <sub>ESD(HBM)</sub> | Electrostatic discharge voltage (human body model)    | T <sub>A</sub> = 25 °C, conforming to ANSI/ESDA/JEDEC JS-001 | 2     | 2000                         | V    |
| V <sub>ESD(CDM)</sub> | Electrostatic discharge voltage (charge device model) | T <sub>A</sub> = 25 °C, conforming to ANSI/ESD S5.3.1        | C4B   | 500                          |      |
| V <sub>ESD(MM)</sub>  | Electrostatic discharge voltage (machine model)       | T <sub>A</sub> = 25 °C, conforming to JESD22-A115            | M2    | 200                          |      |

1. Guaranteed by characterization results.

### Static latch-up

- **LU:** 3 complementary static tests are required on 10 parts to assess the latch-up performance. A supply overvoltage (applied to each power supply pin) and a current injection (applied to each input, output and configurable I/O pin) are performed on each sample. This test conforms to the EIA/JESD 78 IC latch-up standard. For more details, refer to the application note AN1181.

**Table 63. Electrical sensitivities**

| Symbol | Parameter             | Conditions              | Class <sup>(1)</sup> |
|--------|-----------------------|-------------------------|----------------------|
| LU     | Static latch-up class | T <sub>A</sub> = 125 °C | A                    |

1. Class description: the class is an STMicroelectronics internal specification. The class limits are higher than the JEDEC specifications, that means when a device belongs to class A it exceeds the JEDEC standard. B class strictly covers all the JEDEC criteria (international standard).

## 9.4 Thermal characteristics

The maximum chip junction temperature (T<sub>Jmax</sub>) must never exceed the values given in [Table 19: General operating conditions on page 69](#).

The maximum chip-junction temperature, T<sub>Jmax</sub>, in degree Celsius, may be calculated using the following equation:

$$T_{Jmax} = T_{Amax} + (P_{Dmax} \times \Theta_{JA})$$

Where:

- T<sub>Amax</sub> is the maximum ambient temperature in °C
- $\Theta_{JA}$  is the package junction-to-ambient thermal resistance in °C/W
- P<sub>Dmax</sub> is the sum of P<sub>INTmax</sub> and P<sub>I/Omax</sub> (P<sub>Dmax</sub> = P<sub>INTmax</sub> + P<sub>I/Omax</sub>)
- P<sub>INTmax</sub> is the product of I<sub>DD</sub> and V<sub>DD</sub>, expressed in Watts. This is the maximum chip internal power.
- P<sub>I/Omax</sub> represents the maximum power dissipation on output pins

Where:

$$P_{I/Omax} = \Sigma (V_{OL} \cdot I_{OL}) + \Sigma ((V_{DD} - V_{OH}) \cdot I_{OH}),$$

taking into account the actual V<sub>OL</sub>/I<sub>OL</sub> and V<sub>OH</sub>/I<sub>OH</sub> of the I/Os at low and high-level in the application.

**Table 64. Thermal characteristics<sup>(1)</sup>**

| Symbol        | Parameter                                                  | Value | Unit |
|---------------|------------------------------------------------------------|-------|------|
| $\Theta_{JA}$ | Thermal resistance junction-ambient<br>LQFP48 - 7 x 7 mm   | 65    | °C/W |
| $\Theta_{JA}$ | Thermal resistance junction-ambient<br>LQFP 64- 10 x 10 mm | 48    | °C/W |
| $\Theta_{JA}$ | Thermal resistance junction-ambient<br>LQFP 80- 14 x 14 mm | 38    | °C/W |

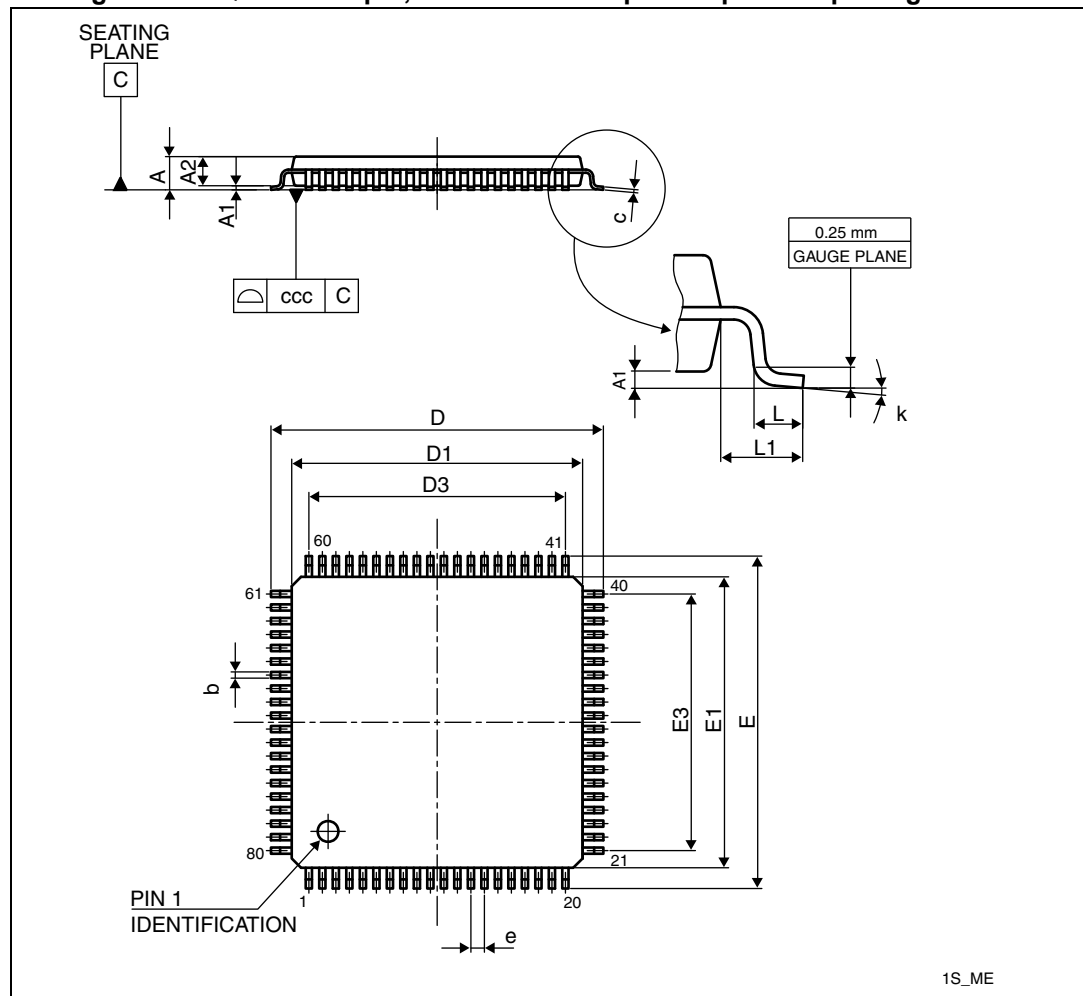
1. Thermal resistances are based on JEDEC JESD51-2 with 4-layer PCB in a natural convection environment.

## 10 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

### 10.1 LQFP80 package information

Figure 46. LQFP80 - 80-pin, 14 x 14 mm low-profile quad flat package outline



1. Drawing is not to scale.

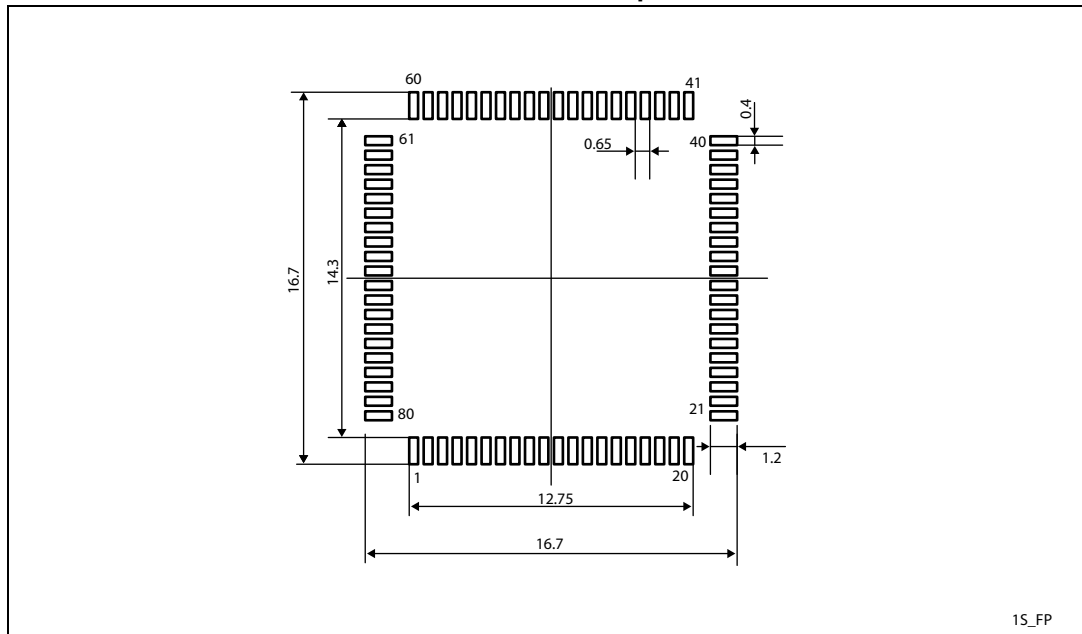


**Table 65. LQFP80 - 80-pin, 14 x 14 mm low-profile quad flat package  
mechanical data<sup>(1)</sup>**

| Symbol | millimeters |        |        | inches |        |        |
|--------|-------------|--------|--------|--------|--------|--------|
|        | Min         | Typ    | Max    | Min    | Typ    | Max    |
| A      | -           | -      | 1.600  | -      | -      | 0.0630 |
| A1     | 0.050       | -      | 0.150  | 0.0020 | -      | 0.0059 |
| A2     | 1.350       | 1.400  | 1.450  | 0.0531 | 0.0551 | 0.0571 |
| b      | 0.220       | 0.320  | 0.380  | 0.0087 | 0.0126 | 0.0150 |
| c      | 0.090       | -      | 0.200  | 0.0035 | -      | 0.0079 |
| D      | 15.800      | 16.000 | 16.200 | 0.6220 | 0.6299 | 0.6378 |
| D1     | 13.800      | 14.000 | 14.200 | 0.5433 | 0.5512 | 0.5591 |
| D3     | -           | 12.350 | -      | -      | 0.4862 | -      |
| E      | 15.800      | 16.000 | 16.200 | 0.6220 | 0.6299 | 0.6378 |
| E1     | 13.800      | 14.000 | 14.200 | 0.5433 | 0.5512 | 0.5591 |
| E3     | -           | 12.350 | -      | -      | 0.4862 | -      |
| e      | -           | 0.650  | -      | -      | 0.0256 | -      |
| L      | 0.450       | 0.600  | 0.750  | 0.0177 | 0.0236 | 0.0295 |
| L1     | -           | 1.000  | -      | -      | 0.0394 | -      |
| k      | 0°          | 3.5°   | 7°     | 0°     | 3.5°   | 7°     |
| ccc    | -           | -      | 0.100  | -      | -      | 0.0039 |

1. Values in inches are converted from mm and rounded to 4 decimal digits.

**Figure 47. LQFP80 - 80-pin, 14 x 14 mm low-profile quad flat package recommended footprint**



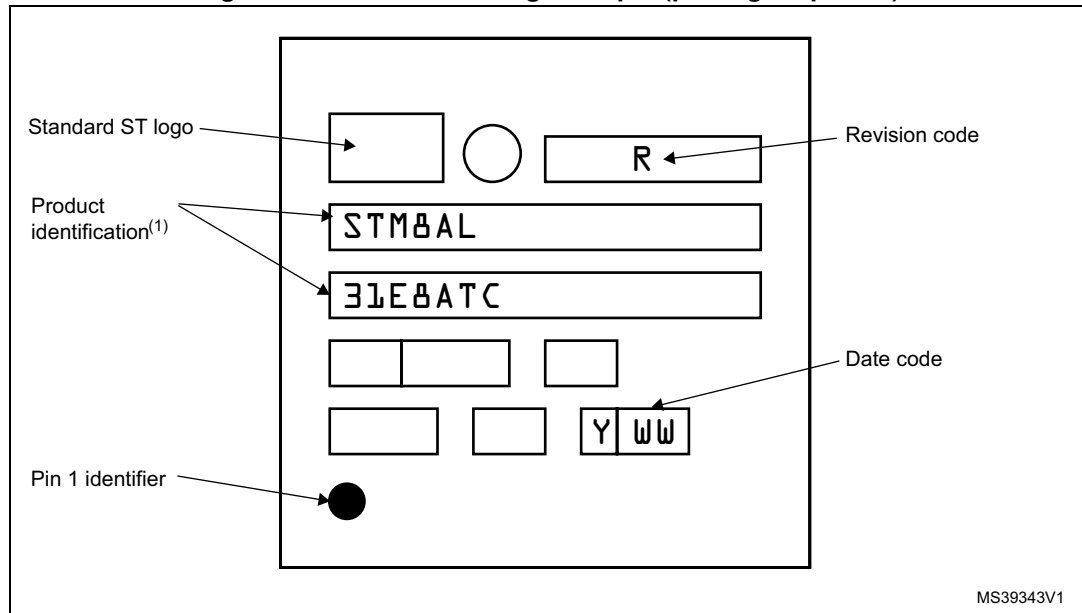
1. Dimensions are expressed in millimeters.

### Device marking

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

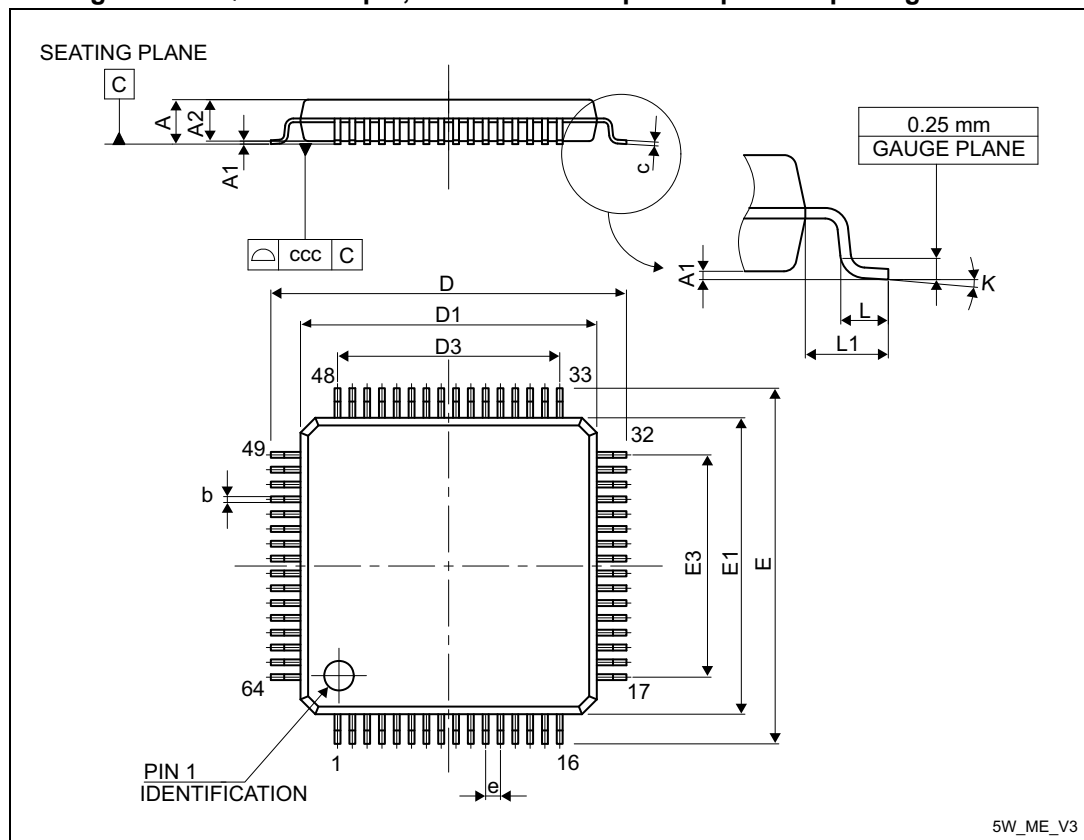
Figure 48. LQFP80 marking example (package top view)



1. Parts marked as "ES", "E" or accompanied by an Engineering Sample notification letter are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST's Quality department must be contacted to run a qualification activity prior to any decision to use these engineering samples.

## 10.2 LQFP64 package information

Figure 49. LQFP64 - 64-pin, 10 x 10 mm low-profile quad flat package outline



1. Drawing is not to scale.

Table 66. LQFP64 - 64-pin, 10 x 10 mm low-profile quad flat package mechanical data

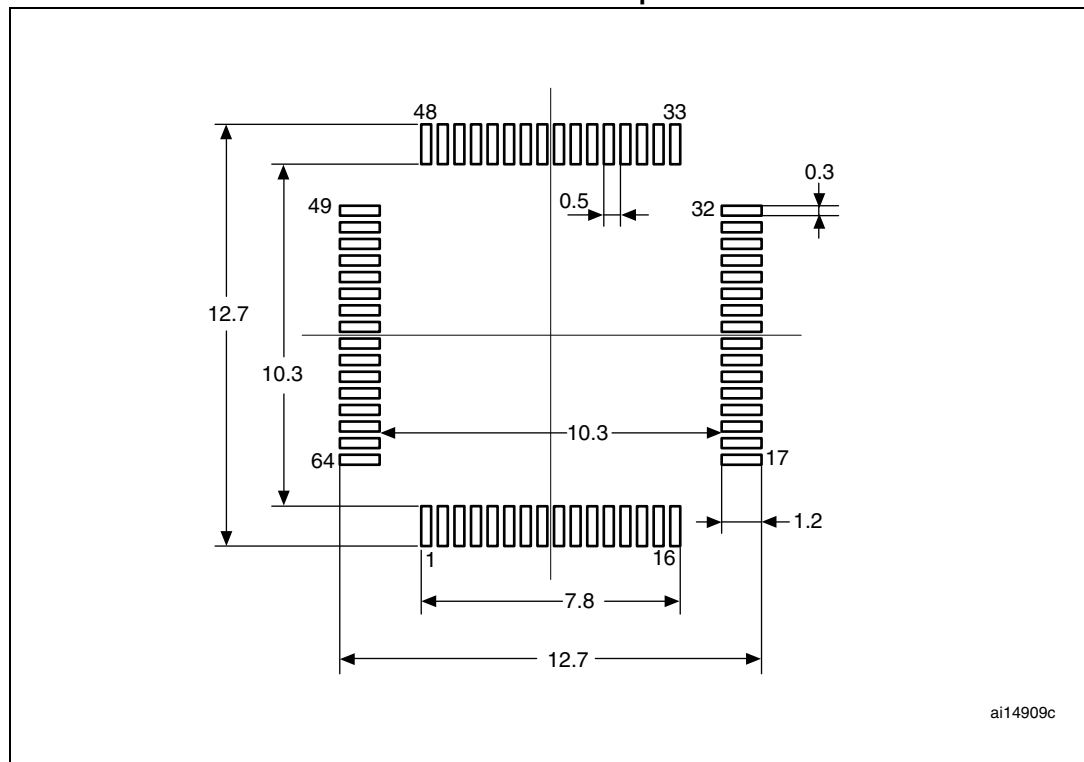
| Symbol | millimeters |        |       | inches <sup>(1)</sup> |        |        |
|--------|-------------|--------|-------|-----------------------|--------|--------|
|        | Min         | Typ    | Max   | Min                   | Typ    | Max    |
| A      | -           | -      | 1.600 | -                     | -      | 0.0630 |
| A1     | 0.050       | -      | 0.150 | 0.0020                | -      | 0.0059 |
| A2     | 1.350       | 1.400  | 1.450 | 0.0531                | 0.0551 | 0.0571 |
| b      | 0.170       | 0.220  | 0.270 | 0.0067                | 0.0087 | 0.0106 |
| c      | 0.090       | -      | 0.200 | 0.0035                | -      | 0.0079 |
| D      | -           | 12.000 | -     | -                     | 0.4724 | -      |
| D1     | -           | 10.000 | -     | -                     | 0.3937 | -      |
| D3     | -           | 7.500  | -     | -                     | 0.2953 | -      |
| E      | -           | 12.000 | -     | -                     | 0.4724 | -      |
| E1     | -           | 10.000 | -     | -                     | 0.3937 | -      |

**Table 66. LQFP64 - 64-pin, 10 x 10 mm low-profile quad flat package mechanical data (continued)**

| Symbol | millimeters |       |       | inches <sup>(1)</sup> |        |        |
|--------|-------------|-------|-------|-----------------------|--------|--------|
|        | Min         | Typ   | Max   | Min                   | Typ    | Max    |
| E3     | -           | 7.500 | -     | -                     | 0.2953 | -      |
| e      | -           | 0.500 | -     | -                     | 0.0197 | -      |
| K      | 0°          | 3.5°  | 7°    | 0°                    | 3.5°   | 7°     |
| L      | 0.450       | 0.600 | 0.750 | 0.0177                | 0.0236 | 0.0295 |
| L1     | -           | 1.000 | -     | -                     | 0.0394 | -      |
| ccc    | -           | -     | 0.080 | -                     | -      | 0.0031 |

1. Values in inches are converted from mm and rounded to 4 decimal digits.

**Figure 50. LQFP64 - 64-pin, 10 x 10 mm low-profile quad flat package recommended footprint**



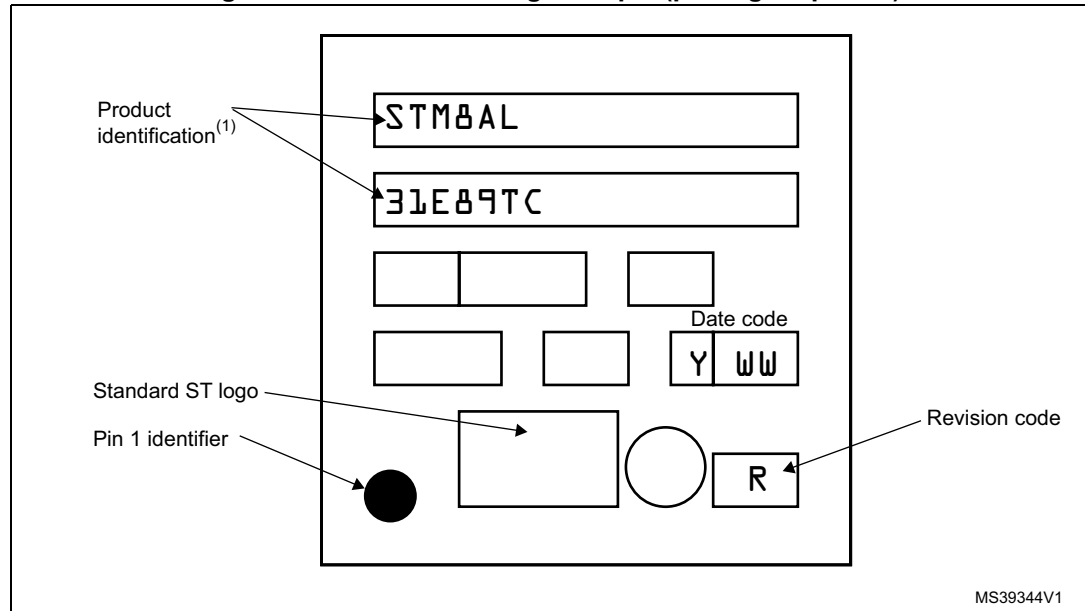
1. Dimensions are expressed in millimeters.

### Device marking

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

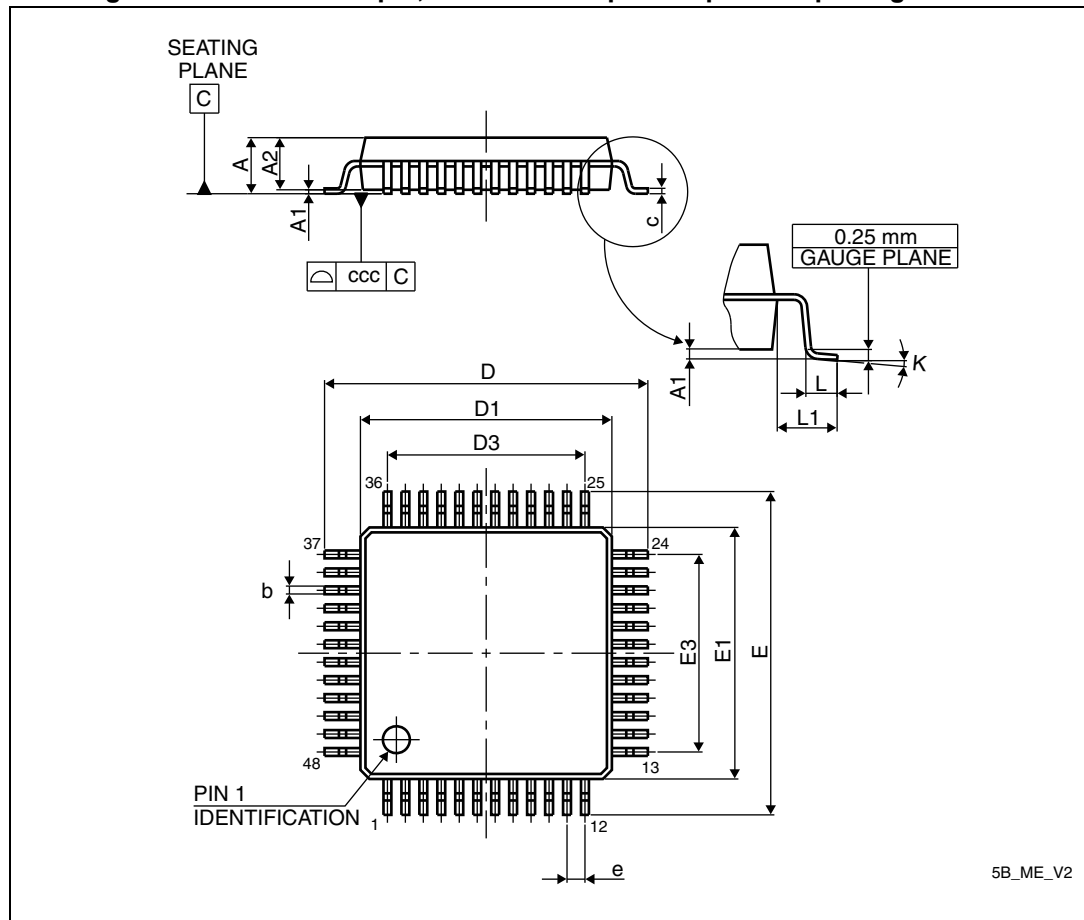
**Figure 51. LQFP64 marking example (package top view)**



1. Parts marked as "ES", "E" or accompanied by an Engineering Sample notification letter are not yet qualified and therefore not approved for use in production. ST is not responsible for any consequences resulting from such use. In no event will ST be liable for the customer using any of these engineering samples in production. ST's Quality department must be contacted to run a qualification activity prior to any decision to use these engineering samples.

### 10.3 LQFP48 package information

Figure 52. LQFP48 - 48-pin, 7 x 7 mm low-profile quad flat package outline



1. Drawing is not to scale.

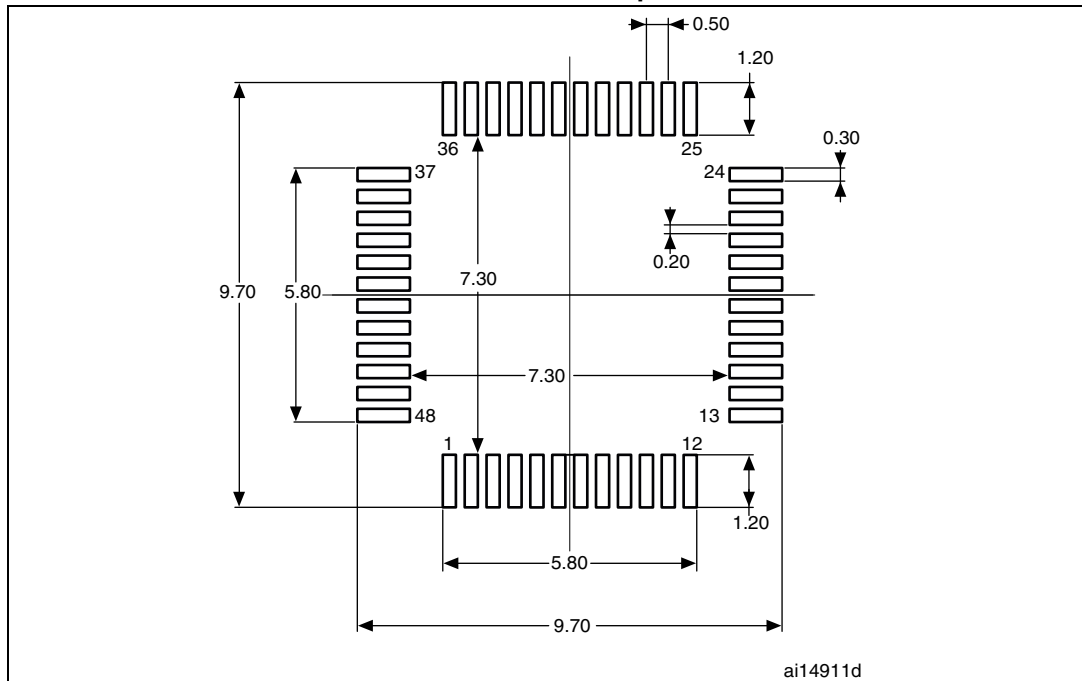
**Table 67. LQFP48 - 48-pin, 7 x 7 mm low-profile quad flat package  
mechanical data**

| Symbol | millimeters |       |       | inches <sup>(1)</sup> |        |        |
|--------|-------------|-------|-------|-----------------------|--------|--------|
|        | Min         | Typ   | Max   | Min                   | Typ    | Max    |
| A      | -           | -     | 1.600 | -                     | -      | 0.0630 |
| A1     | 0.050       | -     | 0.150 | 0.0020                | -      | 0.0059 |
| A2     | 1.350       | 1.400 | 1.450 | 0.0531                | 0.0551 | 0.0571 |
| b      | 0.170       | 0.220 | 0.270 | 0.0067                | 0.0087 | 0.0106 |
| c      | 0.090       | -     | 0.200 | 0.0035                | -      | 0.0079 |
| D      | 8.800       | 9.000 | 9.200 | 0.3465                | 0.3543 | 0.3622 |
| D1     | 6.800       | 7.000 | 7.200 | 0.2677                | 0.2756 | 0.2835 |
| D3     | -           | 5.500 | -     | -                     | 0.2165 | -      |
| E      | 8.800       | 9.000 | 9.200 | 0.3465                | 0.3543 | 0.3622 |
| E1     | 6.800       | 7.000 | 7.200 | 0.2677                | 0.2756 | 0.2835 |
| E3     | -           | 5.500 | -     | -                     | 0.2165 | -      |
| e      | -           | 0.500 | -     | -                     | 0.0197 | -      |
| L      | 0.450       | 0.600 | 0.750 | 0.0177                | 0.0236 | 0.0295 |
| L1     | -           | 1.000 | -     | -                     | 0.0394 | -      |
| k      | 0°          | 3.5°  | 7°    | 0°                    | 3.5°   | 7°     |
| ccc    | -           | -     | 0.080 | -                     | -      | 0.0031 |

1. Values in inches are converted from mm and rounded to 4 decimal digits.



**Figure 53. LQFP48 - 48-pin, 7 x 7 mm low-profile quad flat package  
recommended footprint**



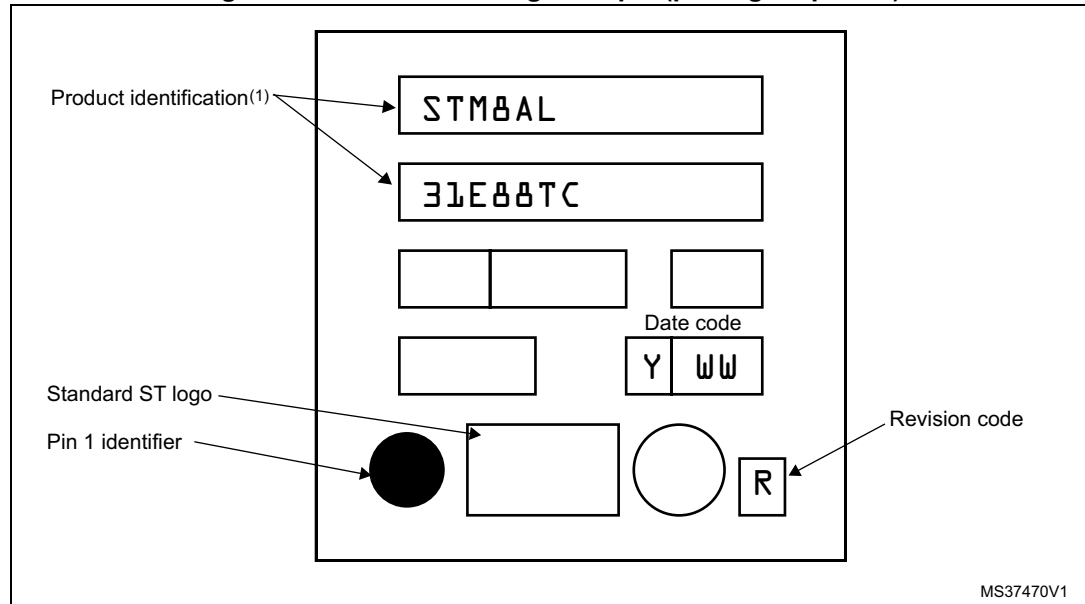
1. Dimensions are expressed in millimeters.

### Device marking

The following figure gives an example of topside marking orientation versus pin 1 identifier location.

Other optional marking or inset/upset marks, which identify the parts throughout supply chain operations, are not indicated below.

**Figure 54. LQFP48 marking example (package top view)**



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# 11 Ordering information

**Table 68. STM8AL31E8x STM8AL3LE8x ordering information scheme**

|                                            |      |    |    |   |   |   |   |   |   |
|--------------------------------------------|------|----|----|---|---|---|---|---|---|
| Example:                                   | STM8 | AL | 31 | E | 8 | 8 | T | C | Y |
| <b>Device family</b>                       |      |    |    |   |   |   |   |   |   |
| STM8 microcontroller                       |      |    |    |   |   |   |   |   |   |
| <b>Product type</b>                        |      |    |    |   |   |   |   |   |   |
| AL = automotive low-power <sup>(1)</sup>   |      |    |    |   |   |   |   |   |   |
| <b>Device subfamily</b>                    |      |    |    |   |   |   |   |   |   |
| 31: standard devices                       |      |    |    |   |   |   |   |   |   |
| 3L: devices with LCD                       |      |    |    |   |   |   |   |   |   |
| <b>AES encryption hardware accelerator</b> |      |    |    |   |   |   |   |   |   |
| E = AES encryption hardware accelerator    |      |    |    |   |   |   |   |   |   |
| <b>Program memory size</b>                 |      |    |    |   |   |   |   |   |   |
| 8 = 64 Kbytes of Flash memory              |      |    |    |   |   |   |   |   |   |
| <b>Pin count</b>                           |      |    |    |   |   |   |   |   |   |
| A = 80 pins                                |      |    |    |   |   |   |   |   |   |
| 9 = 64 pins                                |      |    |    |   |   |   |   |   |   |
| 8 = 48 pins                                |      |    |    |   |   |   |   |   |   |
| <b>Package</b>                             |      |    |    |   |   |   |   |   |   |
| T = LQFP                                   |      |    |    |   |   |   |   |   |   |
| <b>Temperature range</b>                   |      |    |    |   |   |   |   |   |   |
| C = -40 to 125 °C                          |      |    |    |   |   |   |   |   |   |
| A = -40 to 85 °C                           |      |    |    |   |   |   |   |   |   |
| <b>Packing</b>                             |      |    |    |   |   |   |   |   |   |
| Y = tray                                   |      |    |    |   |   |   |   |   |   |
| X = Tape and reel compliant with EIA 481-C |      |    |    |   |   |   |   |   |   |

1. Qualified and characterized according to AECQ100 and Q003 or equivalent, advanced screening according to AEC Q001 and Q002 or equivalent.

For a list of available options (e.g. memory size, package) and orderable part numbers or for further information on any aspect of this device, please go to [www.st.com](http://www.st.com) or contact the nearest ST sales office.

## 12 Revision history

Table 69. Document revision history

| Date        | Revision | Changes                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
|-------------|----------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 22-Apr-2015 | 1        | Initial release.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                         |
| 27-Jul-2015 | 2        | Updated the document confidentiality level to "Public".<br>No other changes in the content.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| 19-Aug-2015 | 3        | Changed datasheet status to "production data".<br>Added LQFP64 and LQFP80 packages together with the corresponding part numbers.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                         |
| 18-Oct-2016 | 4        | <ul style="list-style-type: none"> <li>Updated <a href="#">Table 5: High-density STM8AL3xE8x pin description</a>: pin name changed from PC3/USART1_TX/LCD_SEG23(3)/ADC1_IN5/COMP_IN3M/COMP2_INM/COMP1_INP to PC3/USART1_TX/LCD_SEG23(3)/ADC1_IN5/COMP2_INM/COMP1_INP.</li> <li>Added footnote to <a href="#">Table 68: STM8AL31E8x STM8AL3LE8x ordering information scheme</a>.</li> <li>Updated <a href="#">Section : Device marking on page 122</a>, <a href="#">Section : Device marking on page 126</a>, <a href="#">Section : Device marking on page 130</a></li> <li>Updated <a href="#">Section 9.2: Absolute maximum ratings</a></li> <li>Updated <a href="#">Figure 12: Power supply thresholds</a>.</li> </ul> |
| 5-Dec-2016  | 5        | <ul style="list-style-type: none"> <li>Updated <a href="#">Table 5: High-density STM8AL3xE8x pin description</a>: two pin names changed from PIO/RTC_TAMP1/[SPI2_NSS]/[TIM3_CH3 to PIO/RTC_TAMP1/[SPI2_NSS]/[TIM3_CH1 and from PF2/ADC1_IN26/[SPI2_SCK]/[USART3_SCK] to PF2/ADC1_IN26/[SPI1_SCK]/[USART3_SCK]</li> </ul>                                                                                                                                                                                                                                                                                                                                                                                                 |

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